

Report on Structure Detailed Design Review (DDR) at MSSL on 29th November 2001.

1 Introduction

The panel was impressed with the quality and amount of work that had been completed in the period leading up to this review.

A mature design was presented in most areas.

There are a few areas of that need to be addressed and these are described in this report.

2 Aims of the review.

Subsystem DDR aims are:

Freeze the subsystem requirements specification

Freeze the subsystem design and release for manufacture of STM/CQM.

3 Documentation.

The following list of documents were made available in advance of the review.

Document tree

Hardware tree

Declared materials list

Declared processes list

FMECA

MAIV flow chart

PA plan

SPIRE interface drawing

Interface control document (ICD)

Development plan

Schedule

Subsystem specification doc (SSD)

Technote 2, Thermal strap support level 0

Technote 3, detector box support.

Technote 6, Random interfaces forces.

4 Agenda.

The agenda is included in annex A

5 Presentation.

All presentations are included as annex B

6 Minutes of meeting

6.1 Review of the Specification and requirements.

Based on December issue of the instrument requirements spec, which is in process of minor updates.

Spectrometer baffle only covers the beam area, it does not go as far as the lid.

Photometer baffle does divide the unit in two, it is mounted in the clam shell lid.

Block diagram 3.1-3 is incorrect. The thermal strap between the cooler and detector boxes should enter the spectrometer box first.

Isolation of the thermal straps not covered in this review.

Thermal requirements are based on old information. The design cannot be fully verified until the Herschel cryostat model is available.

There may be some scope for changing the conductivity of the mounting feet to improve the thermal isolation. e.g. change to titanium.

The thermal characteristics of the mounts should be reassessed.

More thermal modelling is required in order to determine if a change is required.

A firm decision regarding the supports should be available when the new thermal analysis is complete.

6.2 Overall instrument design.

Random vibration.

Overall damping assumed at 3%, this was questioned by ESA.

FEA modelling shows that the first three modes are the instrument moving on its mounts. Fourth mode and above are all detector modes.

Entrance baffle stop position will need checking during the structure integration.

An alignment document will be written by MSSSL, not yet available.

6.3 Main interfaces.

All mirror mounts use two hollow dowels for location.

Aperture alignment plate drawing to go to LAM for construction of the OGSE (alignment plate).

Interface with the SMEC is not finalised, but can be soon.

Position of STM temperature sensors need to be defined by RAL.

Location of blacked areas is not finally confirmed, action RAL.

Cold stop interfaces to be passed to Tony Richards for checking.

Thermal bus bars not part of this review.

Harness routing is not fully defined.

RF filters.

Thermistor locations for STM and FM.

All other subsystems defined.

6.4 FMECA.

To be updated by Dec 15th so it can be incorporated into the system level FMECA in time for the IBDR documentation.

Short to cold strap needs to be assessed, this should be assessed for all instrument.

Fatigue analysis on feet required, for no fail safe items.

New FMECA due on 15/12/01.

Dynamic clearance to be addressed in the FMECA.

There will be a requirement in the IID-A to measure displacement during vibration tests.

Comments by ESTEC are included as annex C

6.5 Document tree

Interface drawings are issued through the interface doc. The latest drawing is in the latest issue of the doc.

Technical notes covering issues like margins of safety should be written, i.e. analysis should be documented.

Interface doc 4.11 has out of date vibration levels and needs updating.

6.6 MAIV plan.

Clamp optical bench to a surface table.

Build up photometer cover.

Fit to MGSE

Build up spectrometer cover.

Never remove both covers at the same time.

Photometer lid and sides can be removed leaving the base and mounts attached to the optical bench.

Lubrication of fixing screws, a solution needs to be identified, the system team to recommend a lubricant.

Procedure for checking flatness of optical bench, e.g. optical method needs to be addressed.

AIV procedure needs to be extended to the internal components.

6.7 MGSE

All based on hob simulator plate.

Used for transport as well.

Assembly onto Herschel starts with the cone fixed to spacecraft and A frames attached to SPIRE.

Transport case from Light Alloys Ltd.

6.8 Planning.

Detailed design now to Jan

STM manufacture Dec 2001 to May 2002

AIT May 2002 to Aug

Margin Aug to September

Delivery mid Sept

A second photometer box could be manufactured if the thermal bus bar becomes a holding item.

ESA would like to see an optimistic schedule based on maximum parallel manufacture.

A detailed list of milestones to be identified for tracking.

Internal review of each instrument and industry is being carried out by ESTEC

6.9 PA.

Heat/cold cycle, is this required. Consider doing at instrument level before mirror int.

Confirmation of design temperature required.

Note.

Shutter harness routing. Put the requirements for the harness in the IID-B.

Check creep of Kevlar.

6.10 Open Items.

Thermal requirements are based on old information. The design cannot be fully verified until the Herschel cryostat model is available.

The thermal characteristics of the mounts should be reassessed.

Dynamic envelope for all instruments.

Overall damping assumed at 3%, this was questioned by ESA. The SPIRE mechanical design relies on this figure.

A figure of 2% is more normal.

MSSL should re-run the analysis using 2% damping and see if this throws up any problems.

Thermal design or the mounting feet, raise as an issue.

ECR for vibration level and notches, check status.

7 Summary of Main points

The thermal characteristics of the mounts should be reassessed.

An alignment document to be written by MSSL.

Overall damping assumed at 3%, this was questioned by ESA.

MSSL should re-run the analysis using 2% damping and see if this throws up any problems.

The following interfaces are not finalised:

SMEC

STM temperature sensors

Location of blacked areas

Harness routing

RF filters.

In the FMECA, a short to cold strap needs to be assessed; this should be assessed for all instruments.

Fatigue analysis on feet required, for non fail-safe items.

Dynamic clearance to be addressed in the FMECA.

There will be a requirement in the IID-A to measure displacement during vibration tests.

Technical notes covering issues like margins of safety should be written, i.e. analysis should be documented.

Interface doc 4.11 has out of date vibration levels and needs updating.

Lubrication of fixing screws, a solution needs to be identified, the system team to recommend a lubricant.

Procedure for checking flatness of optical bench, e.g. optical method needs to be addressed.

AIV procedure needs to be extended to the internal components.

A second photometer box could be manufactured if the thermal bus bar becomes a holding item.

ESA would like to see an optimistic schedule based on maximum parallel manufacture.

A detailed list of milestones to be identified for tracking.

Heat/cold cycle - is this required. Consider doing at instrument level before mirror int.

ANNEX A

SPIRE STRUCTURE DETAILED DESIGN REVIEW – 29 & 30 NOVEMBER 2001 MULLARD SPACE SCIENCE LABORATORY Library

AGENDA (Chair – Eric Sawyer)

Thursday 29 November

14:00	Welcome and Aims of the Meeting	ES
14:15	Main Specification	
	- Specification Document	
	- Requirements Downflow	BW
14:45	Overall Instrument Design	BW/JC
	- Dynamic Performance	
15:45	Tea	
16:00	Main Interfaces	BW/JC/PG
18:00	Questions	
18:30	Close	

8 Friday 30 November

08:30	Recap of Previous Day	
08:45	Main Interfaces - continued	BW/JC
09:15	Questions	BW
09:30	MGSE	PB
10:00	AIV Plan	CBB
10:30	Coffee	
10:45	Planning	BW
11:15	PA Planning	TD
11:45	FMECA	CBB
12:15	Lunch	
13:45	Wrap up of Meeting Aims	
14:00	Final Questions	
14:15	Board Sitting (Closed)	
15:00	Tea	
15:15	Feedback from Board	
15:30	Close	



Herschel/SPIRE structure DDR Specification & Requirements

Berend Winter

Mullard Space Science Laboratory



Contents

- Specification
 - Purpose of the instrument
 - General overview of layout of the instrument
- Overview of requirements and open issues
 - down flow from IID-A and IID-B
 - Overview of the various design implementations with regard to the requirements

Purpose of the structure of the Instrument-1

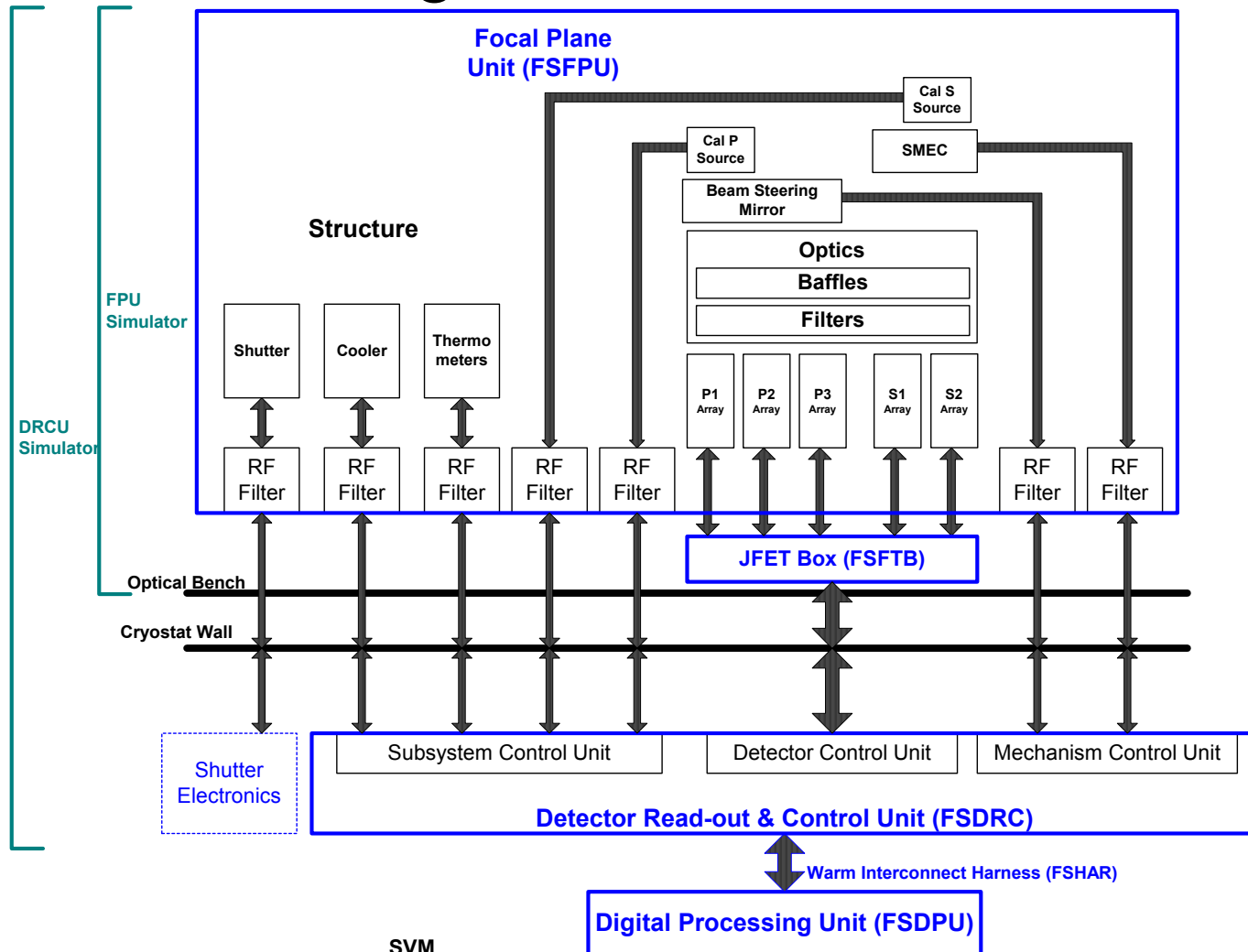
- House various parts of the instrument
 - Housing (two covers separated by SPIRE optical bench)
 - Photometer
 - Photometer detectorbox
 - Spectrometer
 - Spectrometer detectorbox
 - Optics
 - Straylight baffles
 - Iso-static mounting, thermally insulating and stiff
- Thermal control
 - Cryogenic instrument with different temperature zones
 - Level 0 (about 1.8 K) for detector boxes
 - Level 1 for the rest of the instrument structure (about 5 K)
 - 0.300 K busbar, cooling the detectors using a He³ refrigerator



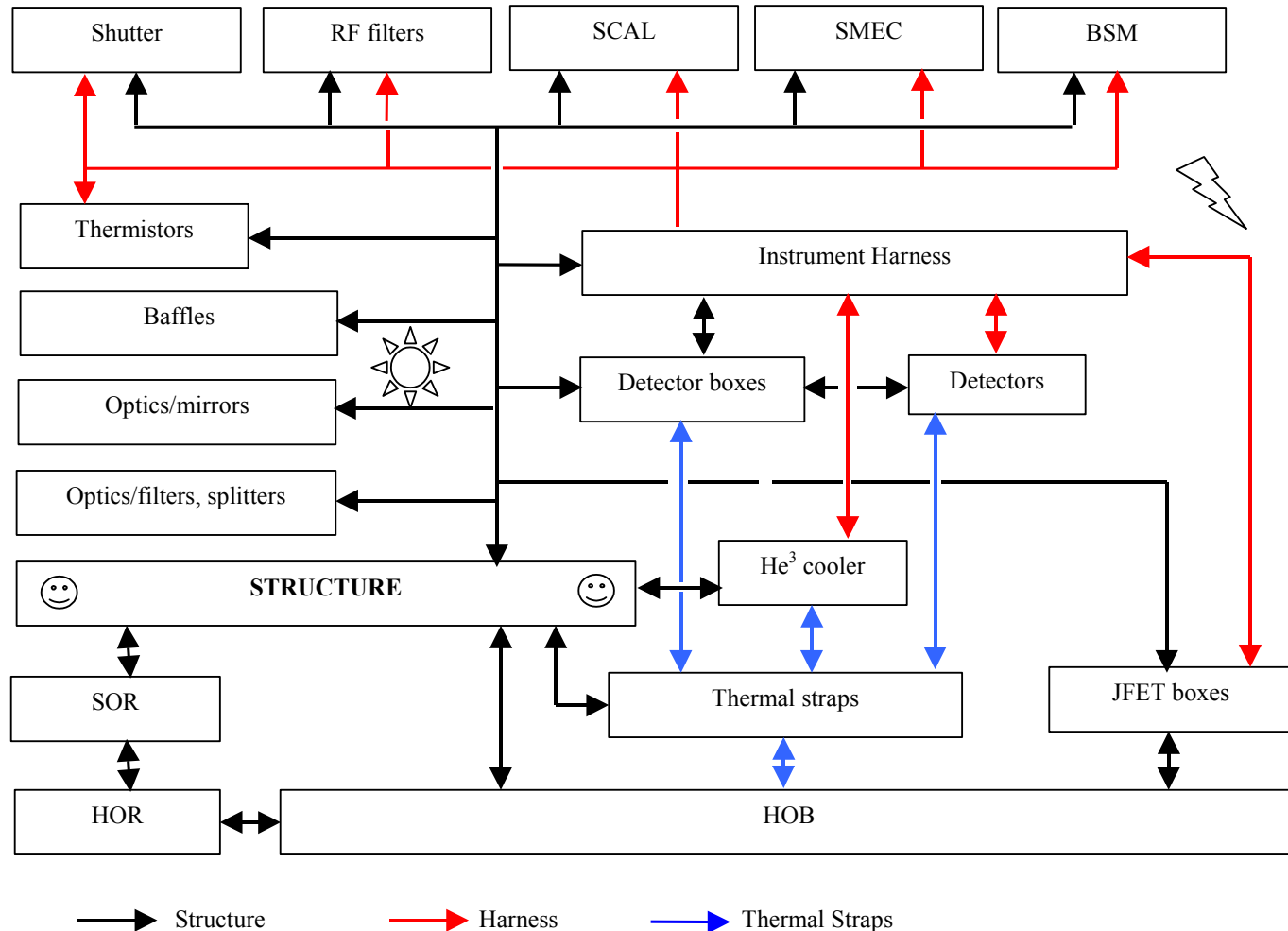
Purpose of the structure of the Instrument-1

- Straylight control
 - Mainly embedded in the optics (see block diagram presented later)
 - Straylight baffles
- RF-control
 - The outer contour of the structure works as an RF-attenuator
 - RF-filter boxes
- Structure
 - Provide for strength
 - strong enough to survive mechanical environment
 - Launch
 - Handling and integration
 - Provide for Stiffness
 - Maintain optical alignment
 - Help to separate main spacecraft dynamical modes from main instrument dynamical modes

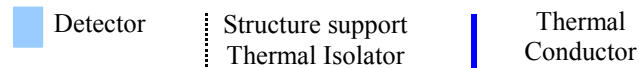
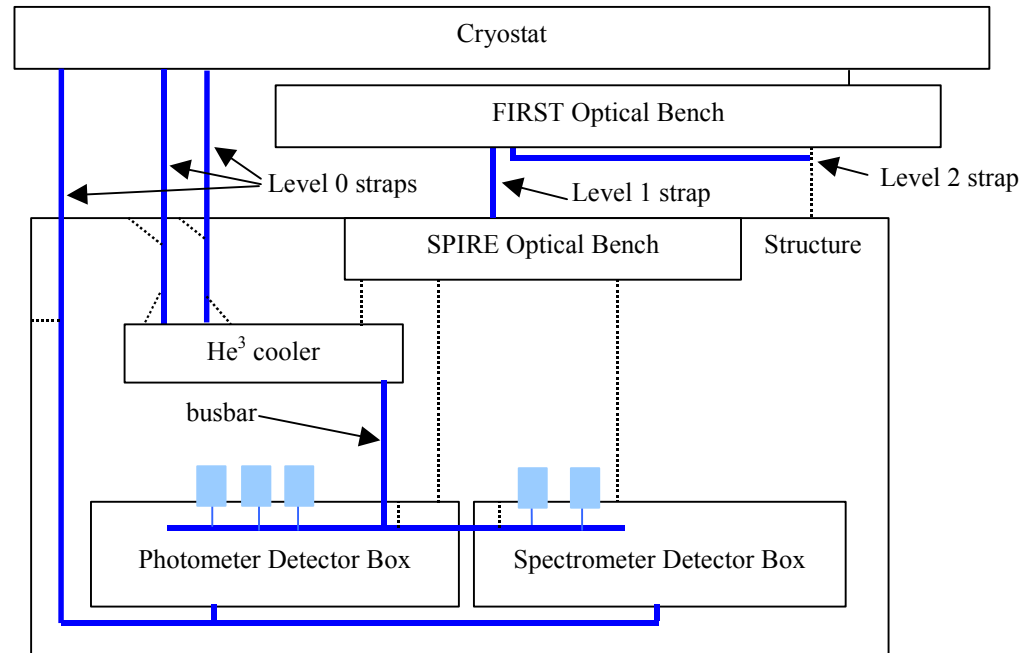
Block Diagram-1 The Whole of SPIRE



Block Diagram-2 Components Supported



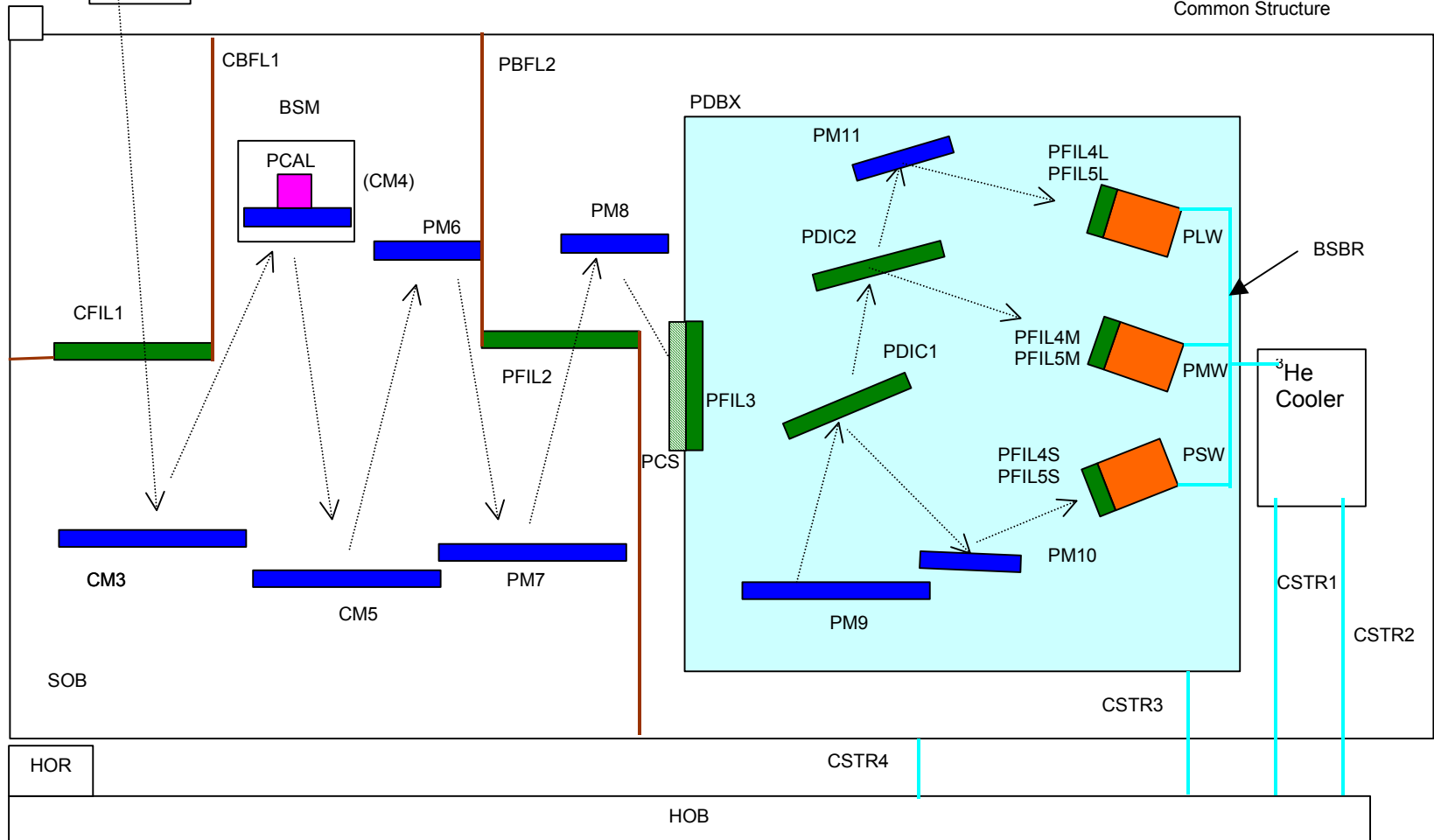
Block Diagram-3 Thermal topology



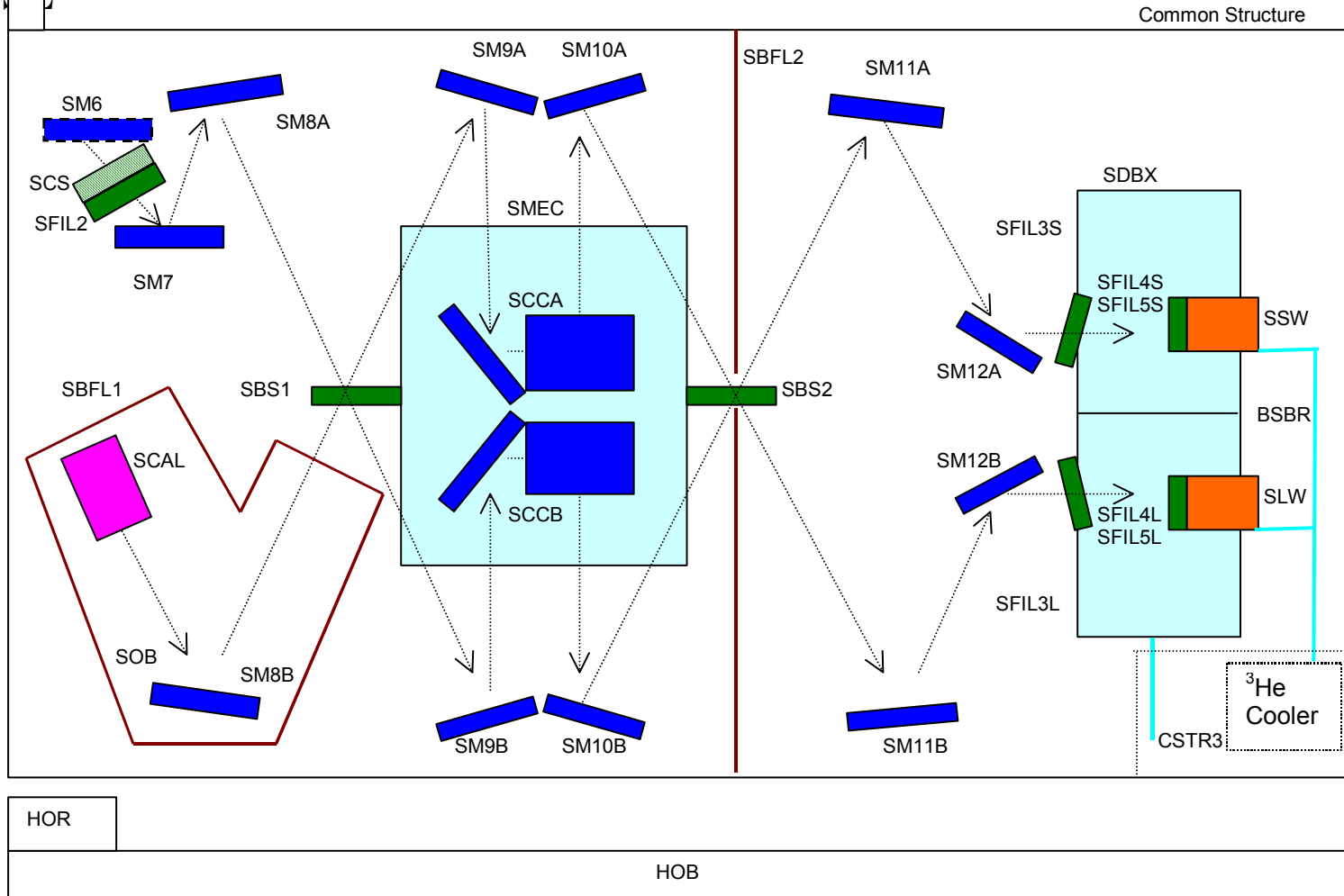


Block Diagram-4 Photometer Topology


Common Structure



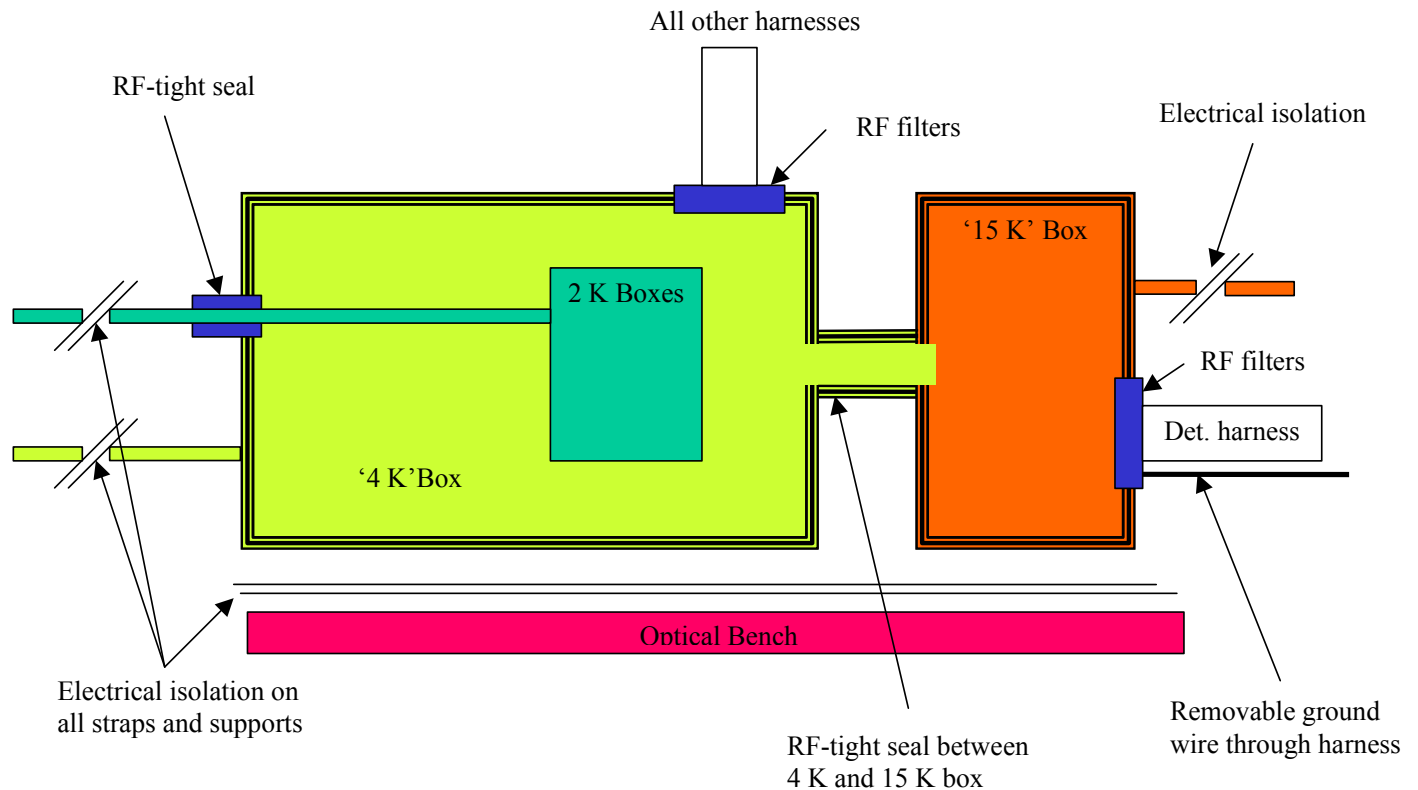
Block Diagram-5 Spectrometer Topology



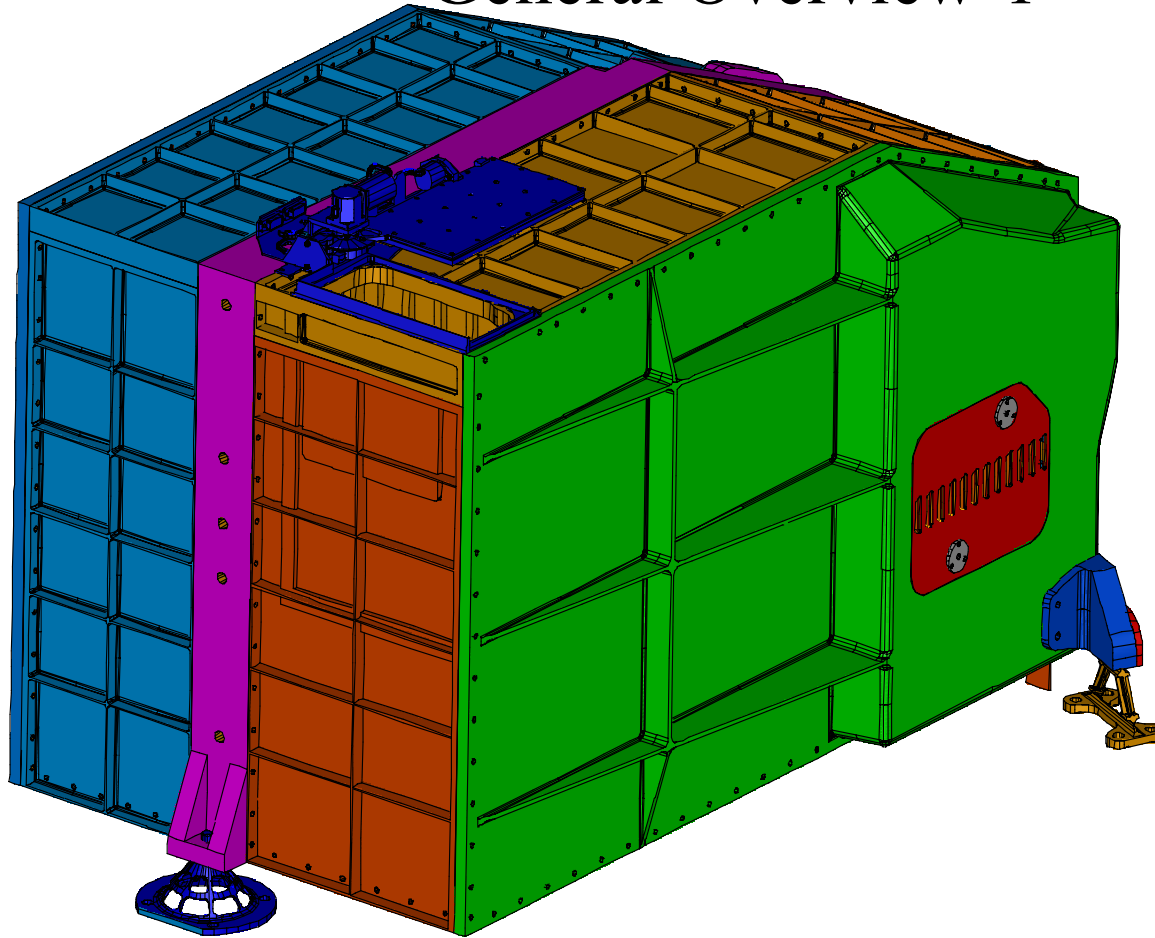
Block Diagram-6 RF Topology

 Denotes RF-tight boundary

- RF-box to float electrically from cryostat
- Only electrical connection is through ground wire
- All thermal, optical, and electrical penetrations to
- have RF-filters or seals

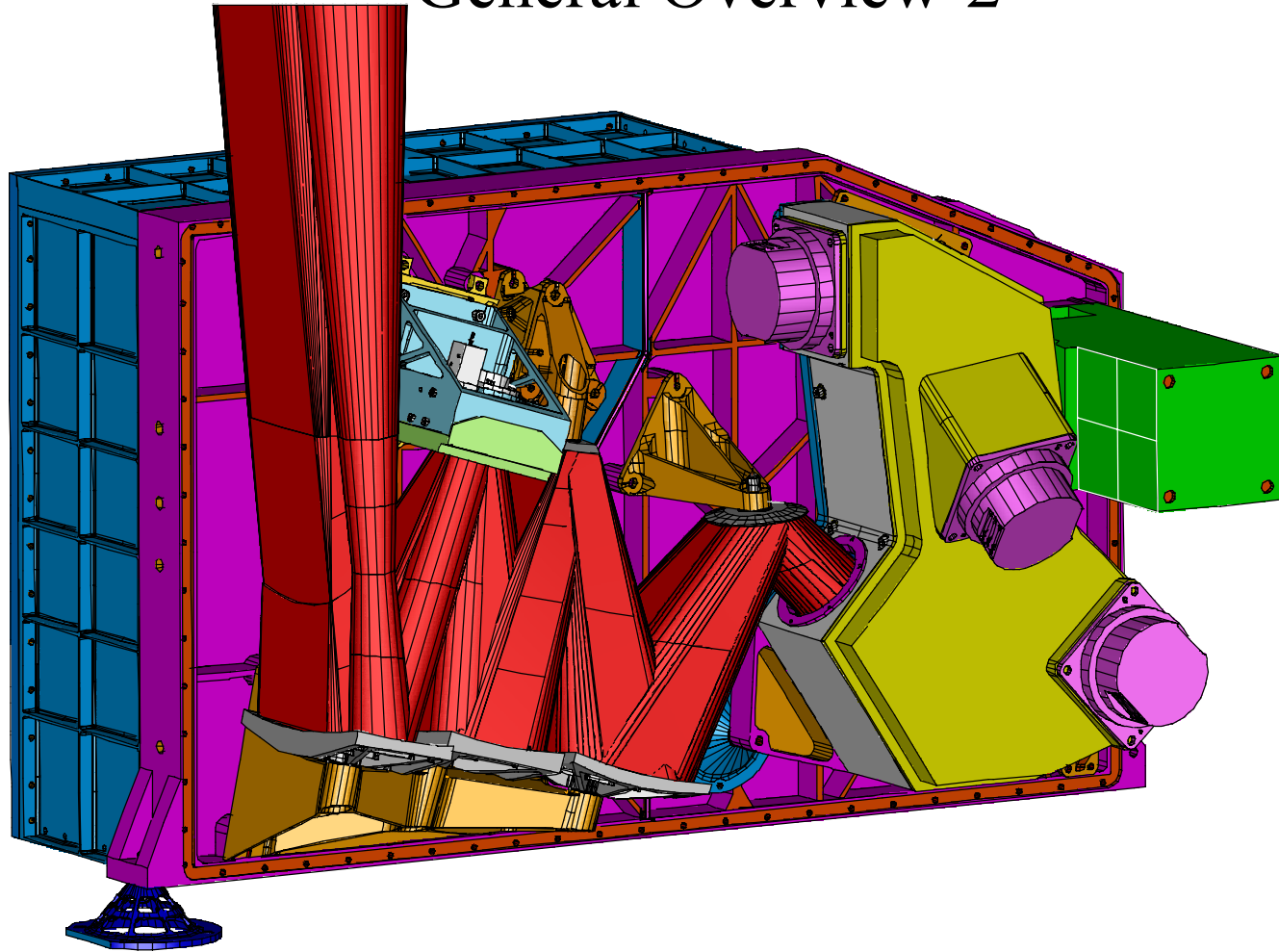


General Overview-1



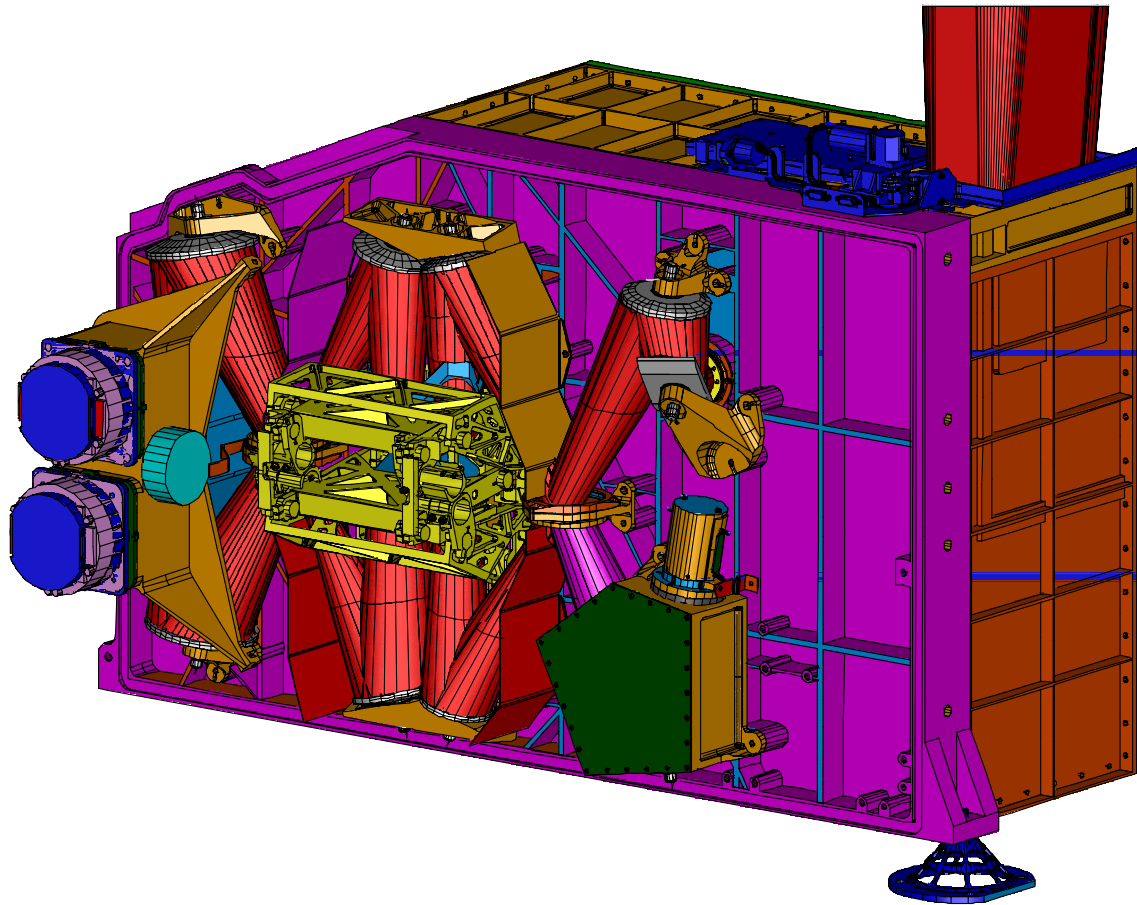
Outside view of the Instrument

General Overview-2



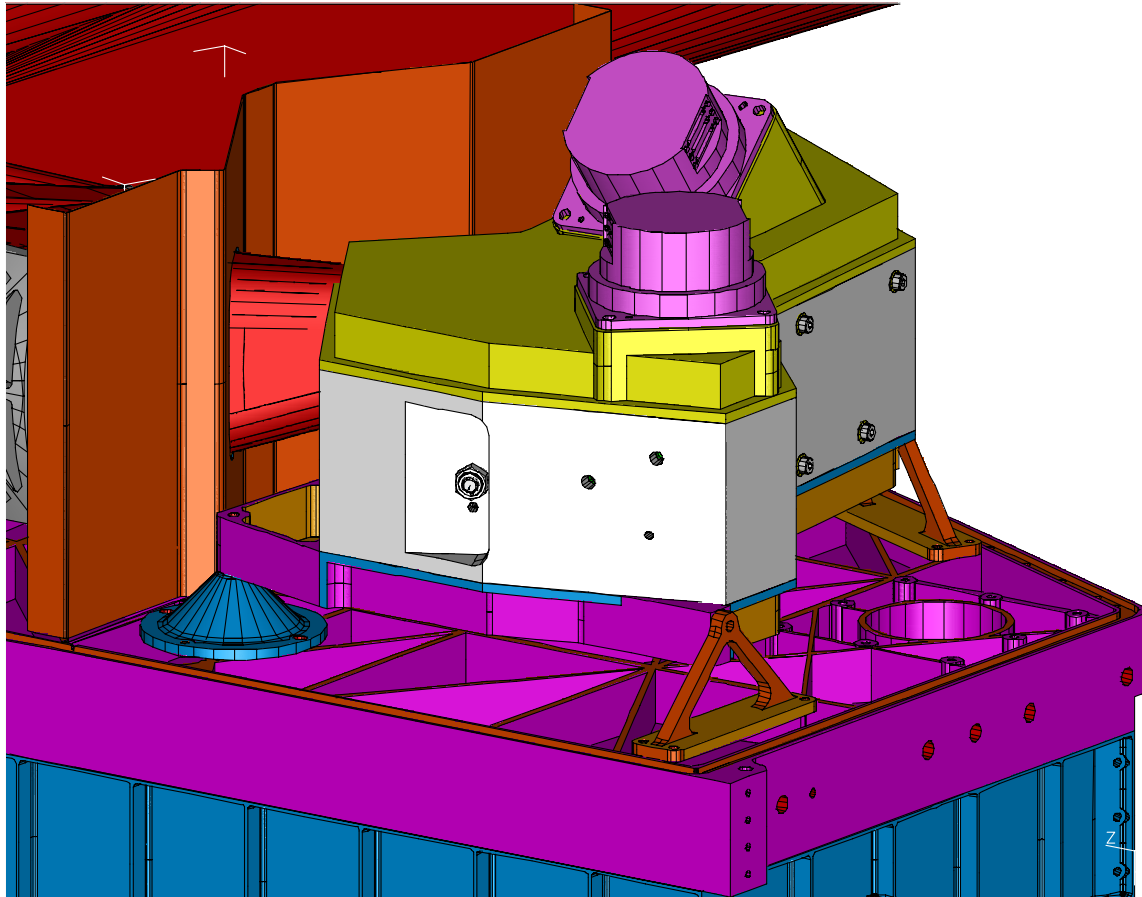
View of the Photometer part of the instrument

General Overview-3



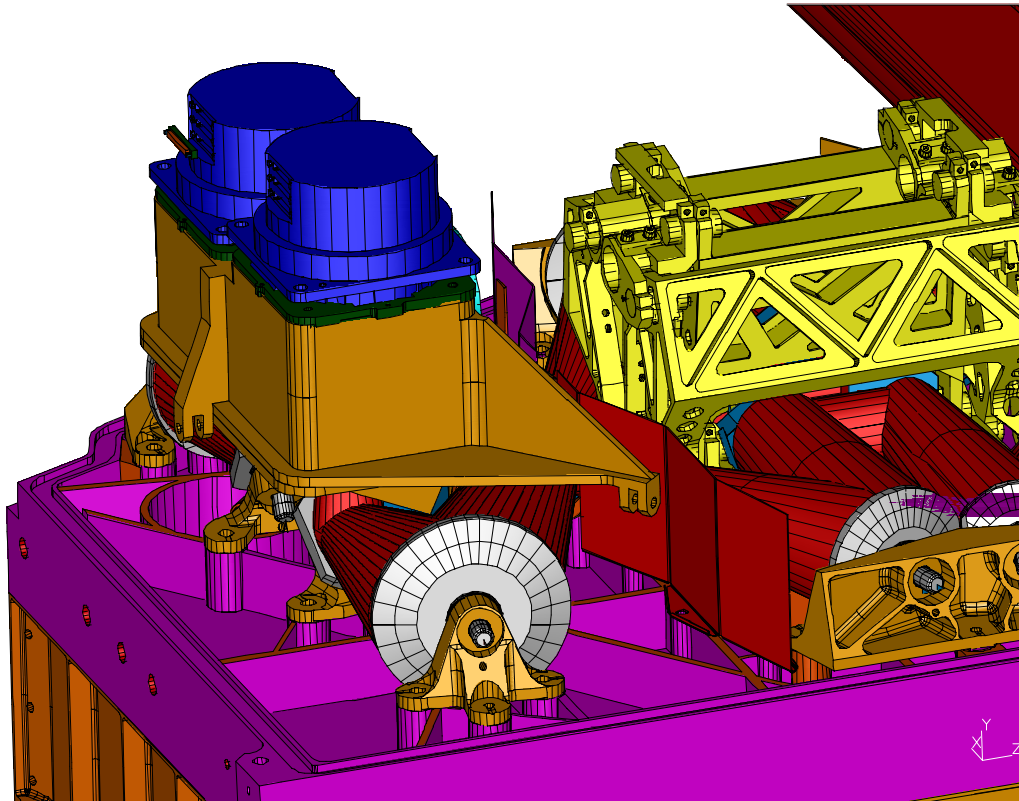
View of the Spectrometer part of the instrument

General Overview-4



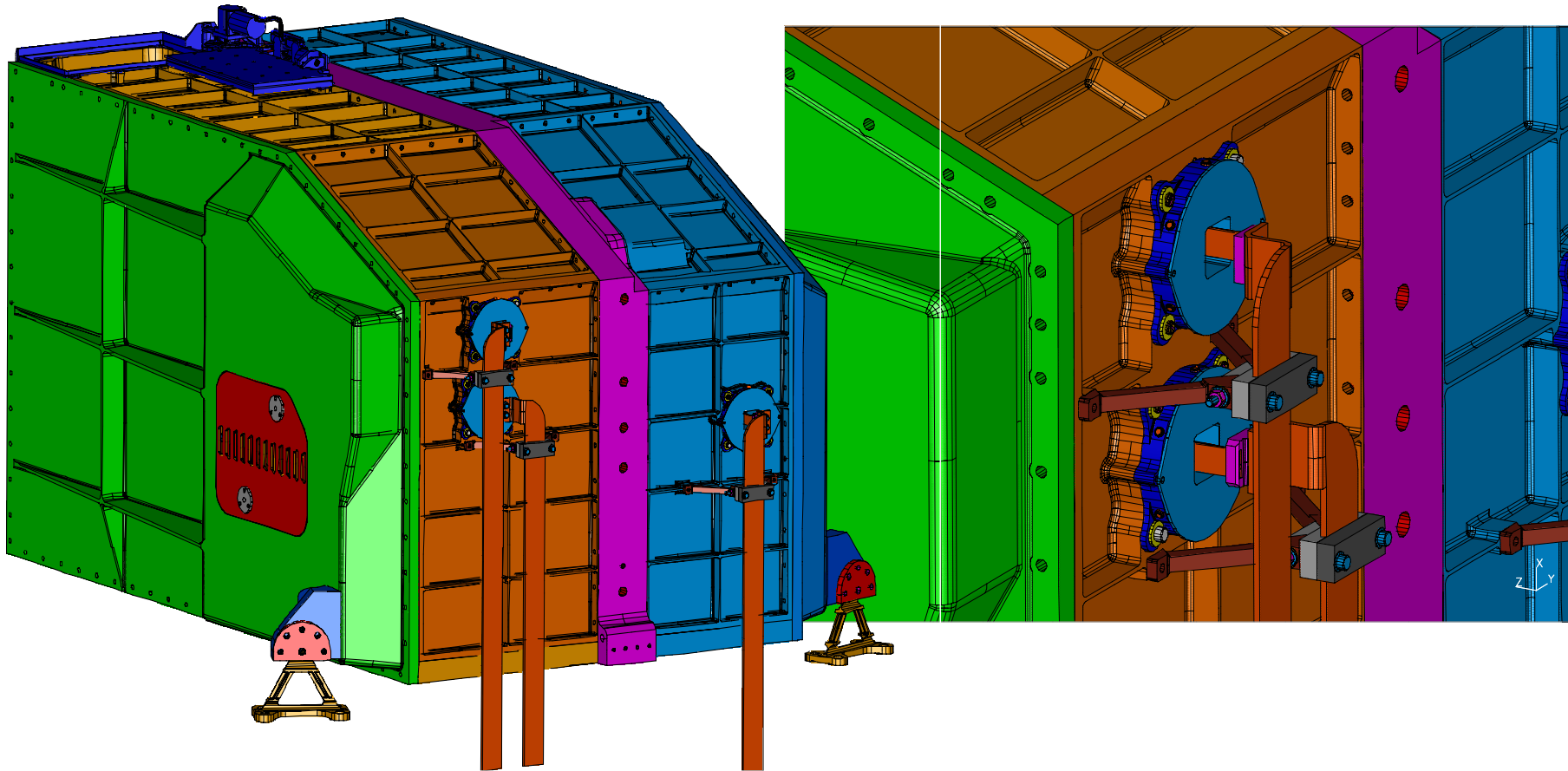
Photometer Detectorbox

General Overview-5

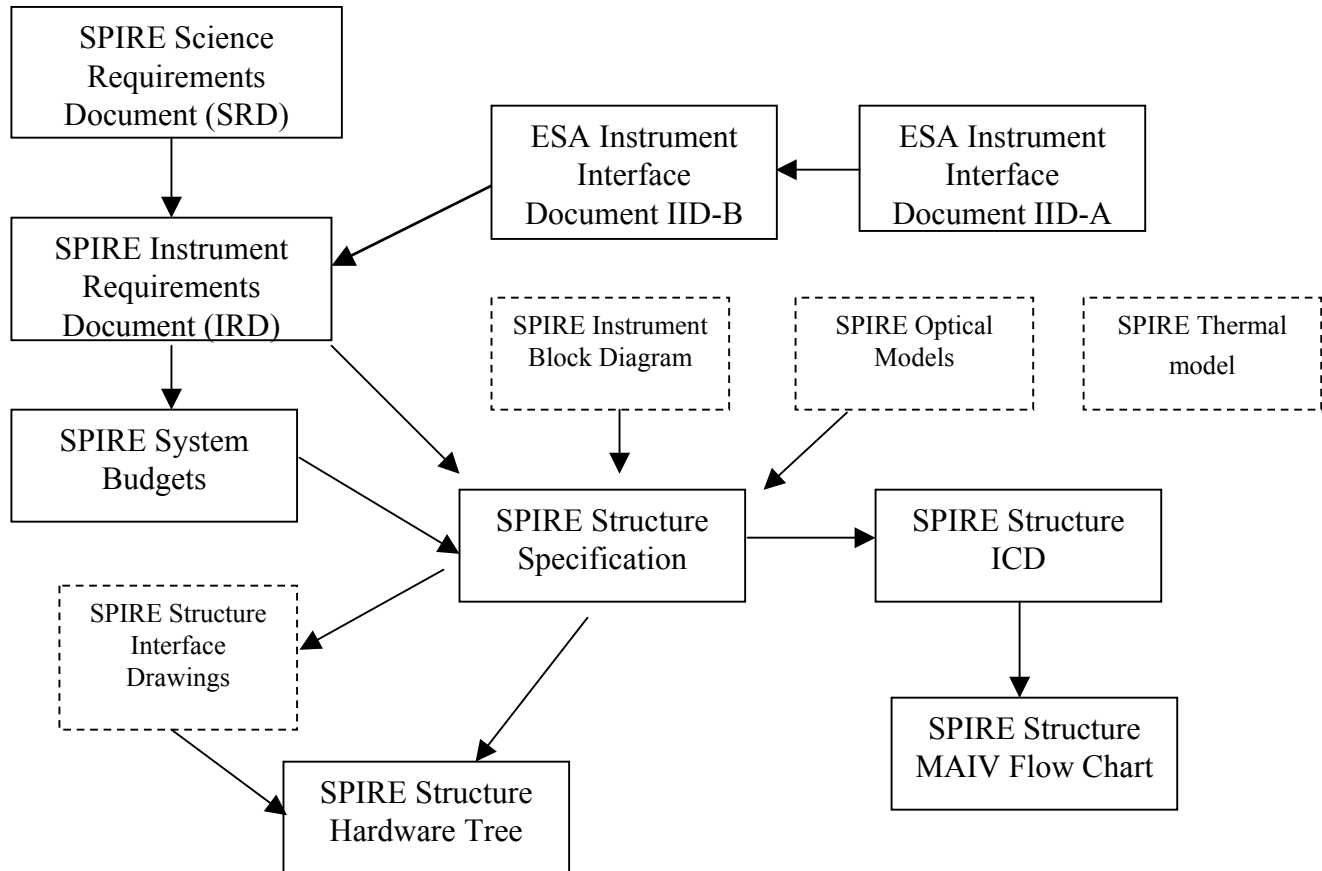


Spectrometer Detector Box

General Overview-5



Requirements Down Flow-1



Requirements Key Requirements

The following requirements were taken from the IRD and are the key requirements

- Alignment: The instrument alignment requirements are specified FIRST SPIRE Optical Alignment Plan, compliant (IRD-STRC-R04)
- Temperature: The structure will facilitate the cooling of the active part of the detectors down to 0.3 K. Three temperature zones identified. Level 0 for the detector boxes. Level 1 for the common structure and SOB. Level 2 for the FOB interface. (IRD-STRC-R14, IRD-STRP-R01/R09, IRD-STRS-R01/R09), compliant
- RF: The RF will be sufficiently attenuated, following the specification in the IRD (IRD-STRC-R02), compliant
- Stiffness: The structure will have an eigenfrequency of at least 100 Hz with a goal of at least 120 Hz, compliant (IRD-STRC-R09)
- Mass: The total mass of the structure will not exceed 27.2 kg excluding contingency, compliant. (IRD-SUBS-R03)



Non-Compliance or Open with IRD issue 1

The following requirements were taken from the IRD and are open or non-compliant
Problems indicated in red

Common Structure

- IRD-STRC-R01 Alignment instrument wrt Herschel, open (TBC/TBD)
- IRD-STRC-R02 RF-attenuation, open, (TBD)
- IRD-STRC-R12 Grounding open (TBD)
- IRD-STRC-R13 Elect. Insulation (TBD)

Photometer

- IRD-STRP all compliant

Spectrometer

- IRD-STRS all compliant

Eigenfrequency Distribution

Mode Number	Freq. f [Hz]	Normalised effective mass		
		X (launch)	Y (lateral)	Z (lateral)
1	136	0.00	0.75	0.01
2	151	0.05	0.01	0.79
3	189	0.46	0.00	0.02
4	191	0.06	0.00	0.03
5	207	0.01	0.01	0.00
6	221	0.05	0.00	0.00
7	227	0.16	0.01	0.05
8	238	0.01	0.01	0.00
9	242	0.02	0.00	0.00
10	246	0.00	0.00	0.00
21	299	0.04	0.00	0.00
	total:	0.93	0.83	0.94

The goal is above 120 Hz with uncertainty of 10%
This means in the analysis the first frequency should be above 131 Hz



Mass Budget-1

MSSL mass spreadsheet					
Nominal estimate + contingency					Contingency
Issue 1.4 November 2001					uncertainty
					[%]
	Nett	Contg.	Total		
Photometer cover	5.94	0.30	6.24	[kg]	5.00
Spectrometer cover	5.37	0.27	5.64	[kg]	5.00
Optical bench	8.86	0.89	9.75	[kg]	10.00
Mounting common structure	0.52	0.04	0.56	[kg]	7.01
RF-attenuation	0.00	0.00	0.00	[kg]	0.00
Phot. det. box	4.19	0.42	4.60	[kg]	10.00
Spect. det. box	1.09	0.11	1.19	[kg]	10.00
Structure:	25.96	2.02	27.98		6.72

Mass Budget - 2

MSSL mass spreadsheet					
Nominal estimate + contingency					Contingency
Issue 1.4 November 2001					uncertainty
					[%]
Structure:	25.96	2.02	27.98		6.72
Mounts, Clamps Phot.	1.28	0.06	1.34	[kg]	5.00
Mounts, Clamps Spect.	0.86	0.04	0.90	[kg]	5.00
Thermal straps	0.52	0.10	0.62	[kg]	20.00
Straylight Baffles	1.39	0.07	1.46	[kg]	5.00
Thermistors	0.35	0.07	0.42	[kg]	20.00
RF-filter boxes	1.72	0.34	2.06	[kg]	20.00
total	32.07	2.71	34.77	[kg]	8.44



Thermal Budget



Herschel/SPIRE structure DDR

Overall Instrument Design

Berend Winter

Mullard Space Science Laboratory



Contents

- Static
- Dynamics
 - sine vibration
 - random vibration
- Thermal
 - Level 1 - Level 2
 - Level 0 - Level 1
- Stray Light
- RF-sealing
- Alignment

Sine Vibration

Sine vibration levels	Frequency range	Input at base (QUAL)
X - Axis	5-40 Hz	20 g
	40-100 Hz	10 g
Y - Axis	5-100 Hz	14 g
Z - Axis	5-100 Hz	14 g

- Allowed to notch on interface loads
 - Strength is limited by quasi static I/F loads
 - Instrument is designed for 100 g in any direction (static)
- No problem, safety factor is 1.5

Static

Quasi Static levels	Case 1	Case 2	Case 3
x-direction	20 g	-	-
y-direction	-	14 g	-
z-direction	-	-	14 g

- Instrument was designed for static loading
- Lowest margin of safety in Y direction
 - safety factor 1.6 in the A-frame support
- Structure is not a problem

Random Vibration

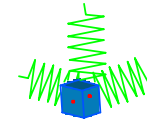
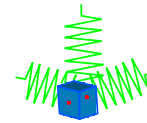
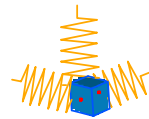
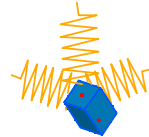
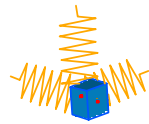
Random vibration levels	Frequency range	Input at base (QUAL.)	RMS
X – Axis	20 – 100 Hz	+6 dB Hz/Oct	5.27g RMS
	100 - 300 Hz	0.05 g ² /Hz	
	300 – 2000 Hz	-6 dB/Oct	
Y – Axis	20 – 80 Hz	+6 dB Hz/Oct	5.27 g RMS
	80 - 300 Hz	0.05 g ² /Hz	
	300 – 2000 Hz	-6 dB/Oct	
Z – Axis	20 – 80 Hz	+6 dB Hz/Oct	5.27 g RMS
	80 - 300 Hz	0.05 g ² /Hz	
	300 – 2000 Hz	-6 dB/Oct	

- Allowed to notch on interface loads
 - Strength is limited by quasi static I/F loads
- No problem, safety factor is 1.6

Random Vibration

- Implemented notch on interface loads and adjusted design of photometer detector box support
 - Strength is limited by quasi static I/F loads
- No problem, safety factor is 1.7
- However....
 - Loads on detectors proved to be a problem, un-notched with previous design detector responses were exceeding 40 g-rms
- Adjusted design of photometer detector introduce increase in parasitic heat loads through support
- Overall damping assumed in random analysis of 3%, and 4% for detector modes
- Detectors modeled using 1-dof mass-spring system in all 3 orthogonal directions for each detector individually

Detector model





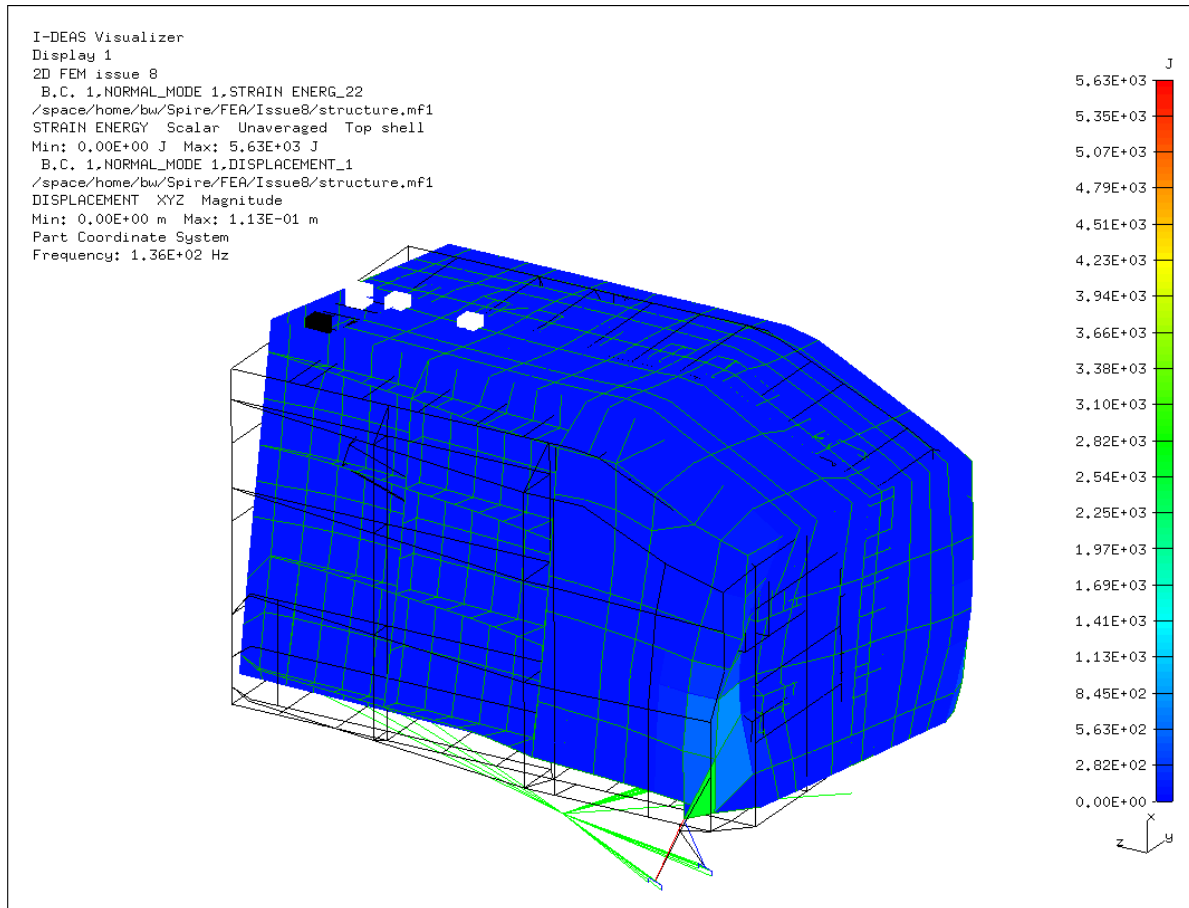
Detectors 1st mode

First mode						
	PLW	PMW	PSW	SLW	SSW	
f-given	221	236	247	265	272	[Hz]
lbs	1.338	1.244	1.126	1.012	0.964	[LBS]
modal %	0.65	0.65	0.65	0.65	0.65	[%]
m1	0.3945	0.3668	0.3320	0.2984	0.2842	[kg]
m2	0.212	0.197	0.179	0.161	0.153	[kg]
m-total kg	0.607	0.564	0.511	0.459	0.437	[kg]
k-effective	7.61E+05	8.06E+05	8.00E+05	8.27E+05	8.30E+05	[N/m]
k-approx	8.00E+05	8.00E+05	8.00E+05	8.00E+05	8.00E+05	[N/m]
f-approx	221	236	247	265	272	[Hz]
m1	0.415	0.364	0.332	0.289	0.274	[kg]
m2	0.192	0.200	0.179	0.170	0.163	[kg]
difference	0	0	0	0	0	[%]

Detectors 2nd and 3rd mode

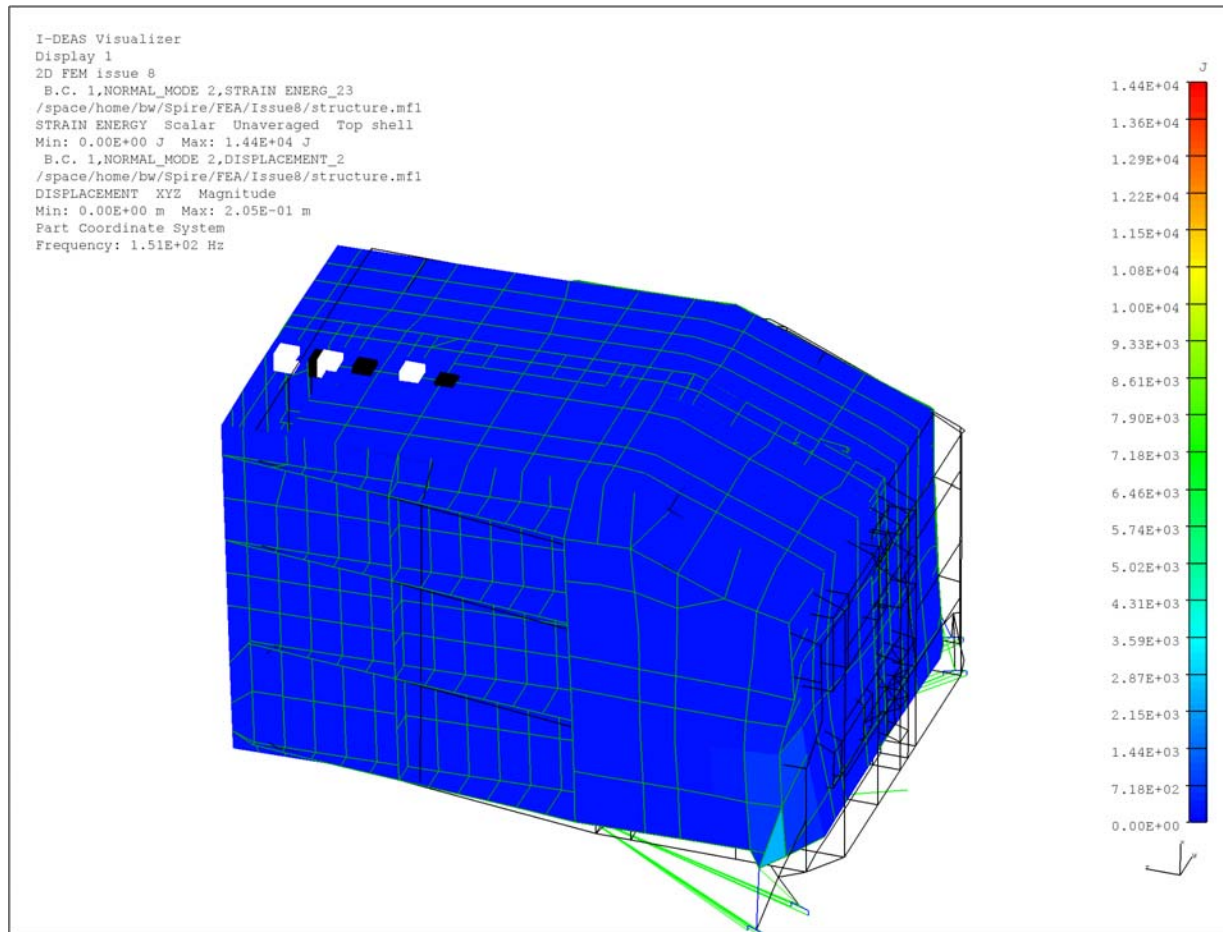
Second mode						
f-given	274	292	304	328	331	[Hz]
k-effective	1.17E+06	1.23E+06	1.21E+06	1.27E+06	1.23E+06	[N/m]
k-approx	1.20E+06	1.20E+06	1.20E+06	1.20E+06	1.20E+06	[N/m]
f-approx	270.7	289.0	302.5	324.6	333.1	[Hz]
difference	1.22	1.01	0.49	1.05	-0.64	[%]
Third mode						
f-given	332	345	371	399	410	[Hz]
k-effective	1.72E+06	1.72E+06	1.80E+06	1.88E+06	1.89E+06	[N/m]
k-approx	1.80E+06	1.80E+06	1.80E+06	1.80E+06	1.80E+06	[N/m]
f-approx	331.5	354.0	370.5	397.5	408.0	[Hz]
difference	0.2	-2.6	0.1	0.4	0.5	[%]

First Mode 136 Hz



- Lateral mode (S/C), 80% effective mass

Second Mode 151 Hz

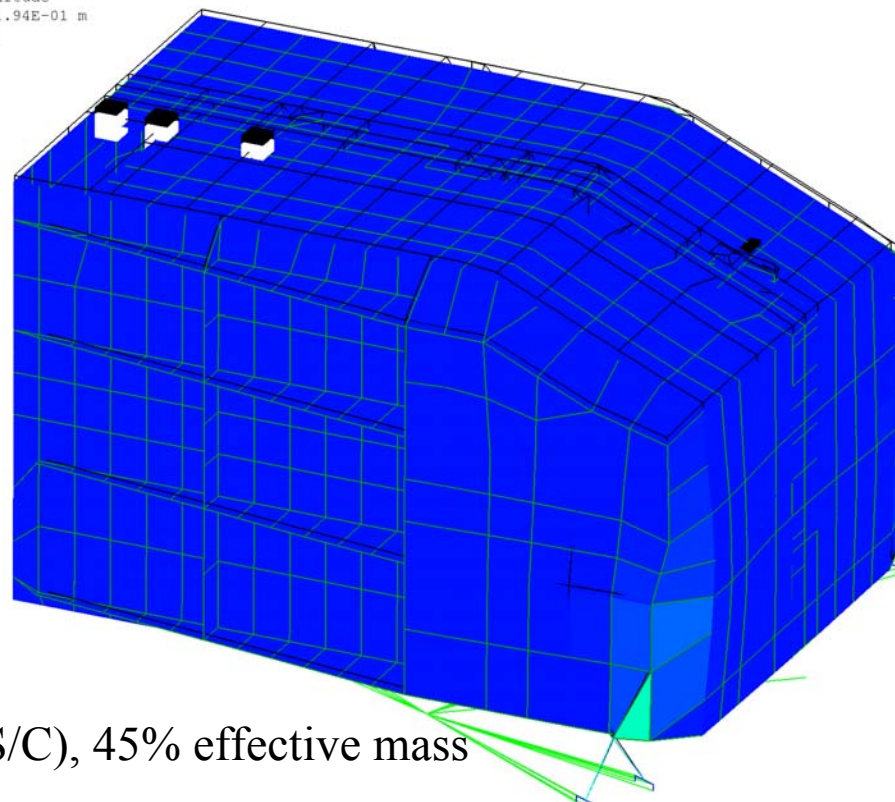


- Lateral mode (S/C), 80% effective mass

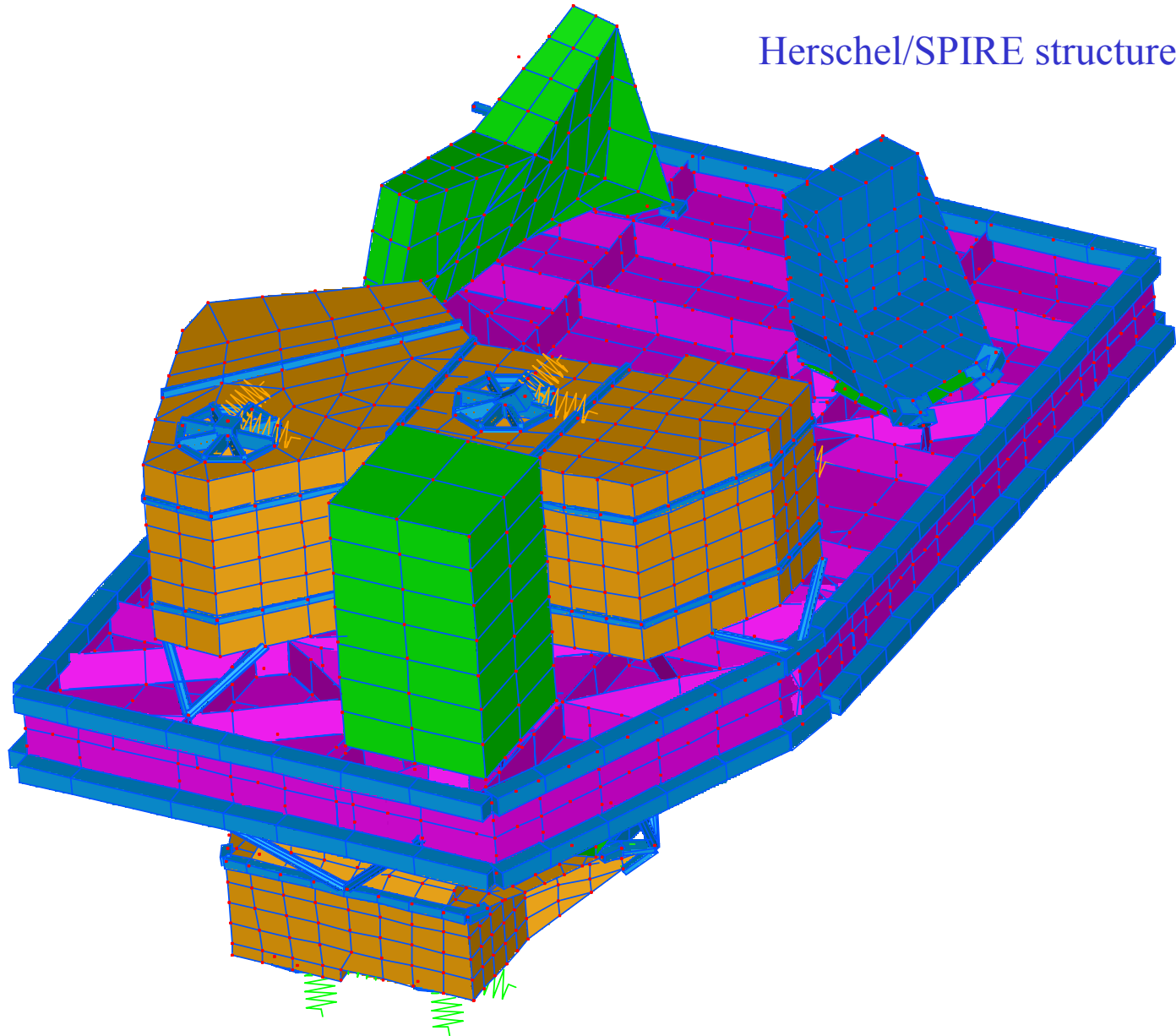
Third Mode 189 Hz

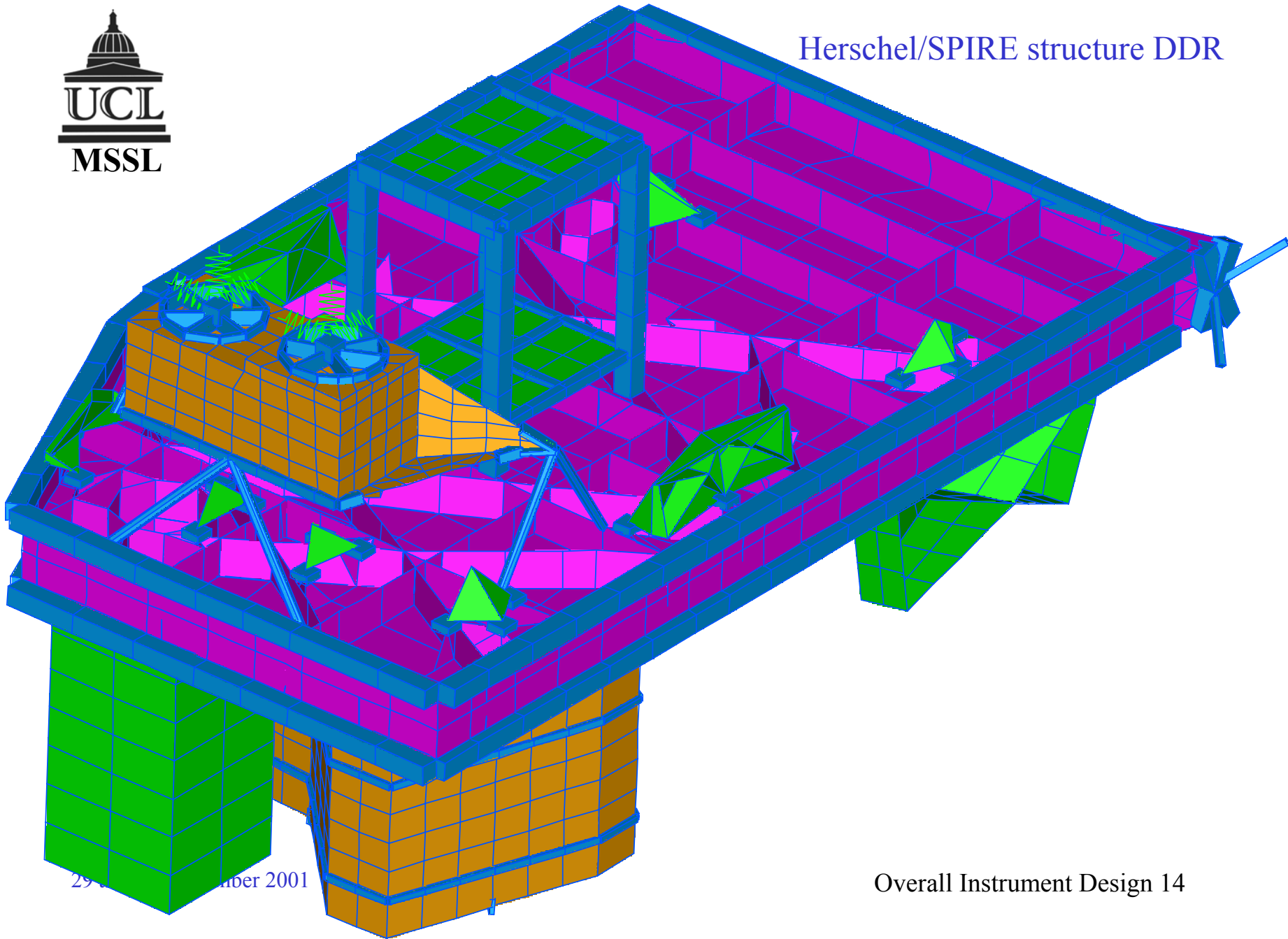
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I-DEAS Visualizer
Display 1
2D FEM issue 8
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STRAIN ENERGY Scalar Unaveraged Top shell
Min: 0.00E+00 J Max: 1.79E+03 J
  B.C. 1,NORMAL_MODE 3,DISPLACEMENT_3
/space/home/bw/Spire/FEA/Issue8/structure.mfl
DISPLACEMENT XYZ Magnitude
Min: 0.00E+00 m Max: 1.94E-01 m
Part Coordinate System
Frequency: 1.89E+02 Hz
  
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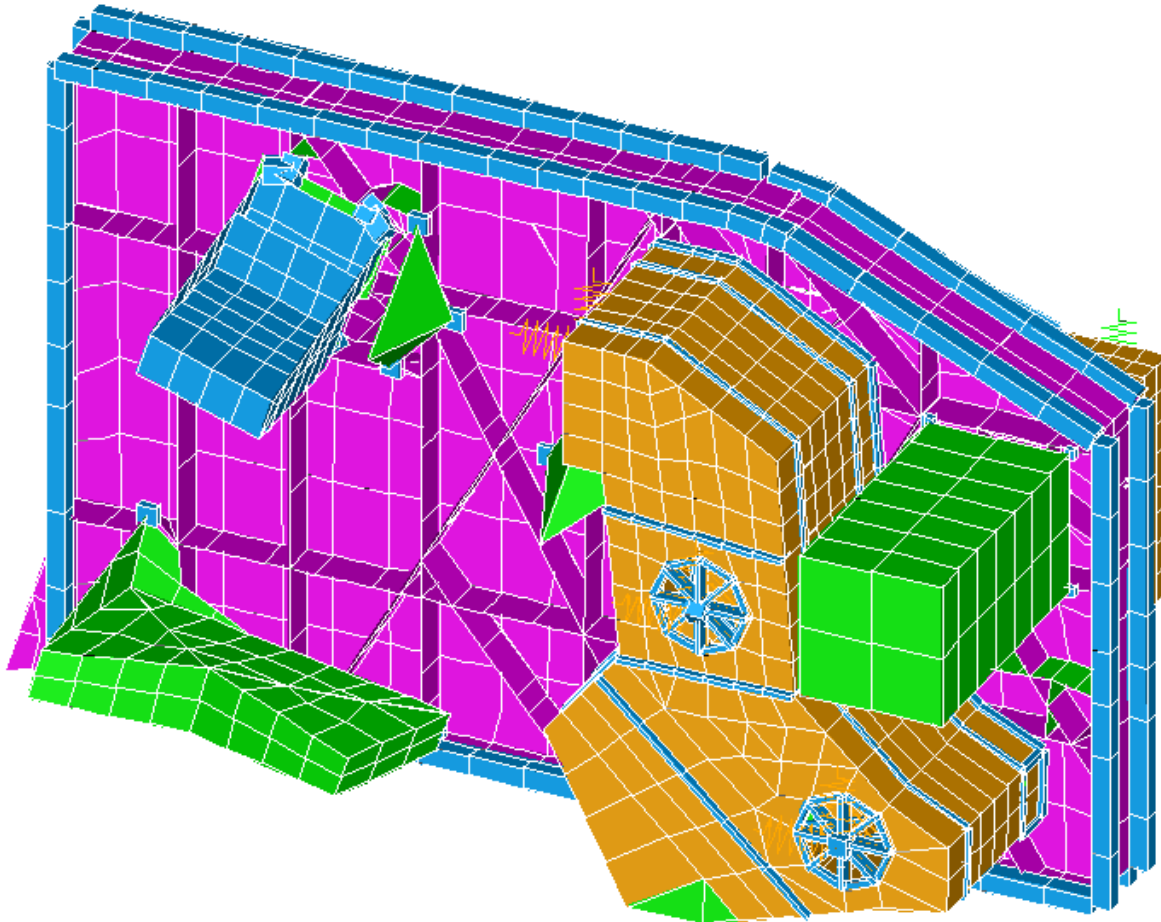


- Longitudinal (S/C), 45% effective mass

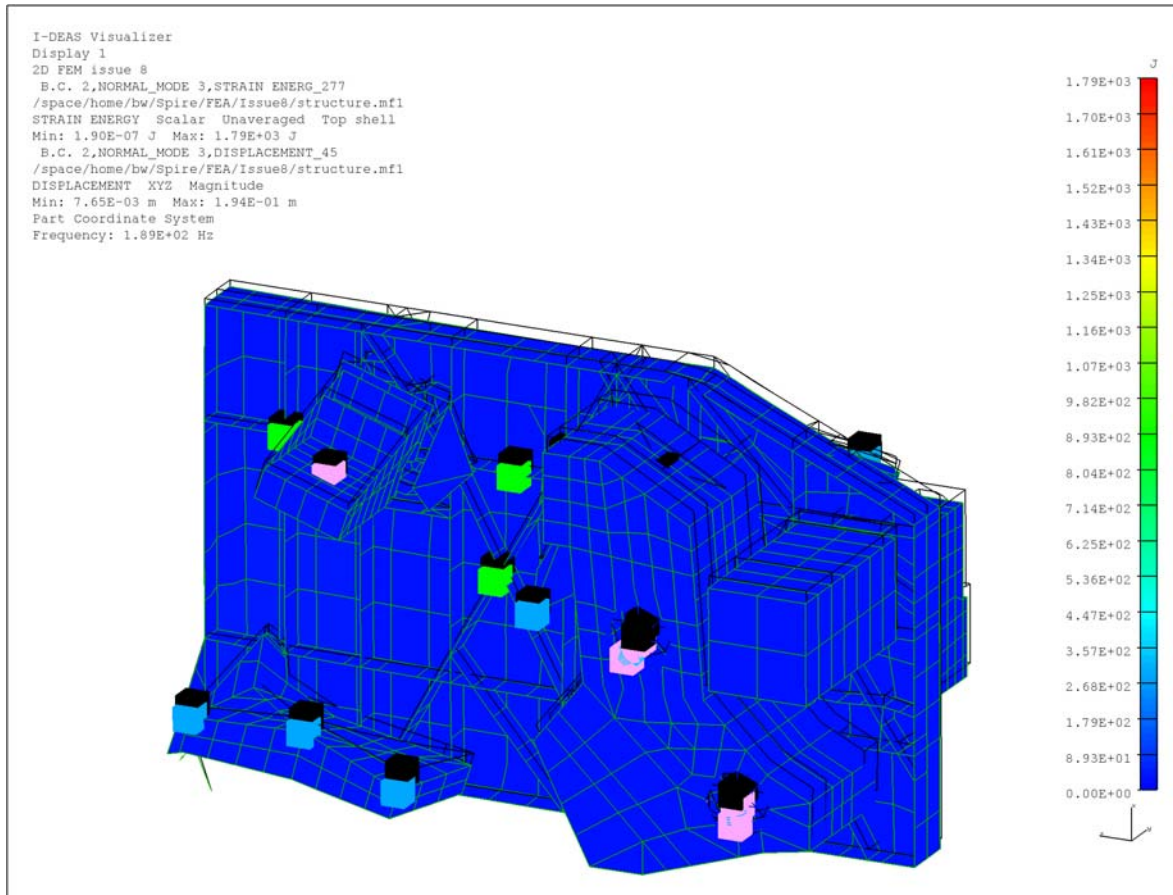




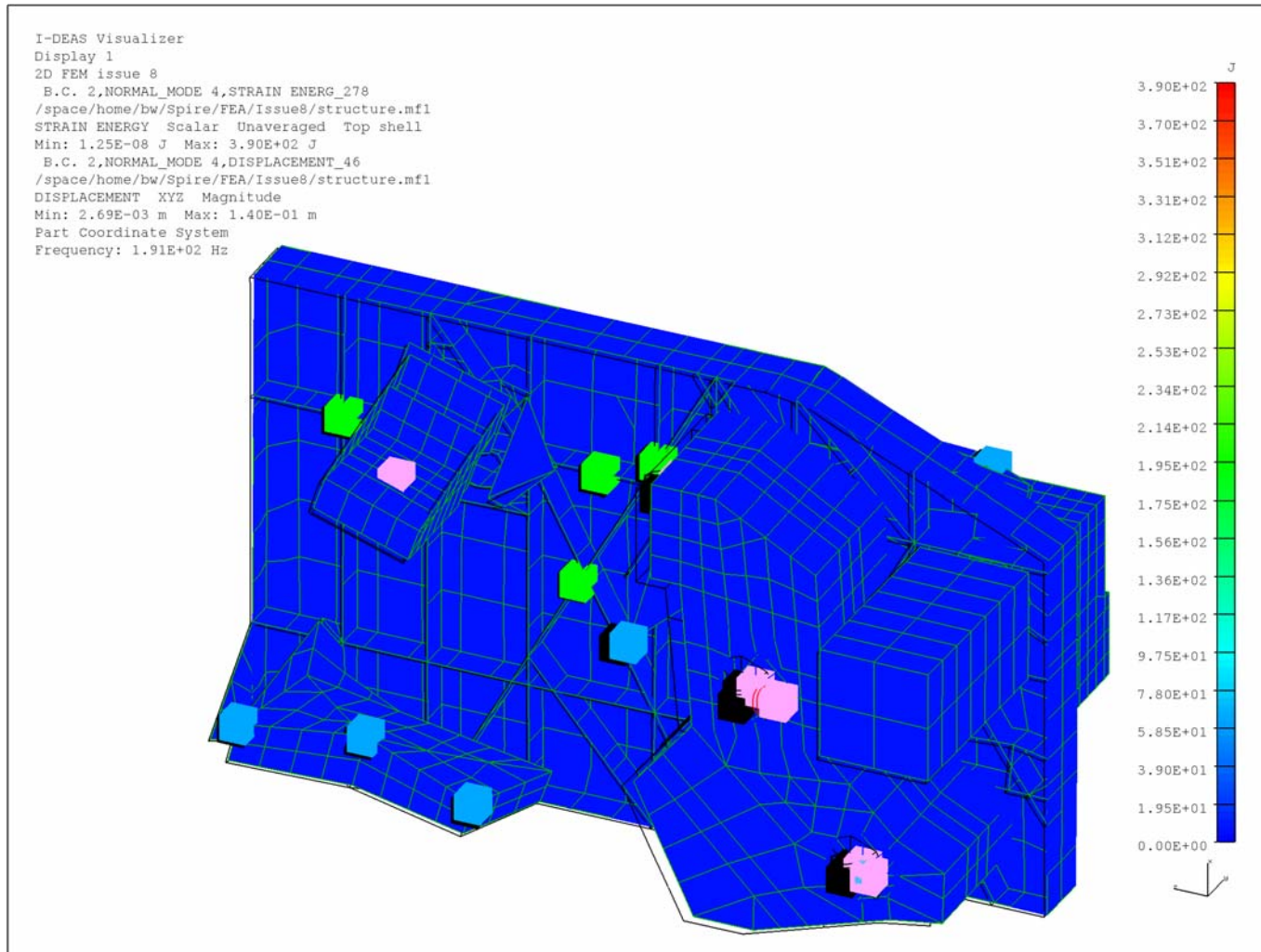
Photometer FEA



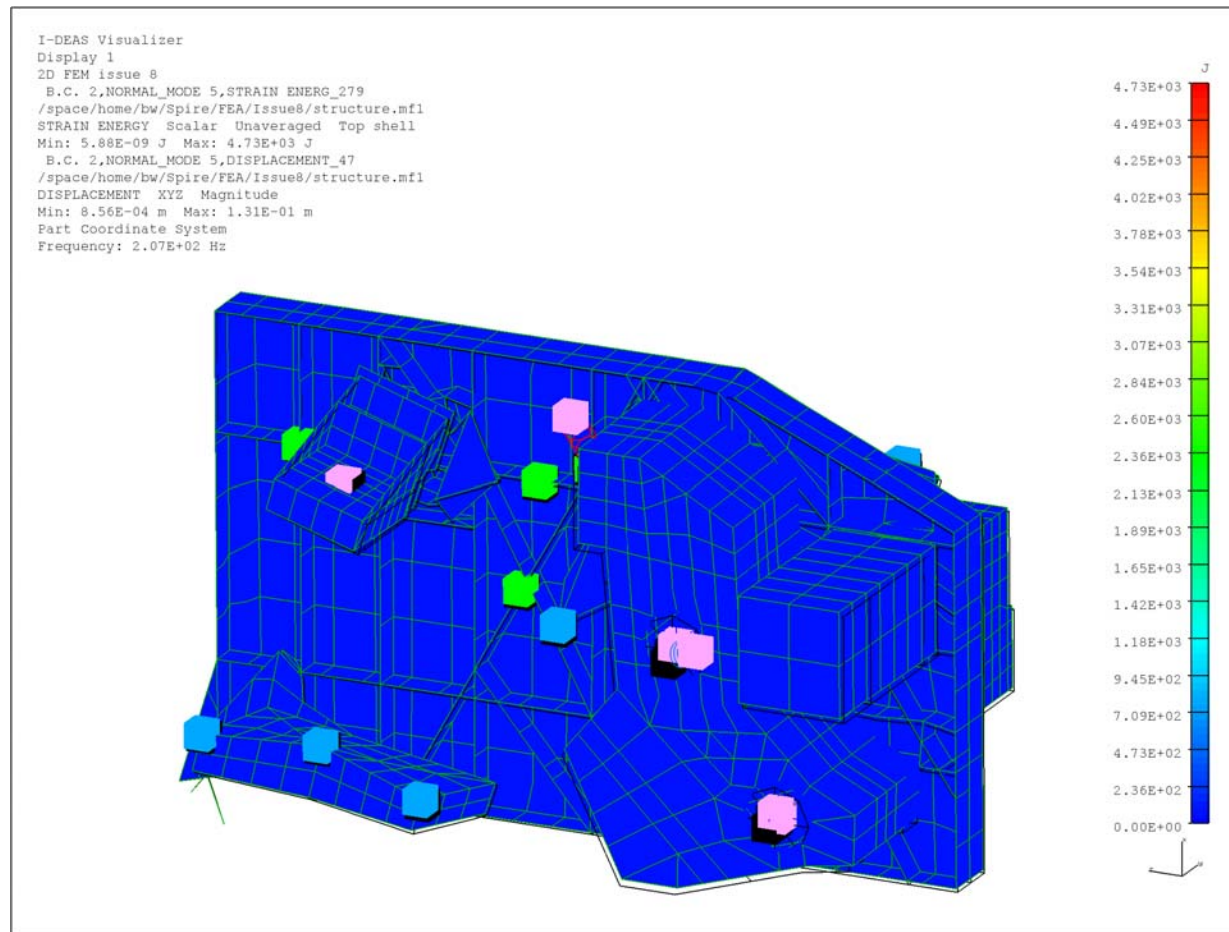
Third Mode, 189 Hz



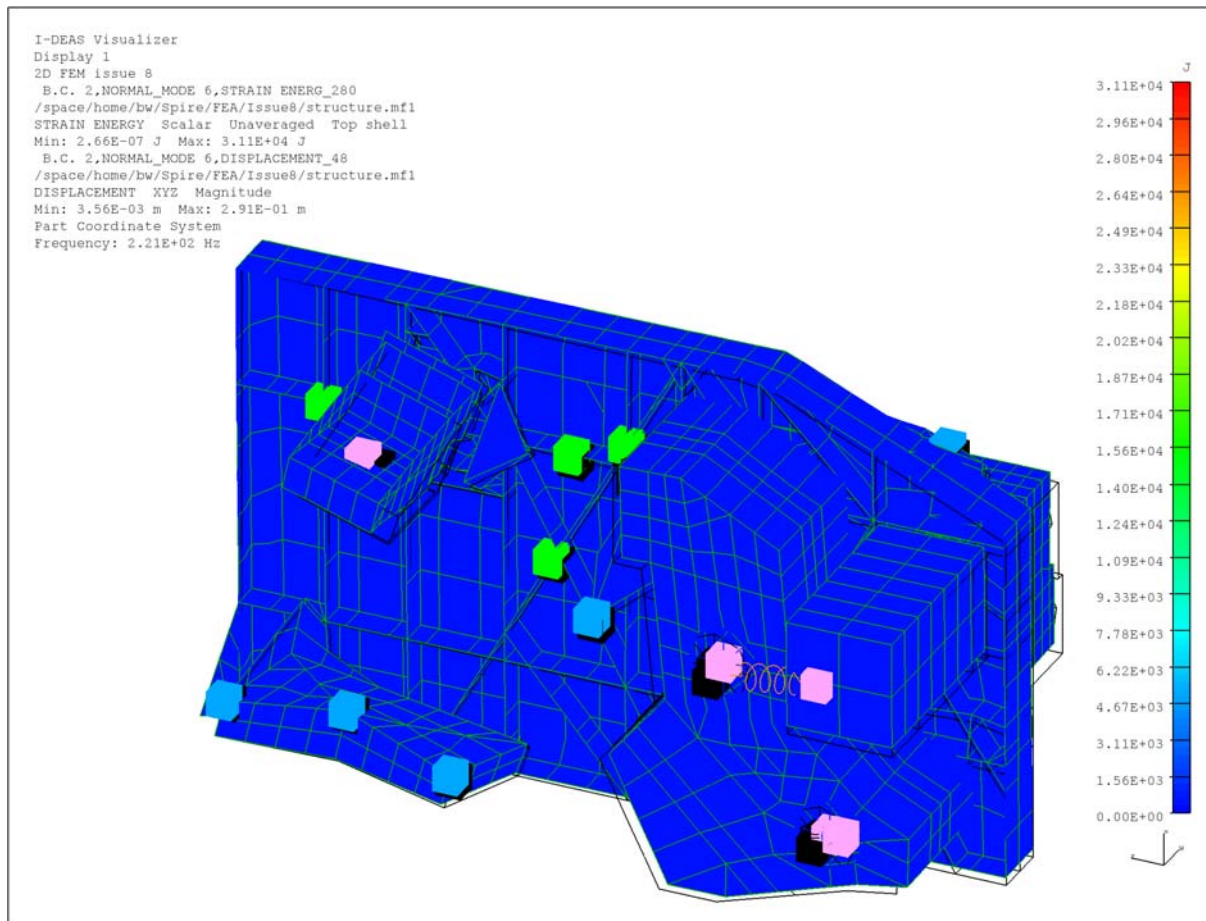
Fourth Mode 191 Hz



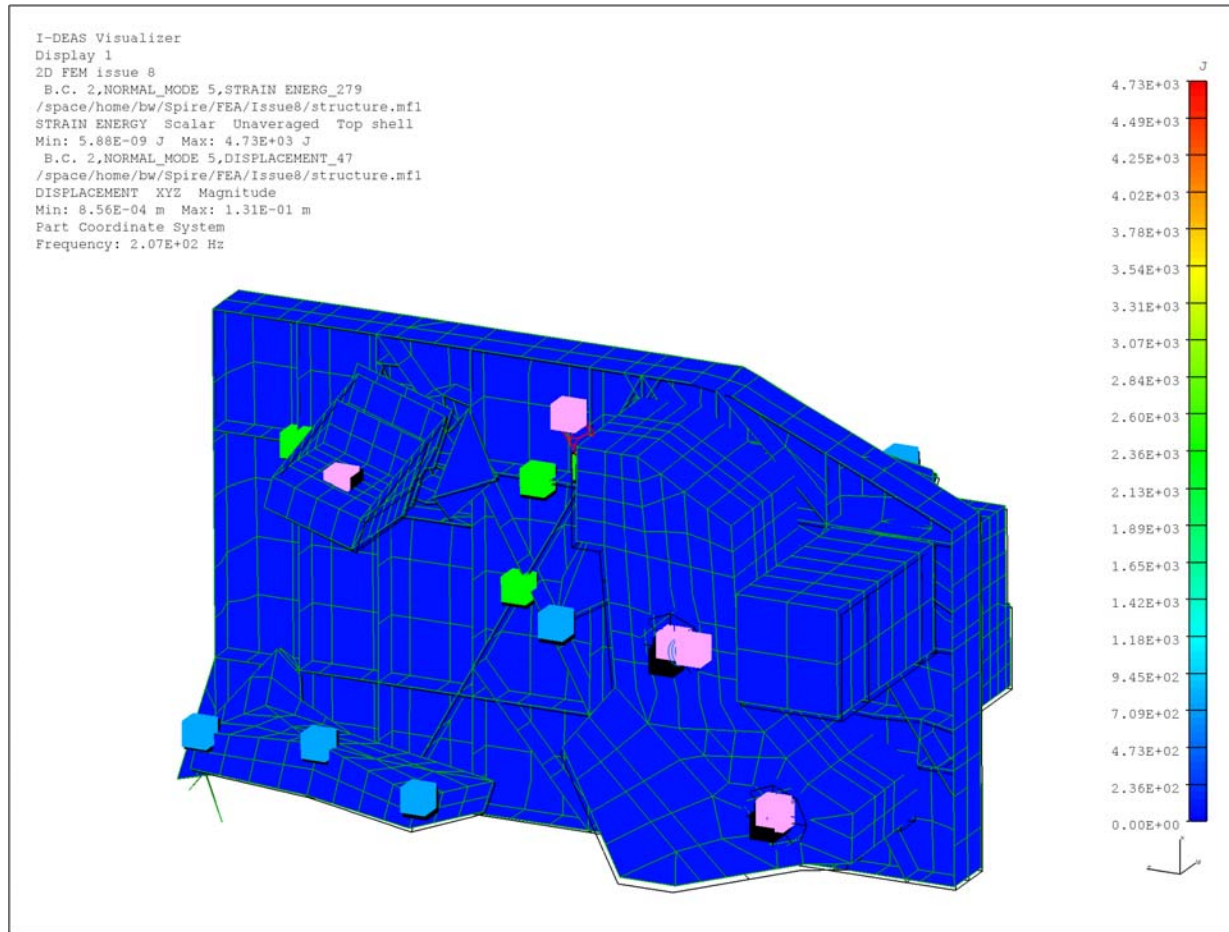
Fifth Mode 207 Hz



Sixth Mode 221 Hz

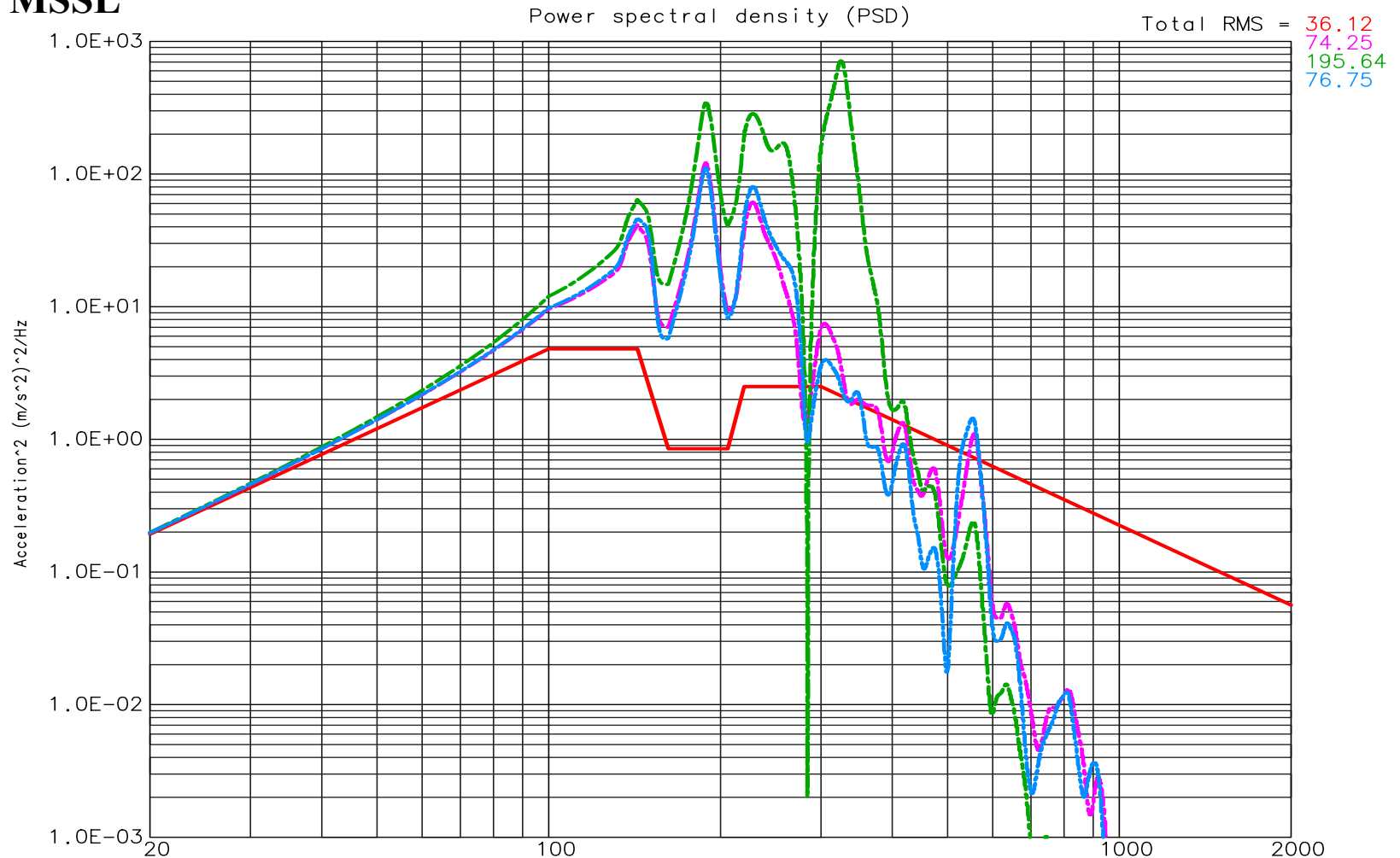


Seventh Mode 227 Hz

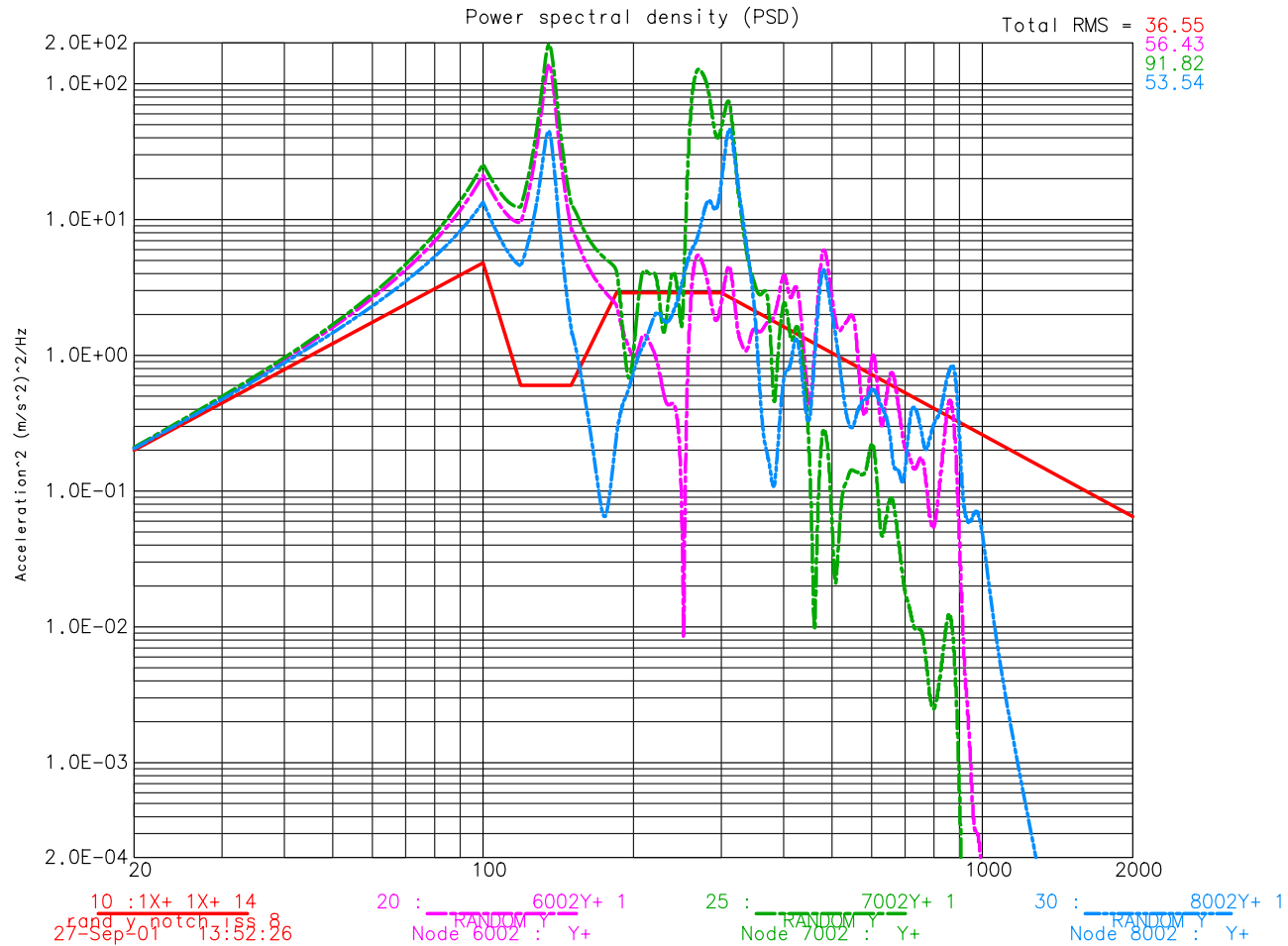




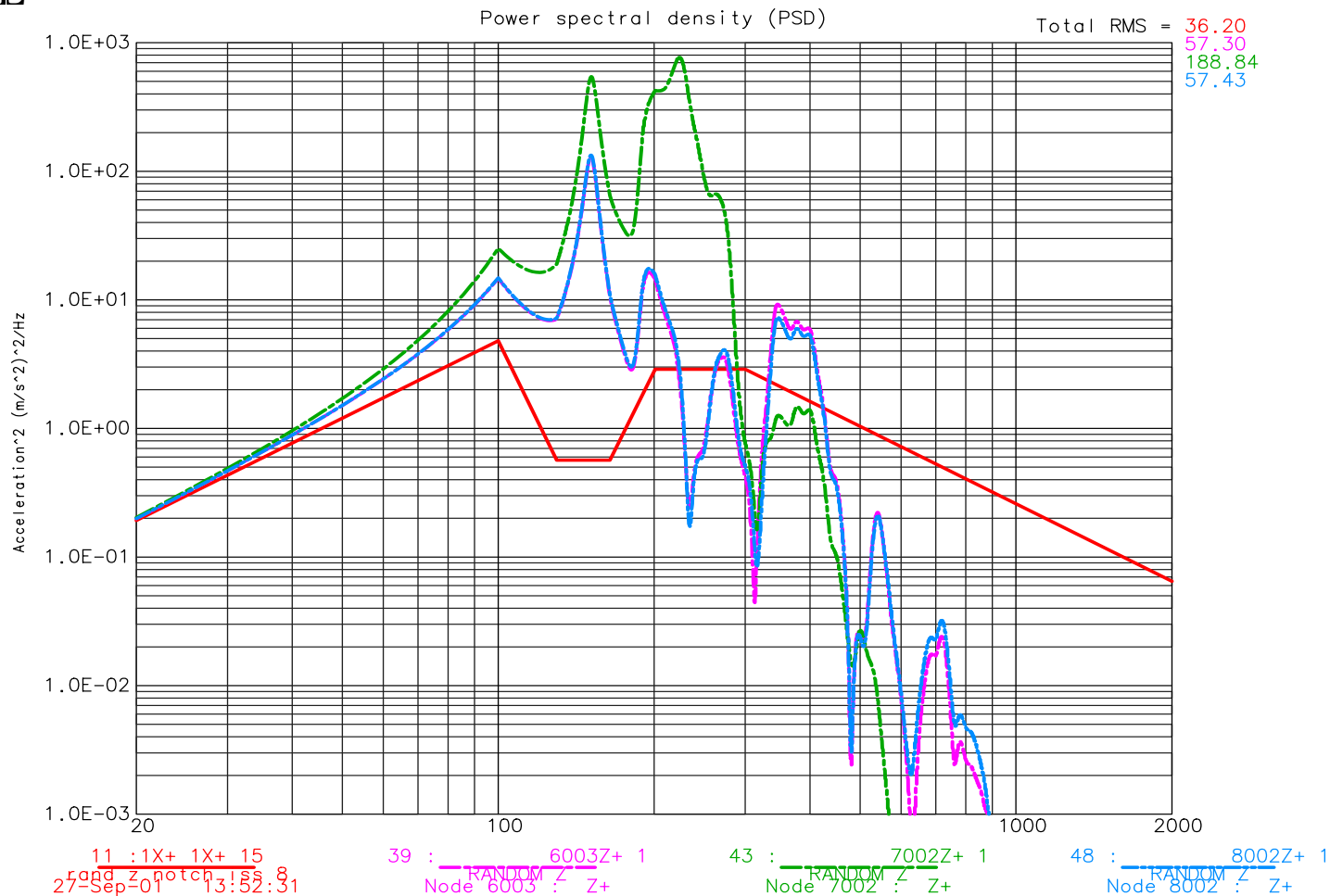
Random -X



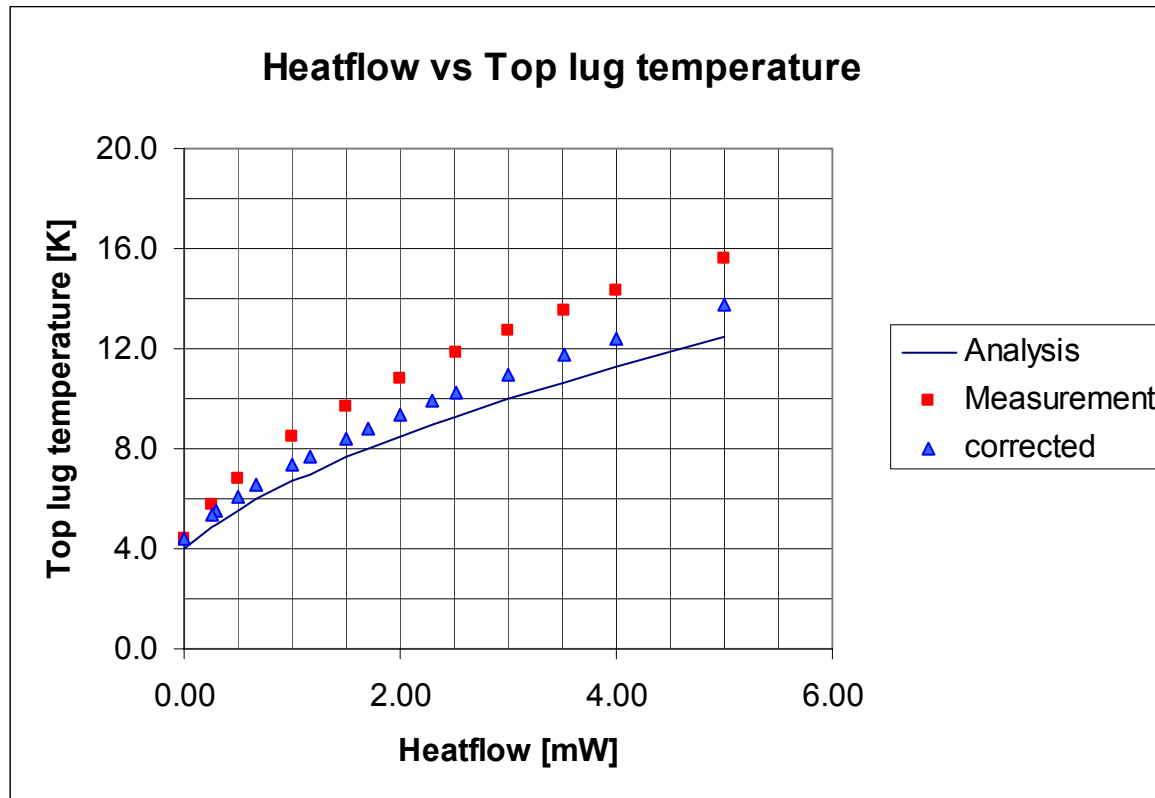
Random -Y



Random -Z

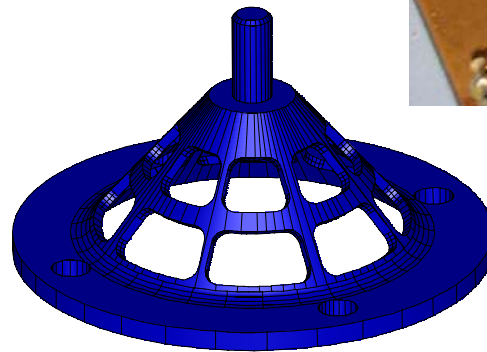
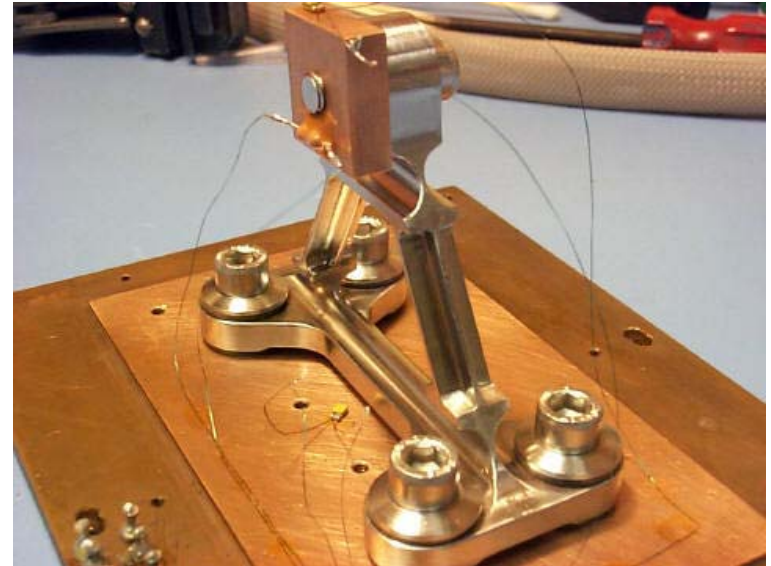
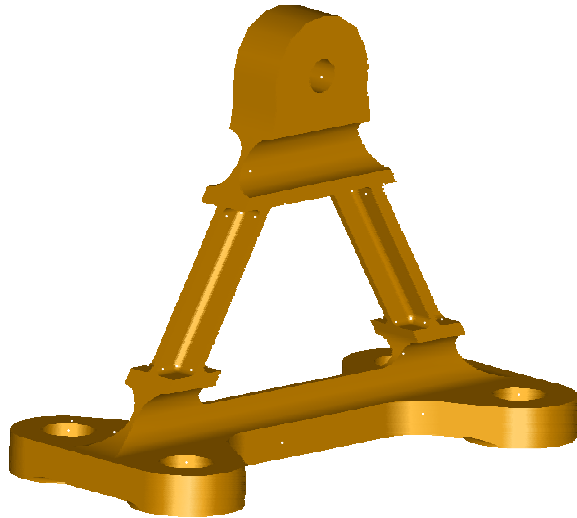


Parasitic Heat Load level 1 - 2



- Heat-flux through A-frame support

A-frame and Cone Support





Parasitic Heat Load level 1 - 2 cont.

- Heat-flux through A-frame support
 - 4.2 - 9 K boundary measured 2 mW
- Cone support
 - 4.2 - 9 K boundary analysed 2 mW (based upon A-frame measurements)
- Total parasitic heat load
 - 6 mW



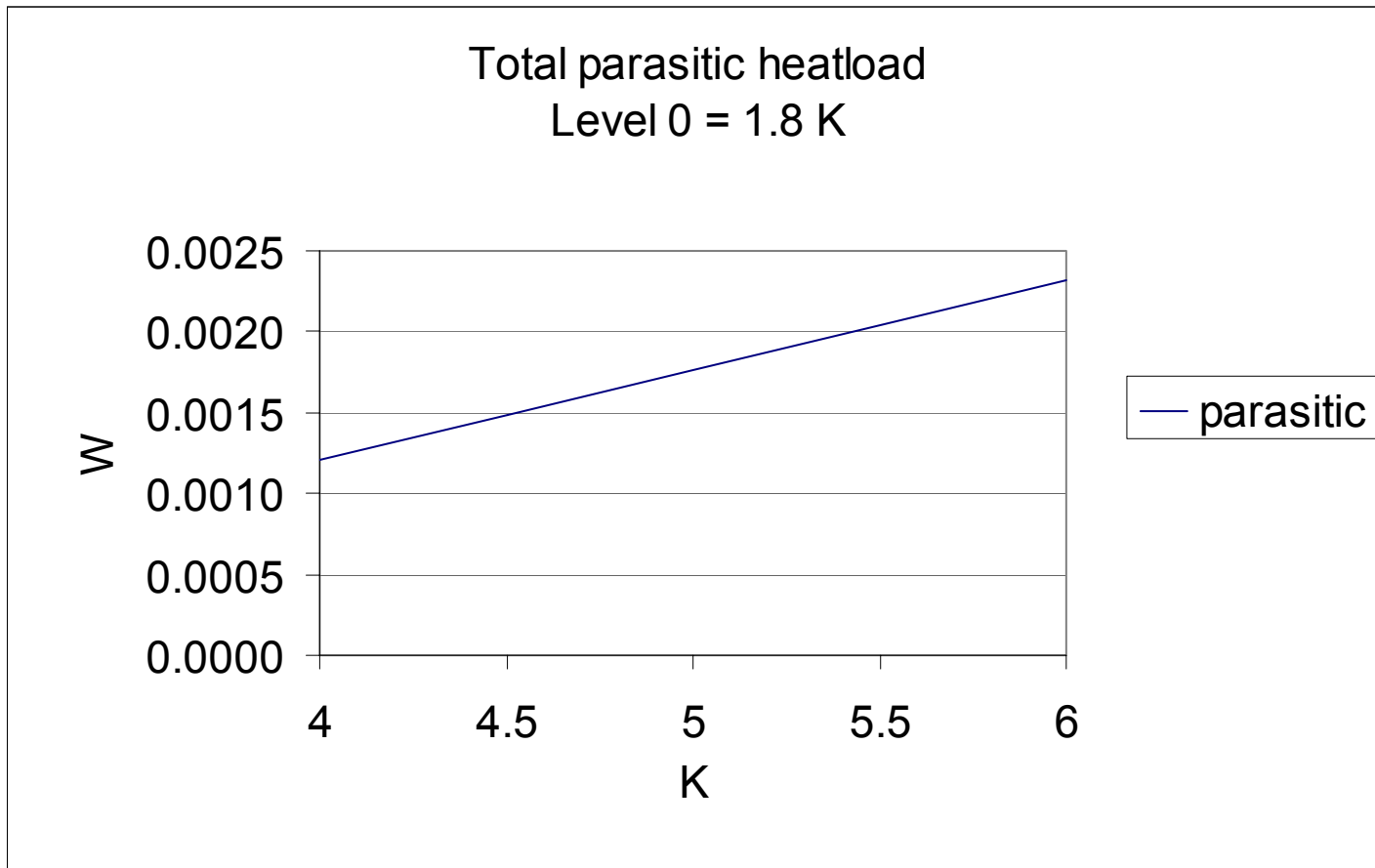
Parasitic Heat Load level 0 - 1

- Two A-frames for photometer box support
- One cone for photometer box support
- Total A/L = 2.0E-3 m

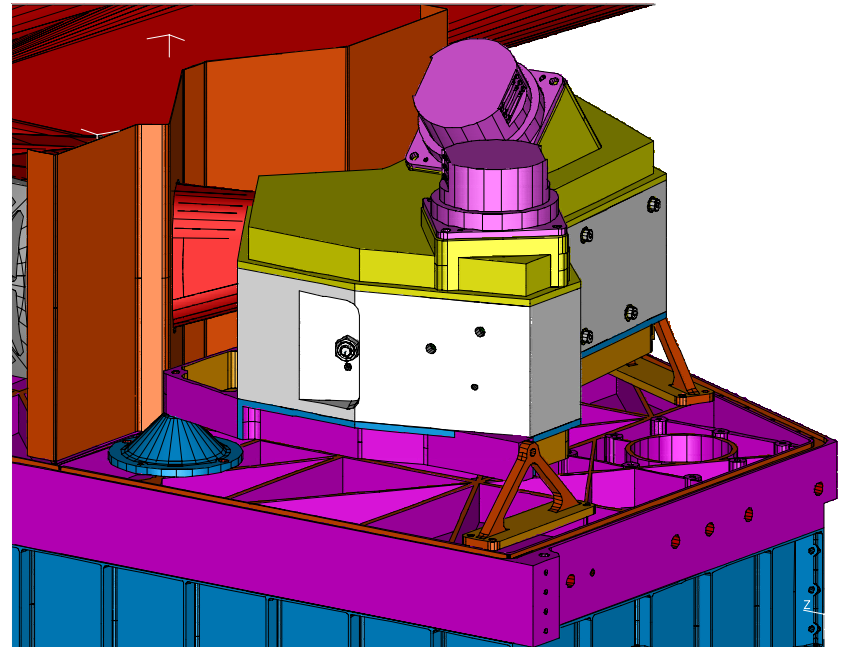
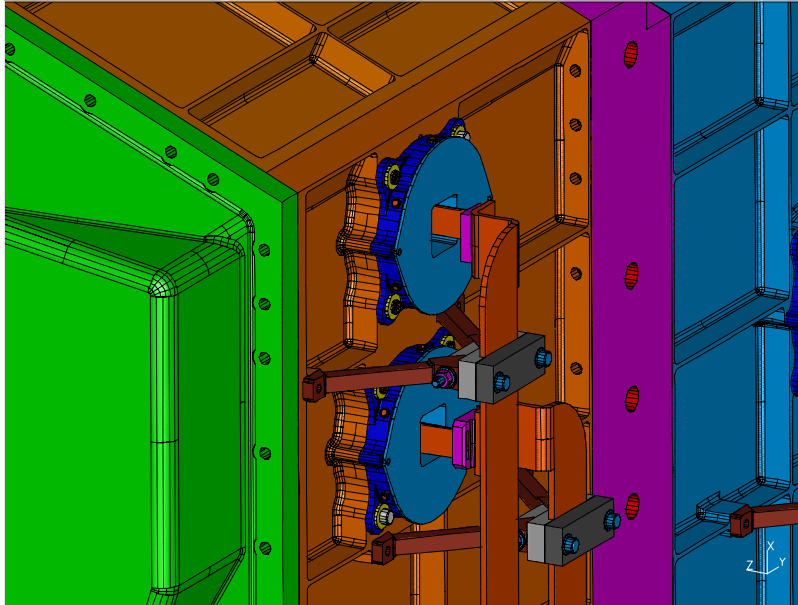
- 3 bi-pots for detector box support
- Total A/L = 0.9E-3 m

- Temperature law: $K = 0.1T - 0.1$ (based upon measurements)

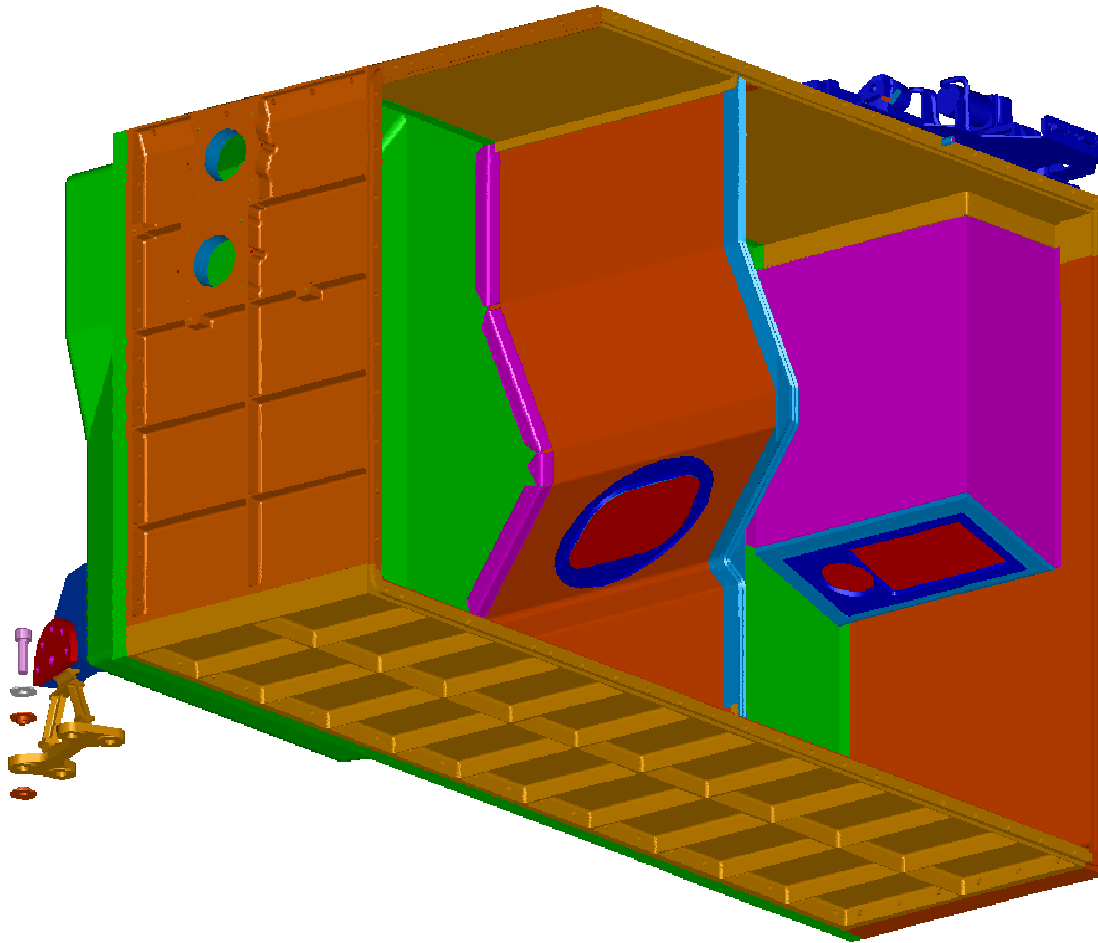
Parasitic Heat Load level 0 - 1 cont.



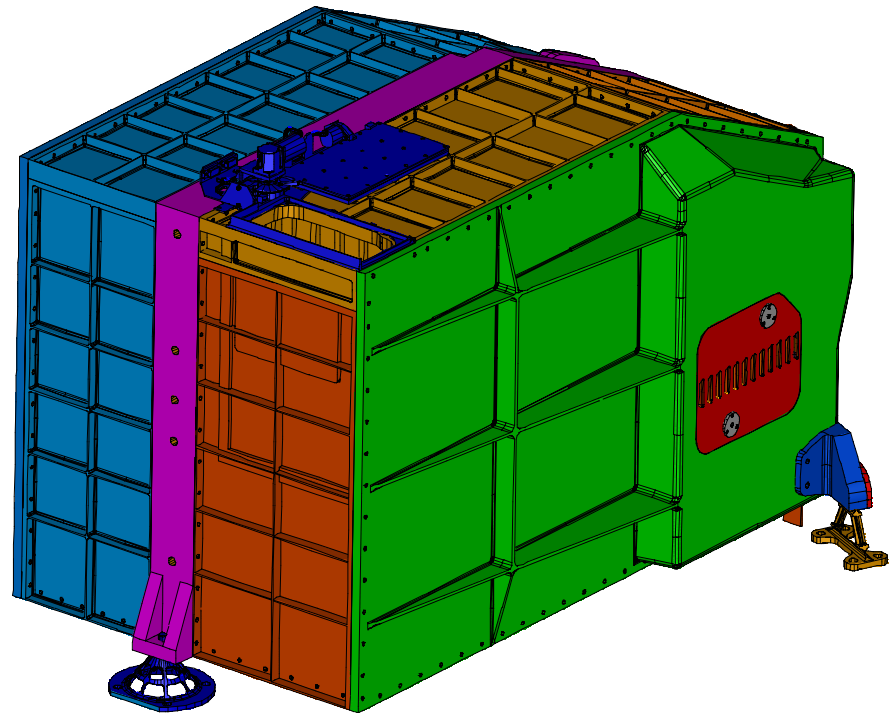
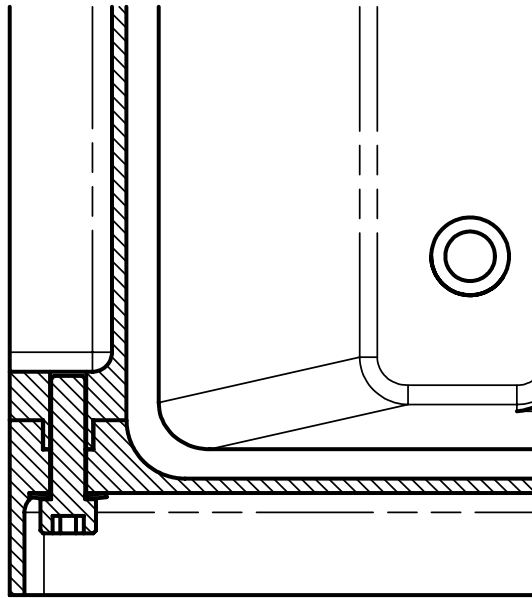
Stray Light



Stray Light cont.



RF-attenuation



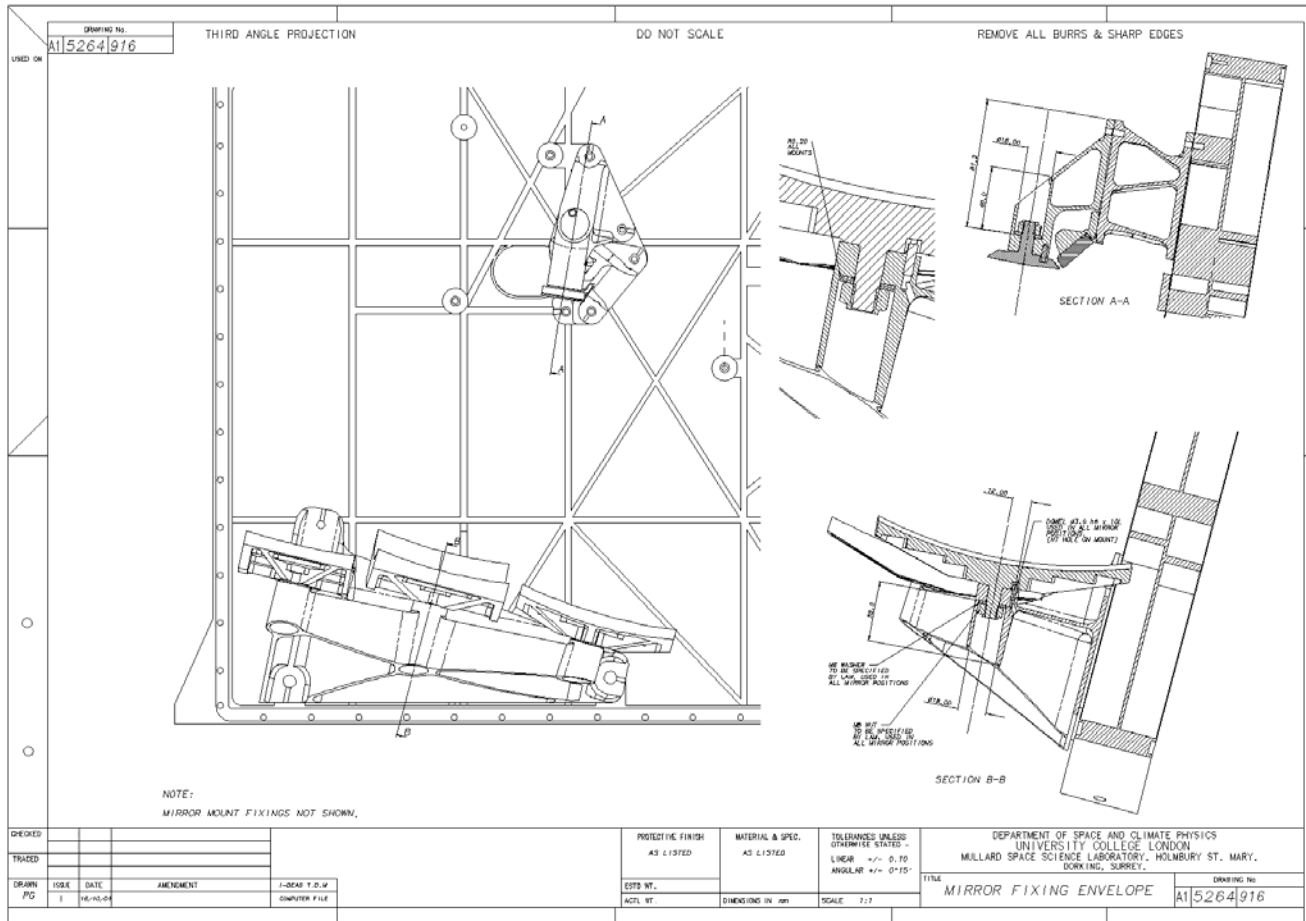
Alignment

- Not reported as such (sorry)
 - all optical parts will be mounted with a nominal tolerance of better than 0.05 mm
 - RSS value for allowable 0.1 mm mirror off-set allows 4 ‘jumps’
 - Reference for alignment is optical bench
 - To almost all mirrors the relative number of ‘jumps’ is 1-2
 - For the detector boxes the number of ‘jumps’ 4
 - Maximum overall angular error per mirror is 1 arcmin

 - The secondary optical bench, holding CM3, CM5 and PM7 are the most critical ones wrt to alignment. Due to construction relative misalignment is very minimal

 - Included combined mirror support for PM6 and SM6, allowing mis-alignment correction

Alignment





Herschel/SPIRE structure DDR

Main Interfaces

John Coker
Paul Gocher
Berend Winter

Mullard Space Science Laboratory
University College London

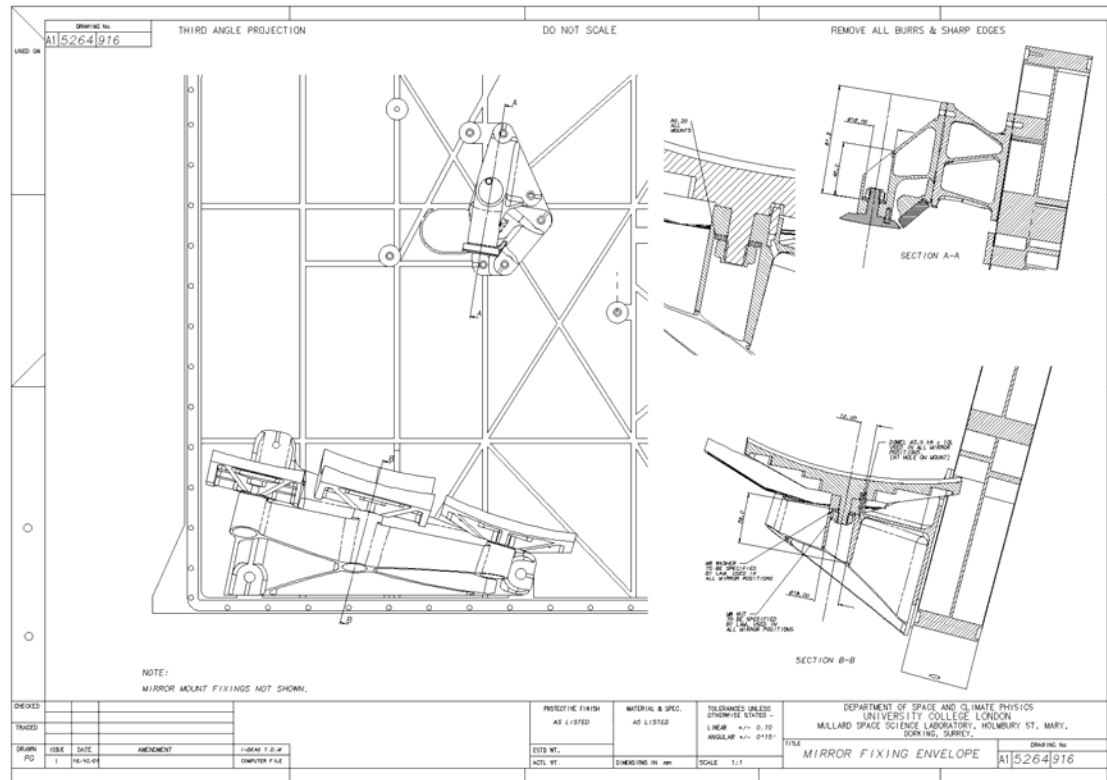


Main Interfaces

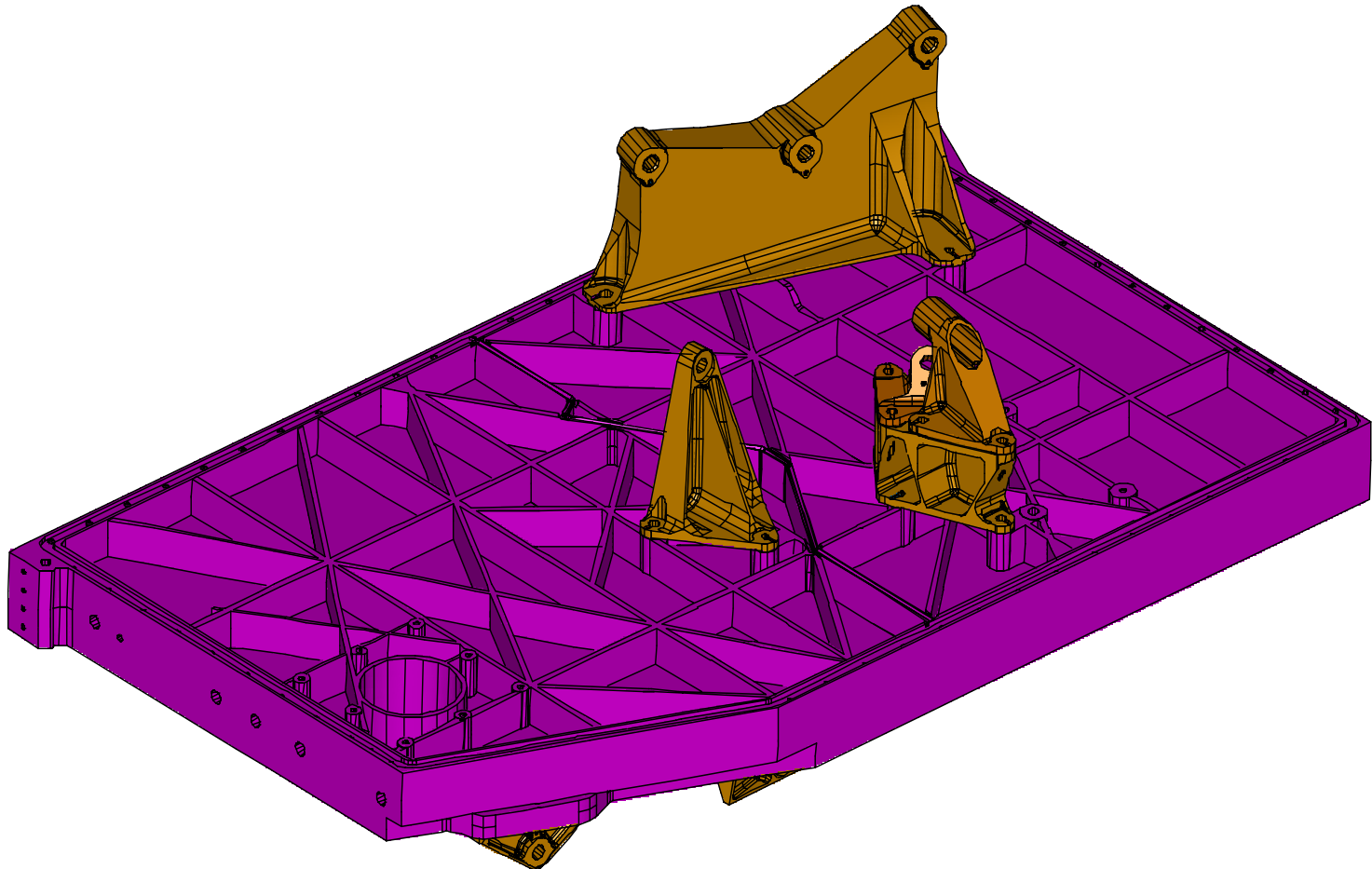
- Mirrors – LAM
- Filters – Cardiff
- Beam Splitters - Cardiff
- Dichroics – Cardiff
- Cooler – CEA
- Detectors – JPL
- BSM – ATC
- SMEC – LAM
- RF Filters – JPL
- Shutter – UofS
- Scal – Cardiff
- JFETS - RAL
- Thermistors – RAL
- Straylight Baffles
- Cardiff Black – Cardiff
- Cold Stops - MSSL

Mirror Mounts

- Interface frozen

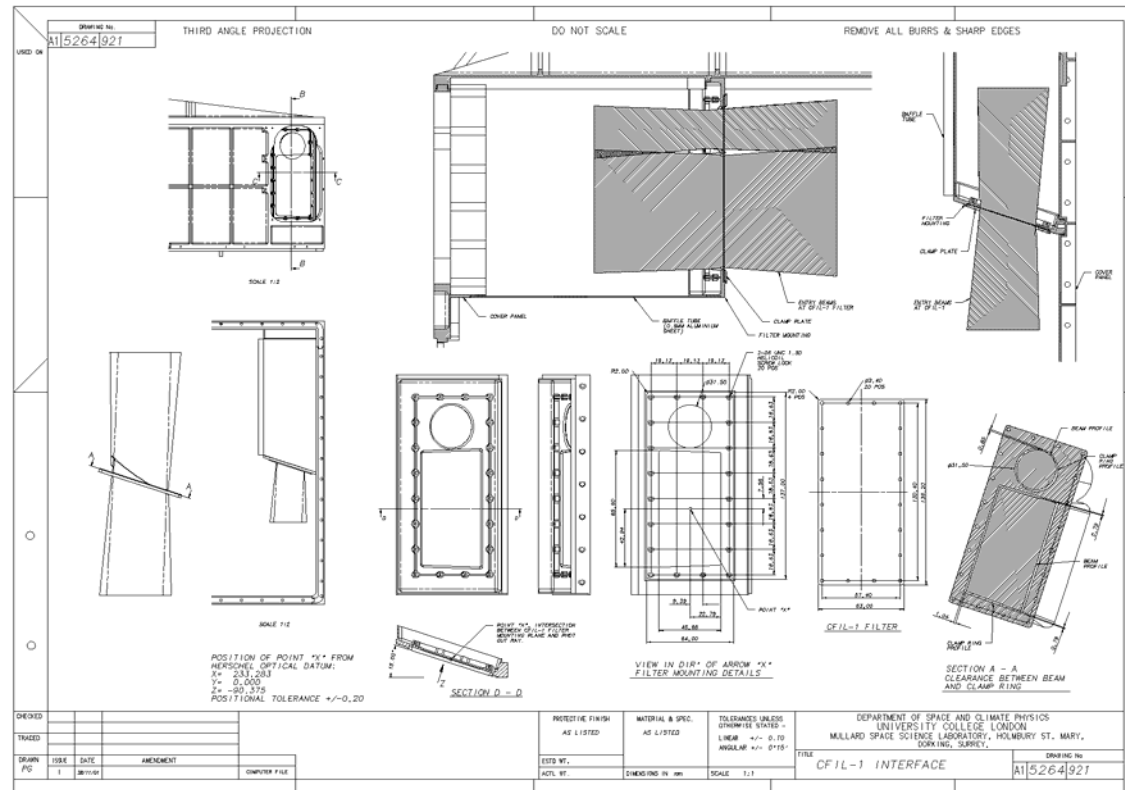


Mirror mounts cont.



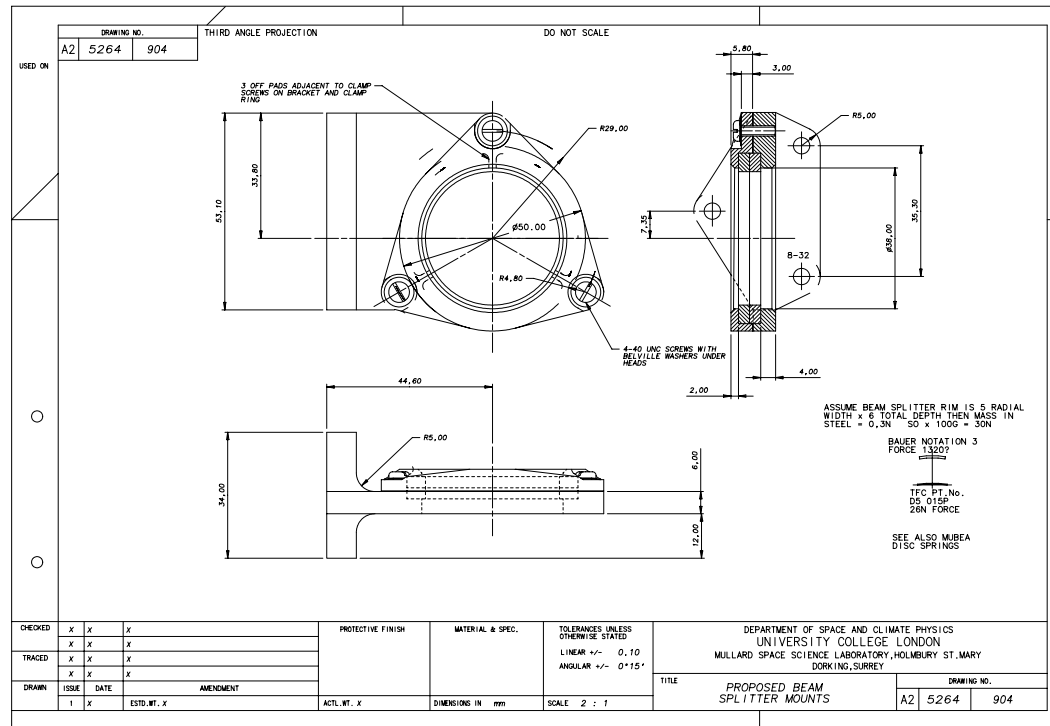
Filters

- Interface frozen

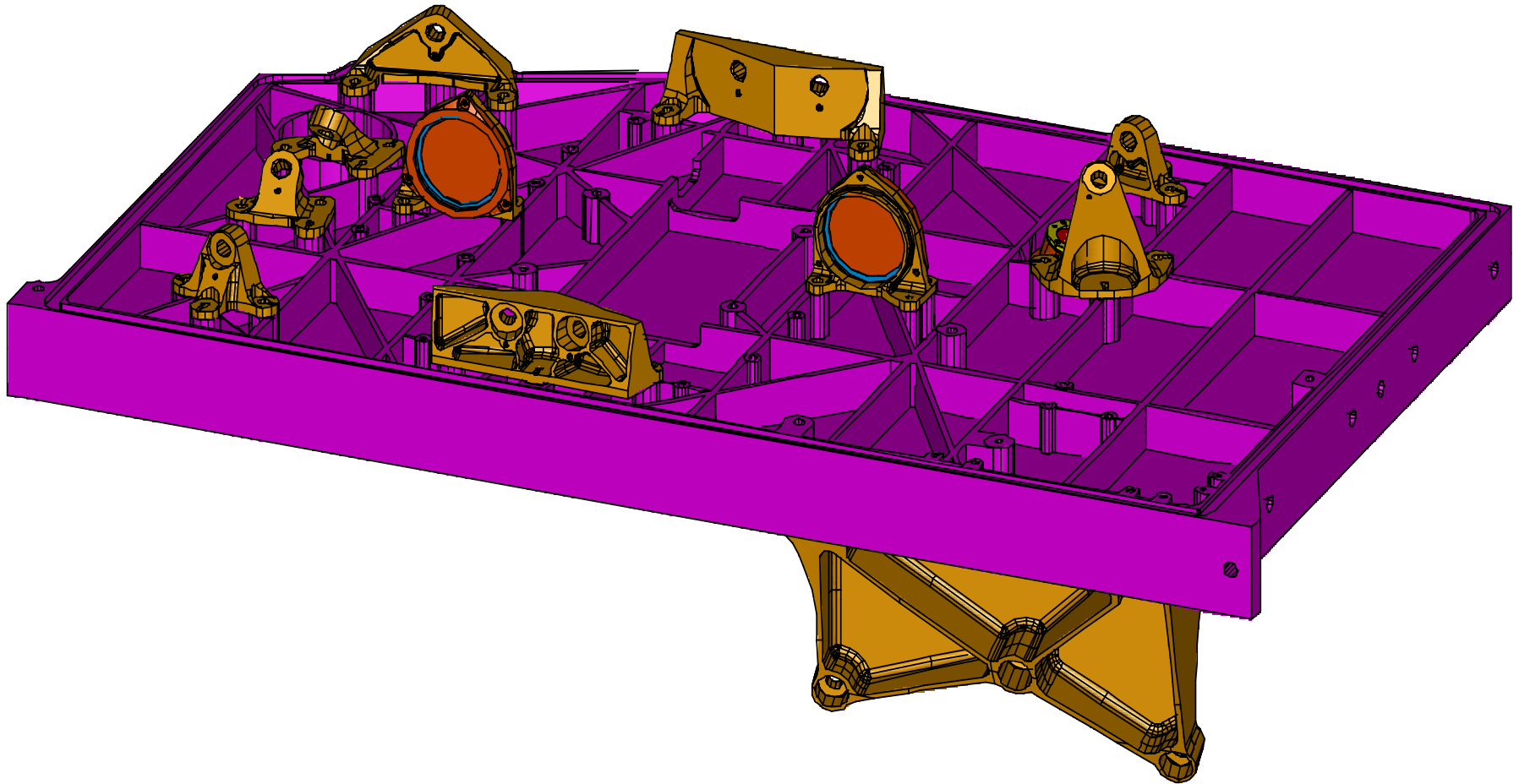


Beam Splitters

- Interface frozen
- Need overall thickness with the rims on

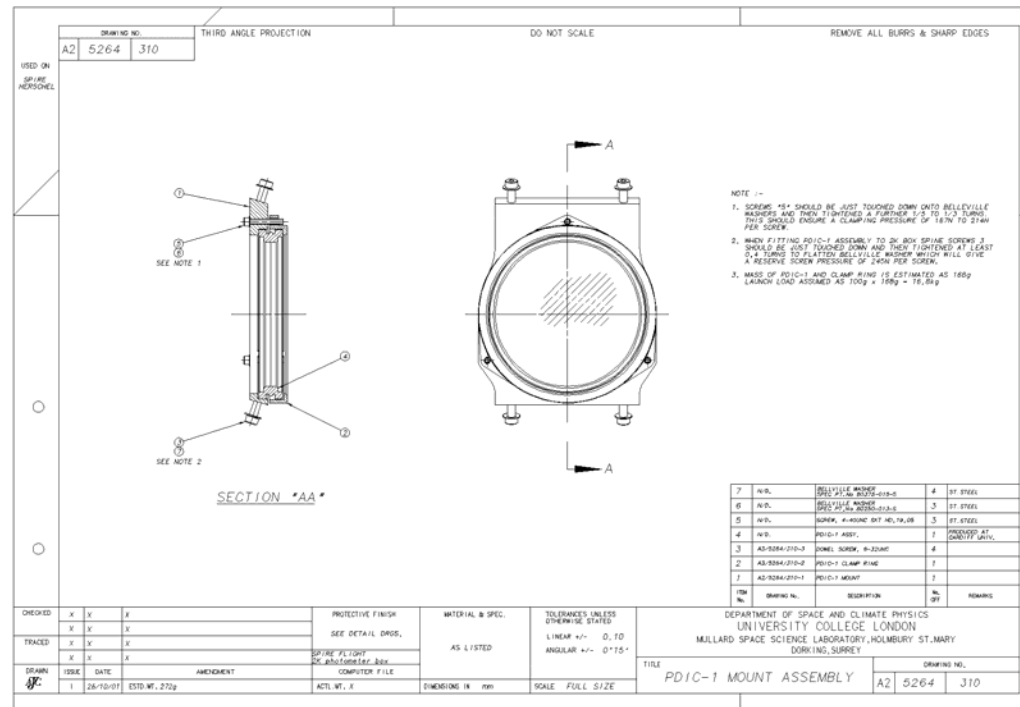


Beam Splitters cont.



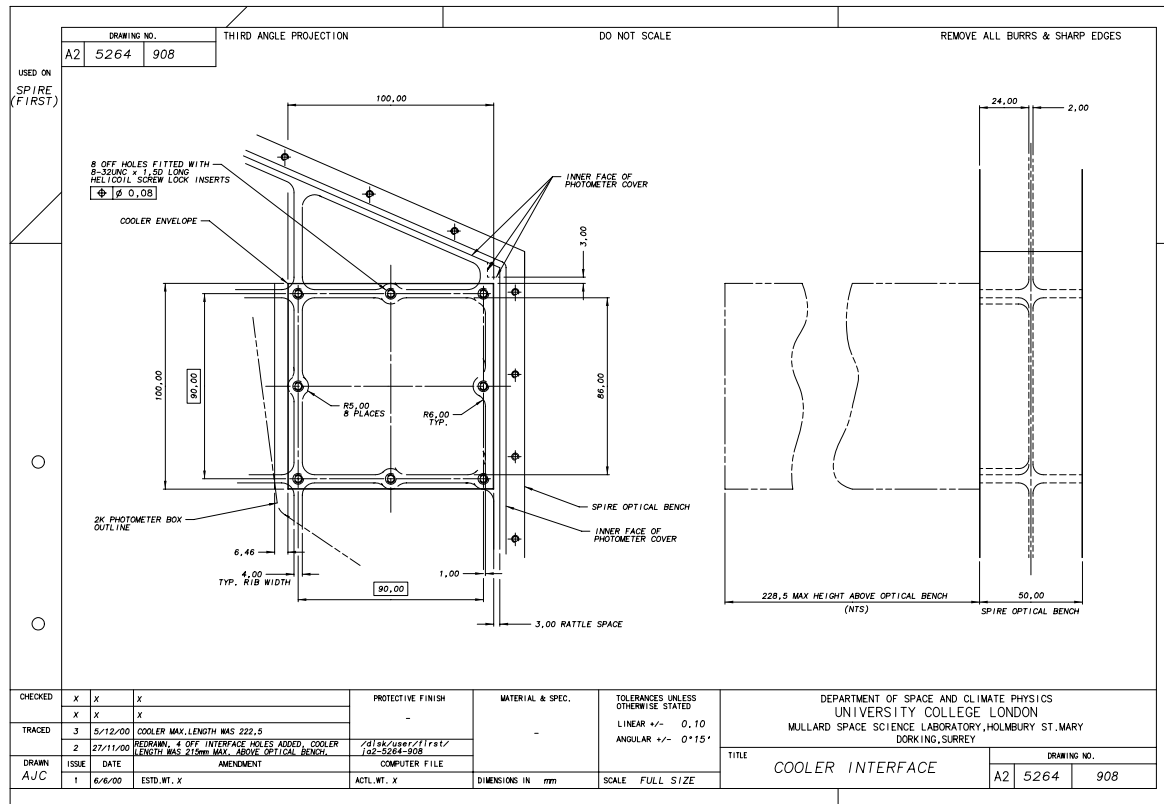
Dichroics

- Interface frozen

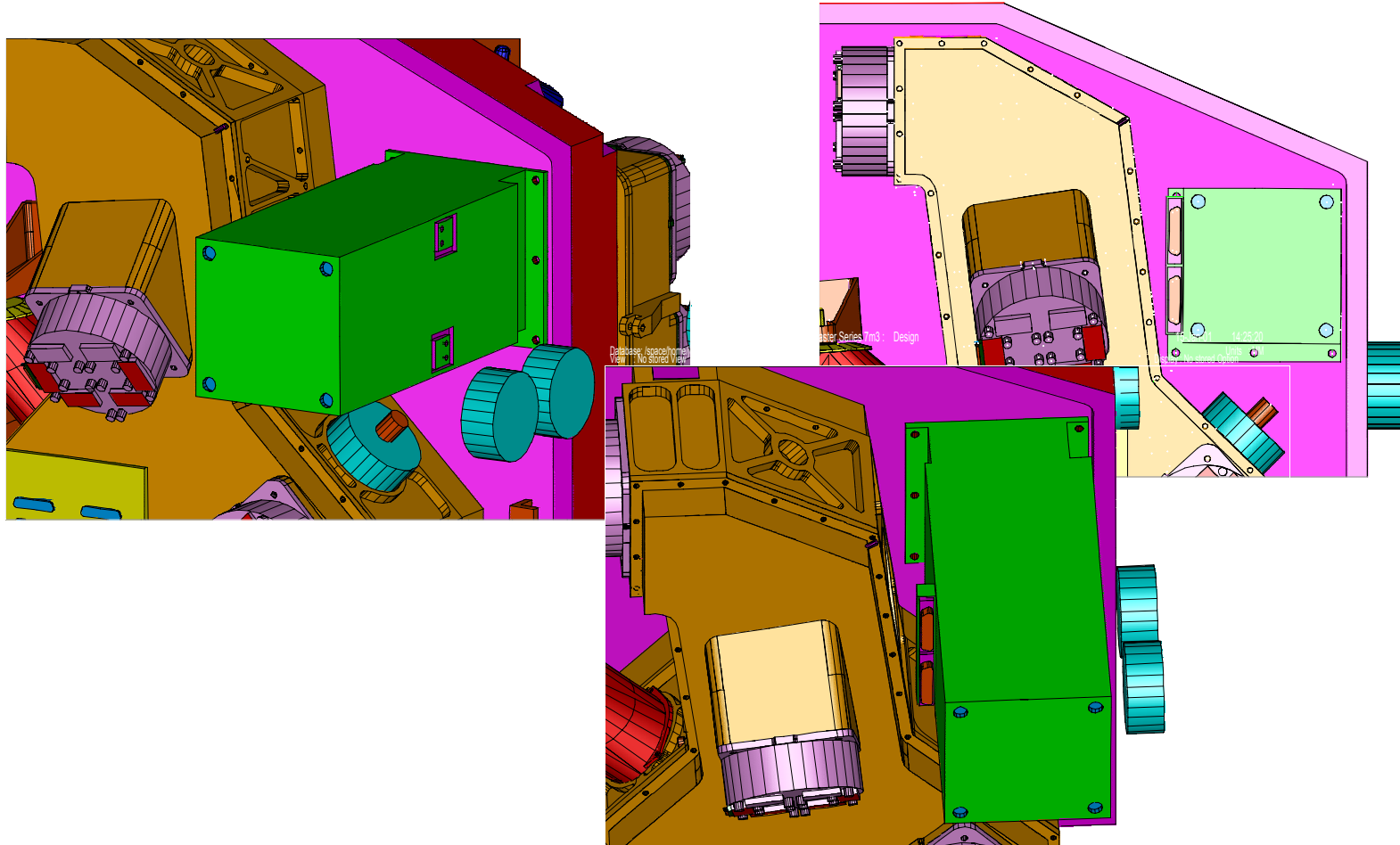


Cooler

- Interface frozen

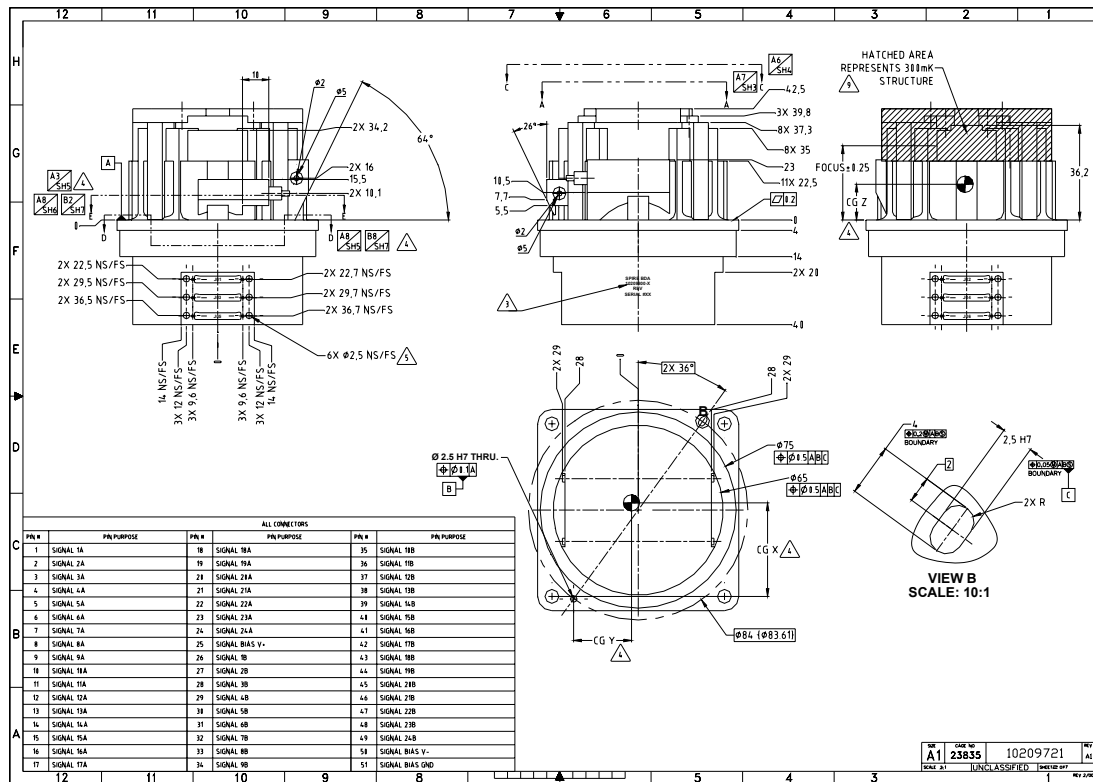


Cooler



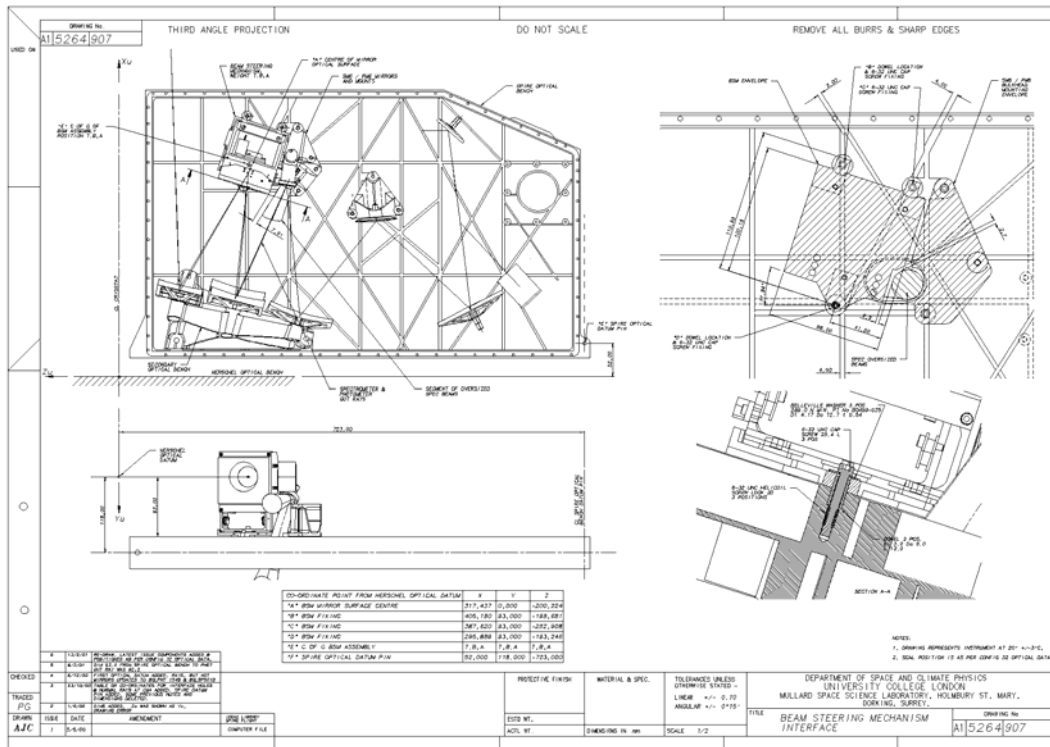
Detectors

- Interface frozen



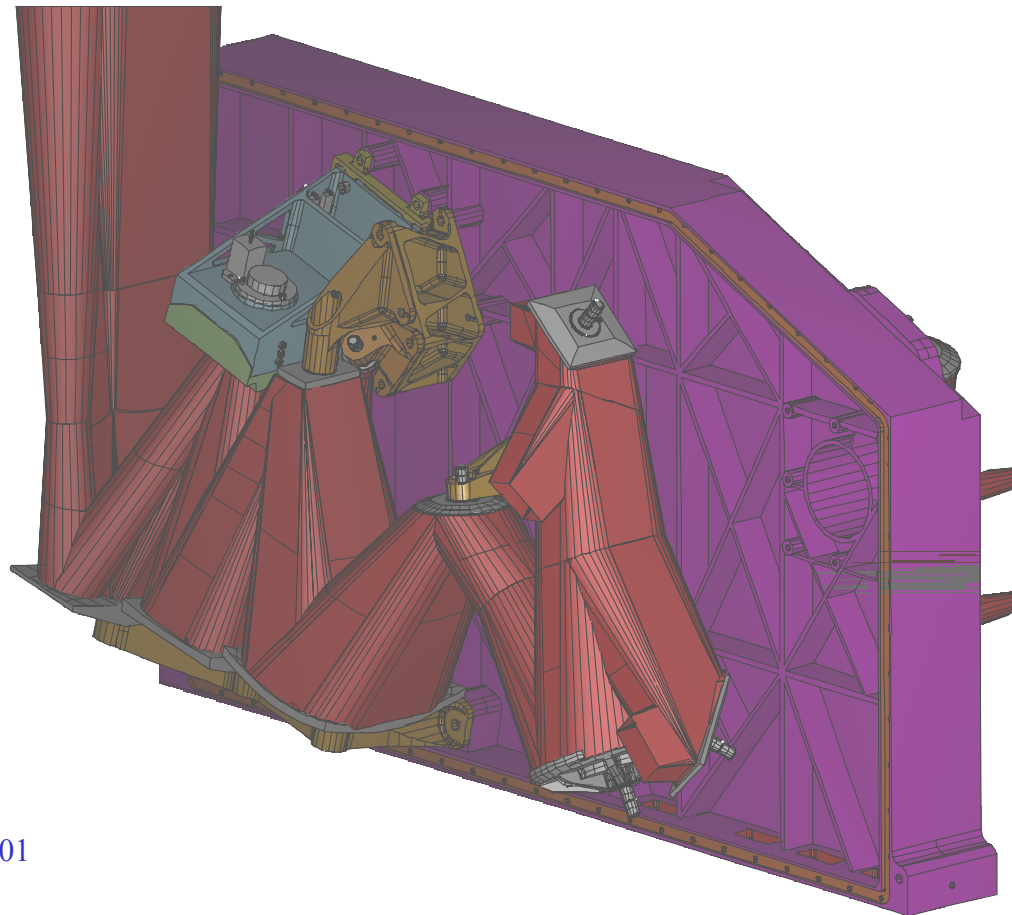
BSM

- Interface frozen



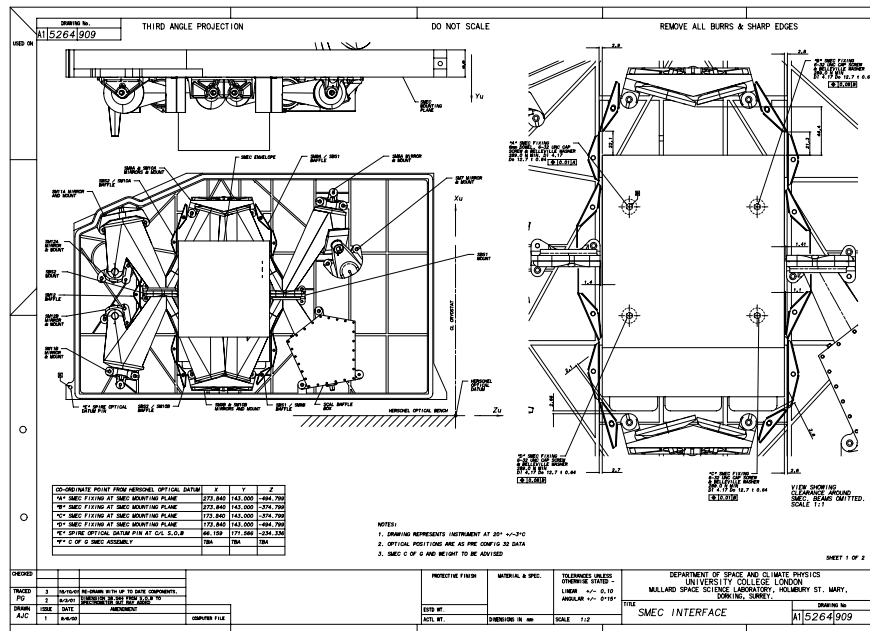
BSM

- Interface frozen

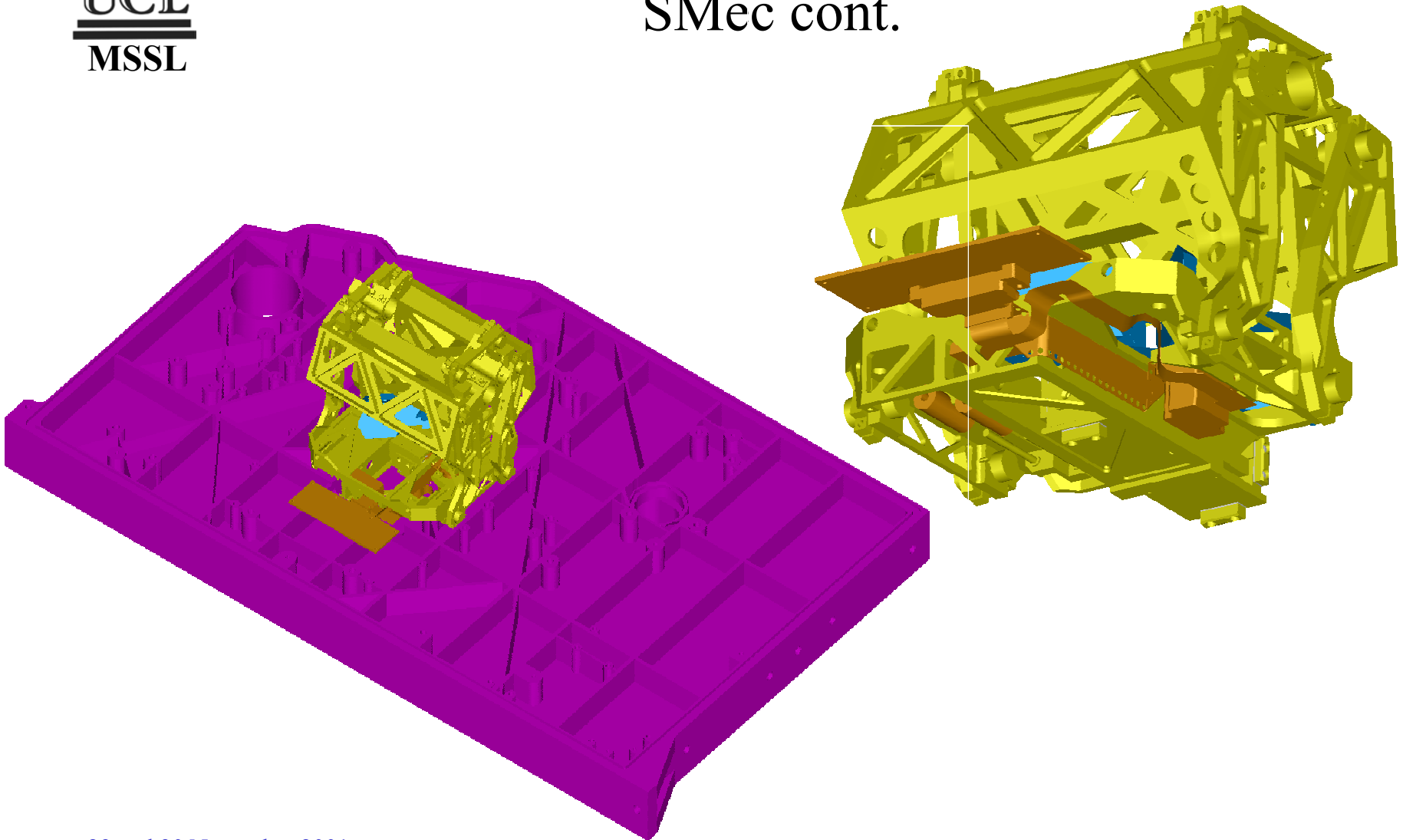


SMec

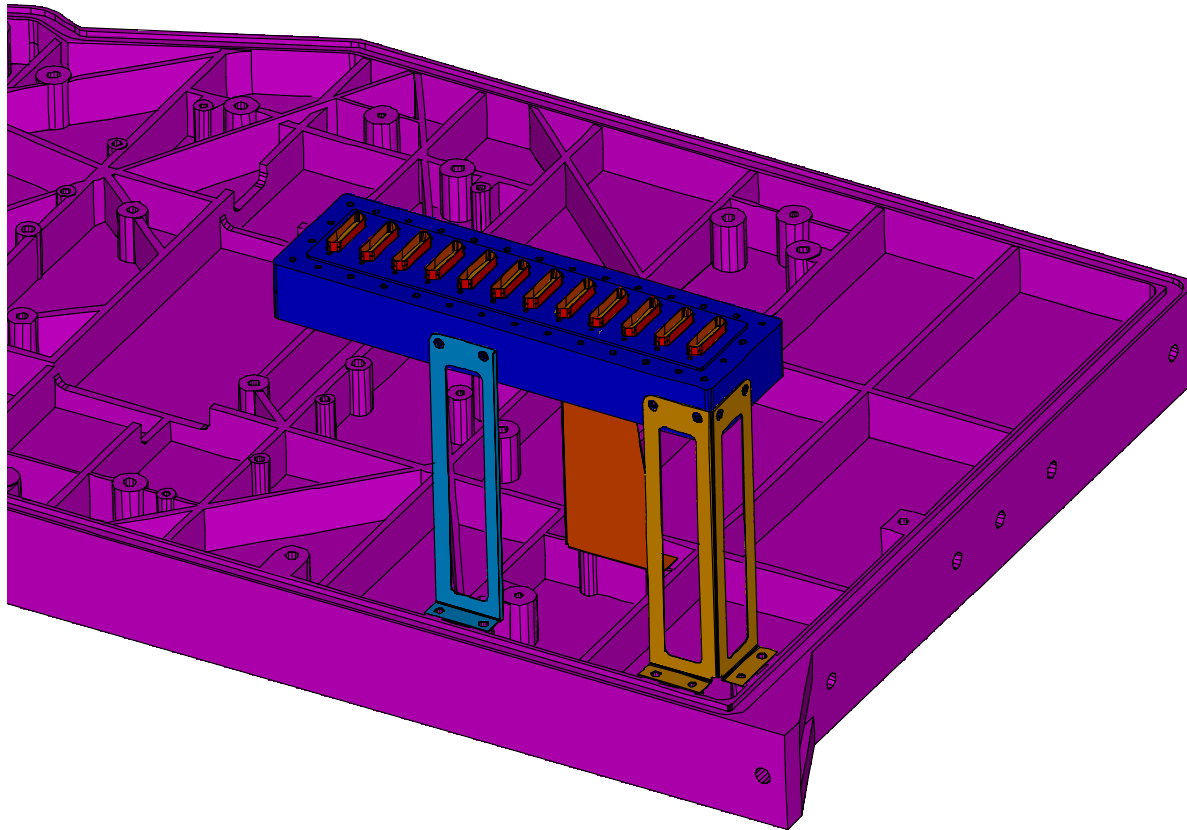
- Interface open, last minor clashes to be sorted after DDR
 - effectively the SMec has a complicated interface with the optical bench
 - LAM, responsible for the SMec design specifies local design of the optical bench



SMec cont.

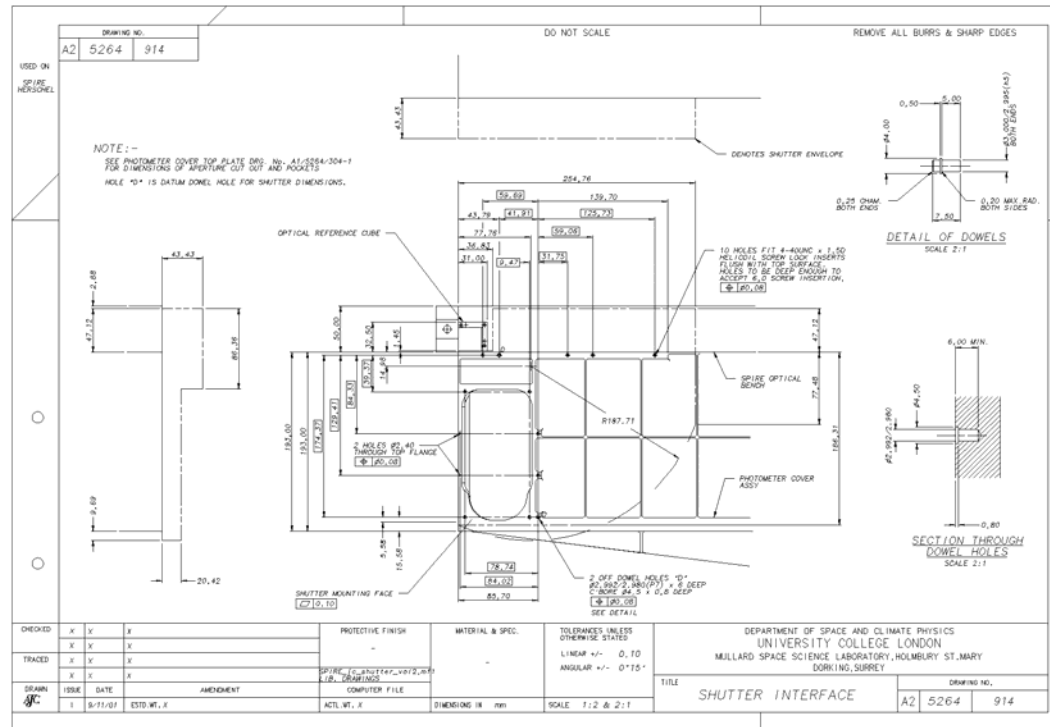


RF-filters Cont.



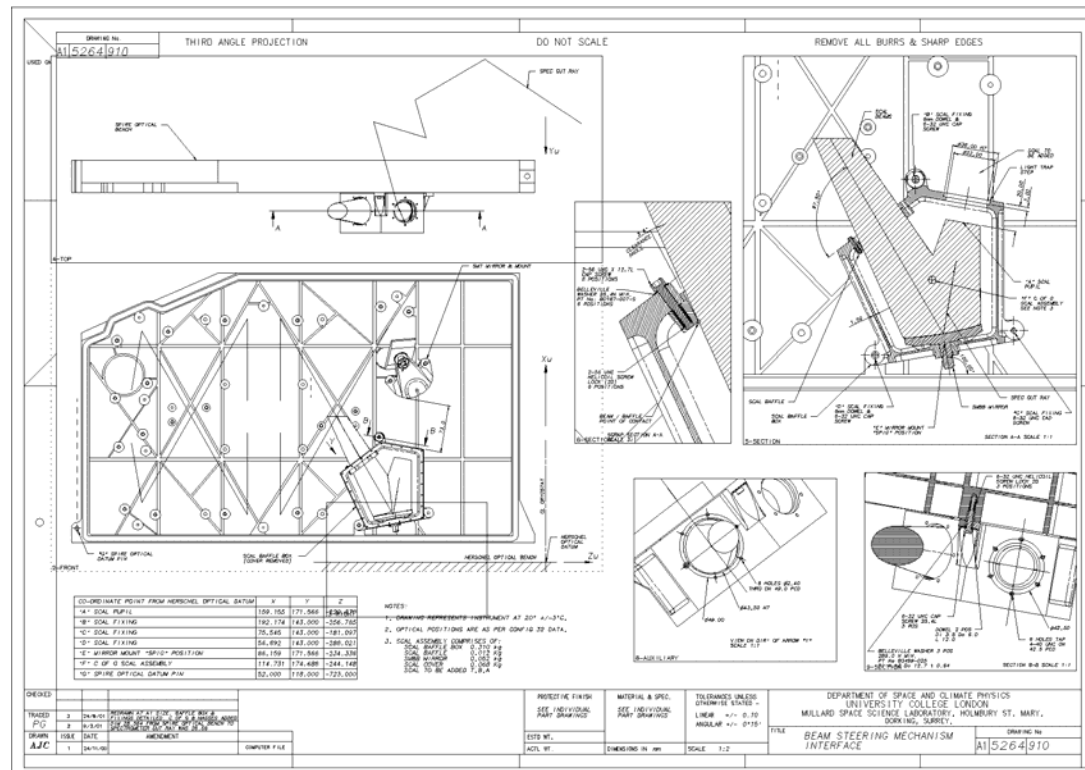
Shutter

- Interface frozen



S-Cal

- Interface frozen





JFETS

- Interface Closed
 - now RAL responsibility



Thermistors

- Interface open
- Mounting location to be defined
 - minor



Baffles

- Closed

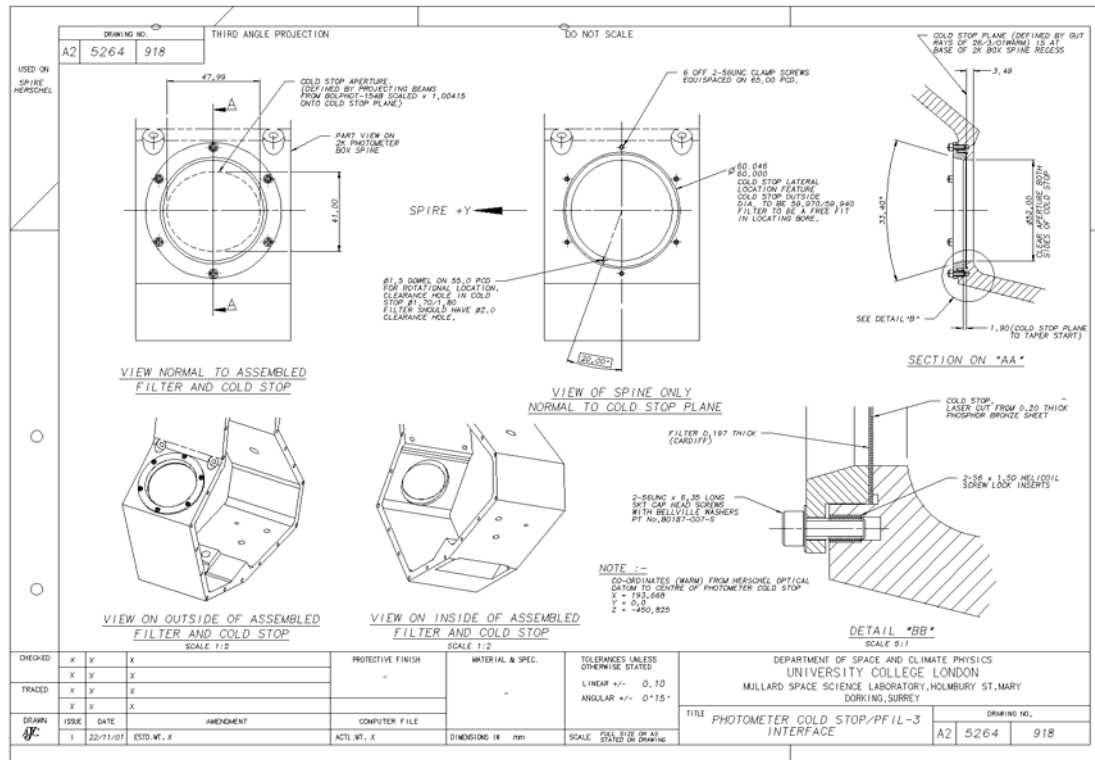


Cardiff Black

- Interface Closed
 - locations identified
 - patches at critical locations
 - needs to be formalised in interface drawing, information is available

Cold Stops

- Interface frozen





Thermal Busbar

- Design not part of this design review
 - Separate design and development team
 - Breadboard testing of engineering models is underway now
 - TO BE REWOKED



Harness

- Routing in Progress
- Need details of type of cables and proposed bundling



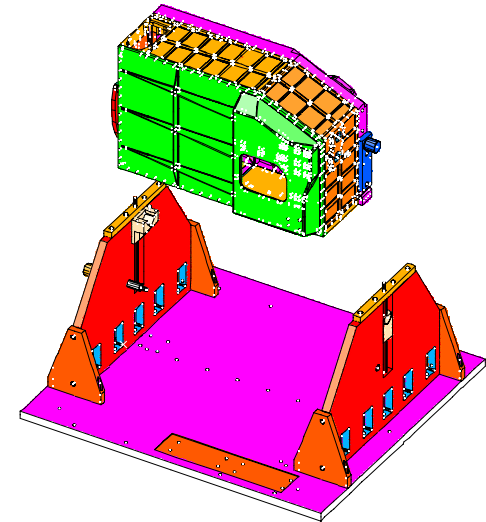
Herschel/SPIRE structure DDR MGSE

John Coker
Peter Bonhomme

Mullard Space Science Laboratory

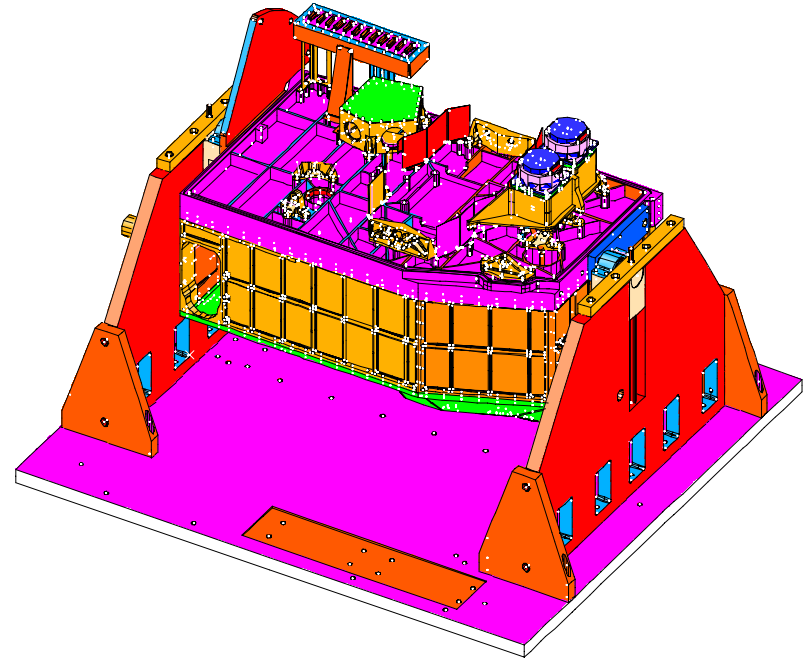
Functions of Assembly Jig

- MSSL Assembly Jig built on RAL Herschel Optical Bench Simulator (HOBS)
- Jig enables SPIRE FPU to be rotated through 360° and locked at 90 ° intervals
- HOBS forms transport base for SPIRE FPU
- HOBS used for Vibration test base for SPIRE FPU
- Jig has jacking for controlled mating of FPU to HOBS



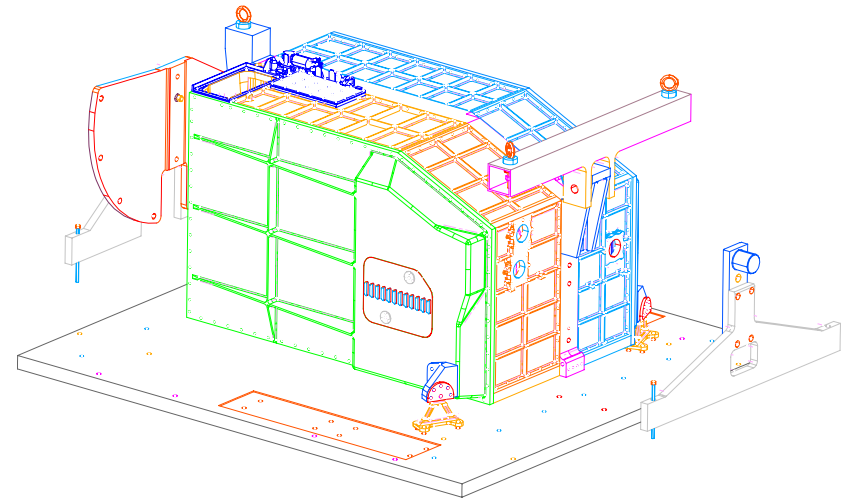
Use of Assembly Jig

- Rotation Journals fitted to SOB/Photometer cover sub assembly
- Above assy. fitted to jig which has been installed on HOBS
- Assembly Of all FPU parts
- Optical Alignment



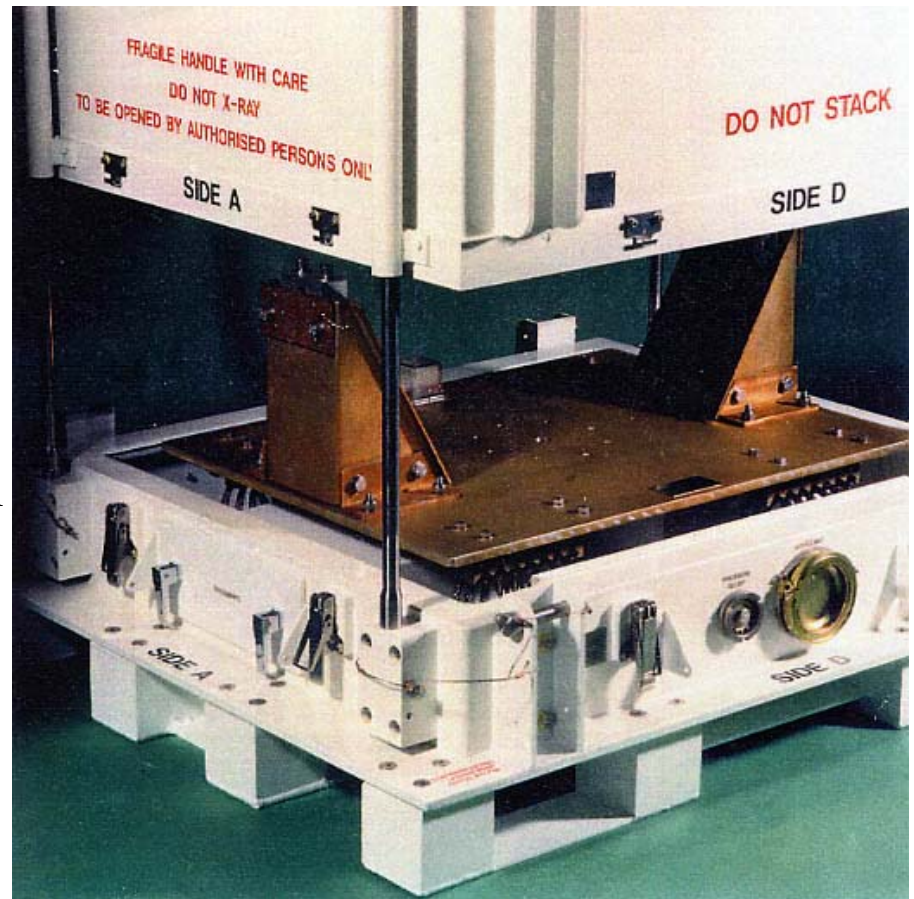
Removal of SPIRE FPU From Assembly Jig

- FPU lowered onto HOBS and jig end plates removed for transport and vibration testing
- FPU/HOBS assembly lifted via eyes in HOBS in this configuration
- FPU fitted with lifting frame for removal from assembly jig or HOBS and fitting to spacecraft
- Cone fitted to spacecraft
- FPU lowered to engage cone spigot and rear frame positions



Transport Case (Light Alloy Limited)

- Previous experience in flight equipment transport cases
- Shock resistant mounting and recording
- Humidity sensing
- Slight overpressure of case with dry nitrogen
- Lifting slings and paperwork storage etc





Herschel/SPIRE structure DDR MAIV Plan

Chris Brockley-Blatt

Mullard Space Science Laboratory
University College London

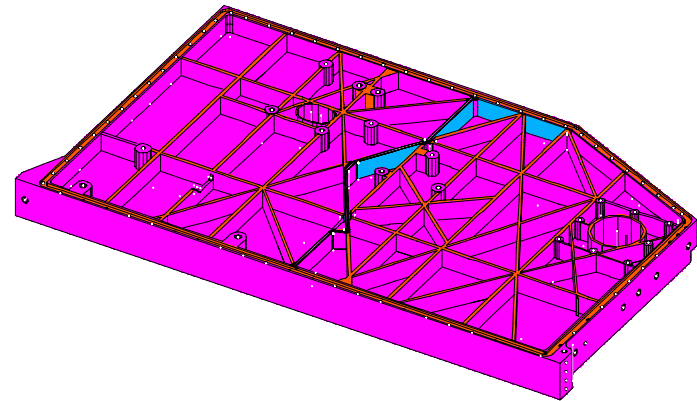


Structure AIV Plan

- HOB Simulator delivered to MSSL from RAL
- Assembly jig installed on HOB
- Photometer side cover panels assembled
- Install structure onto assembly jig
- Build up spectrometer side cover panels
- Install mirror mounts
- Install detector boxes and thermal straps
- Re-assembly covers
- Move to transport container
- Delivery to RAL

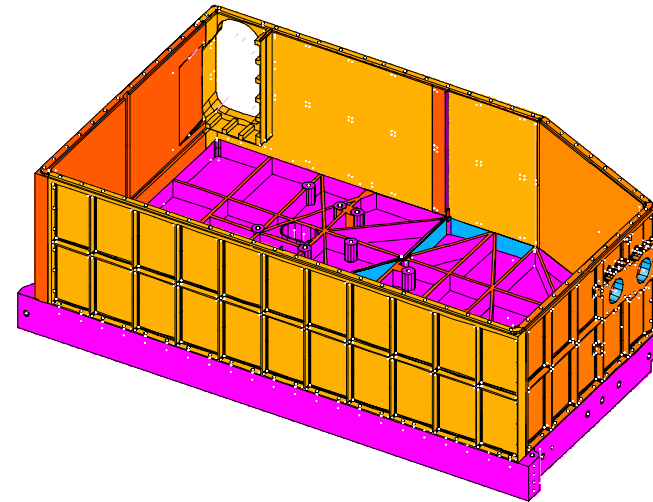
Assembly – Optical bench

- Optical bench clamped to smooth flat surface



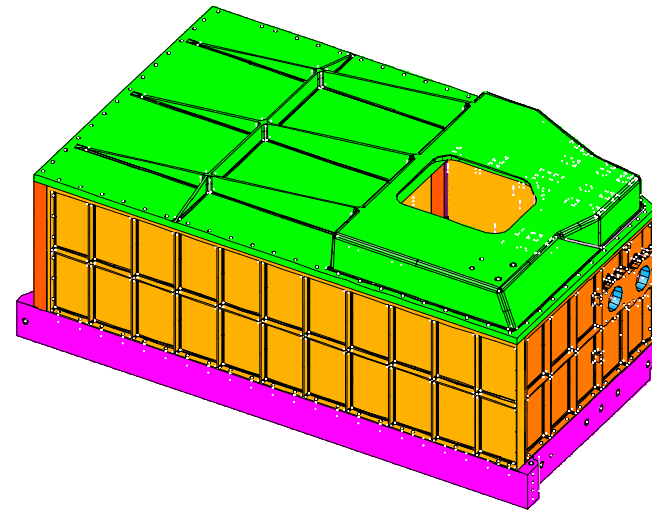
Assembly – Photometer Side Panels

- Photometer side cover panels bolted on
- Straylight baffles are integrated at same time



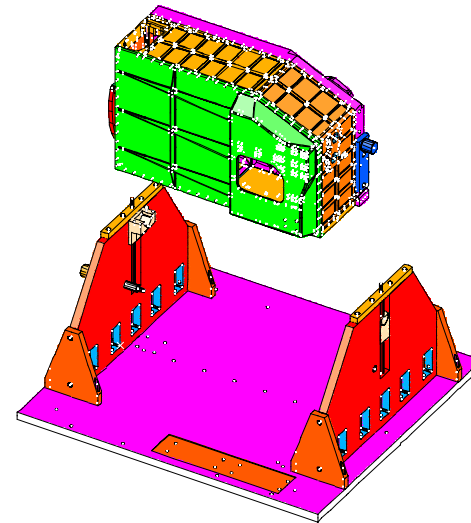
Assembly – Photometer Cover

- Photometer cover is bolted on
- Now structure is a torsionally stiff box



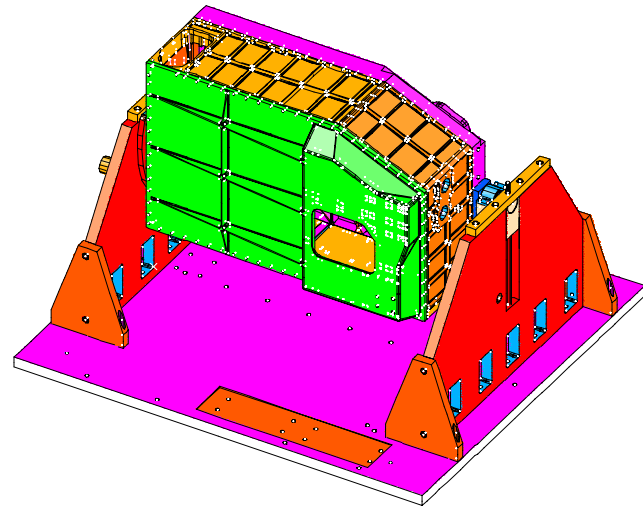
Assembly – Assembly Jig

- Structure removed from smooth surface



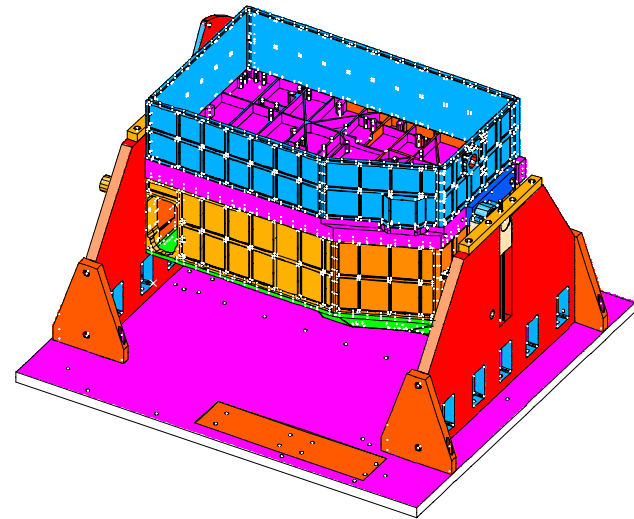
Assembly – Installation onto Jig

- Structure is installed in the assembly jig



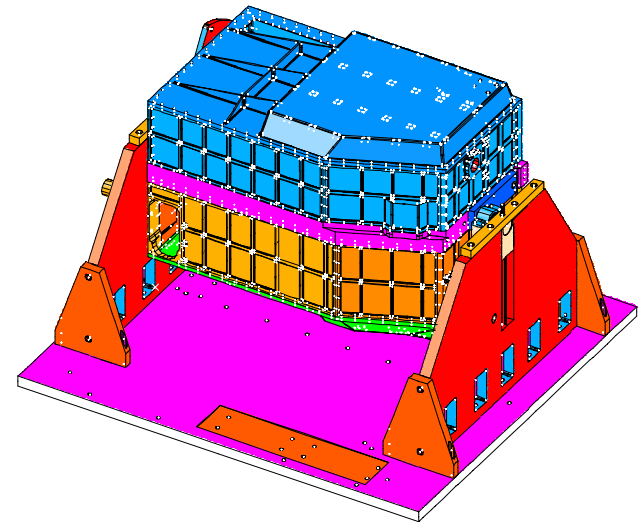
Assembly – Spectrometer Side Panels

- Spectrometer side cover panels bolted on
- Straylight baffles are integrated at same time



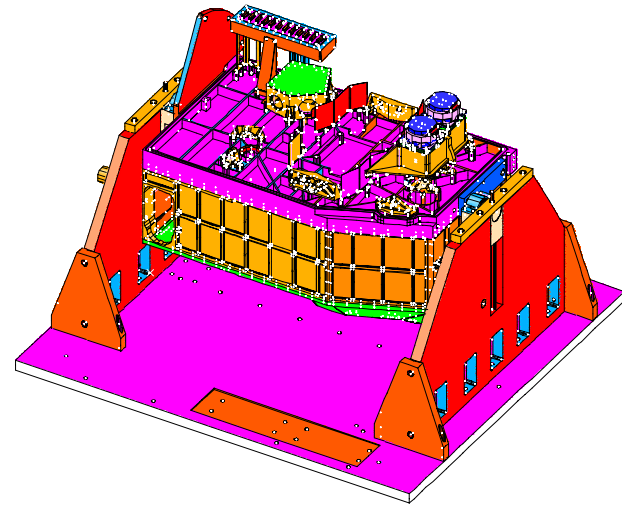
Assembly – Spectrometer Cover

- Spectrometer Cover bolted on



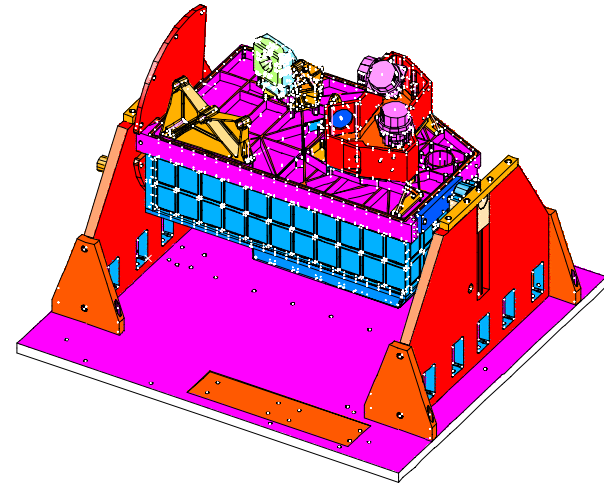
Integration – Spectrometer Side

- Spectrometer cover removed
- Photometer cover left on to ensure rigidity
- Mirror mounts and detector box integrated
- 2-D Alignment check performed
- RF Filter box is mounted



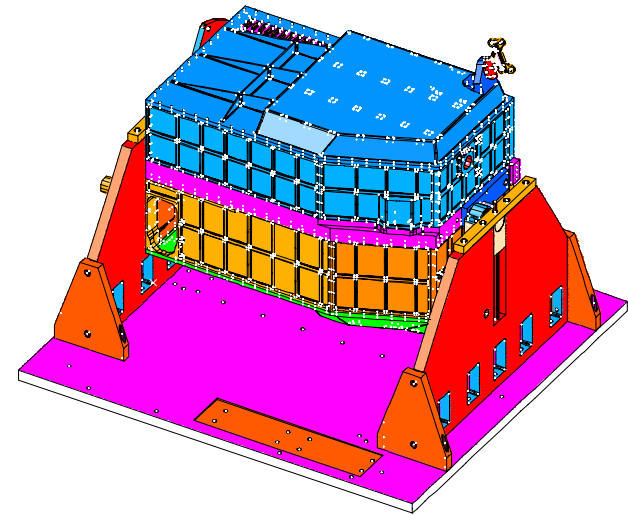
Integration – Photometer Side

- Photometer cover removed
- Spectrometer cover left on to ensure rigidity
- Mirror mounts and detector box integrated
- 2-D Alignment check performed
- 300mK Busbar is mounted



Integration – Installation of Feet

- Spire Structure rotated to upright position
- Feet bolted onto HOB simulator
- Structure lowered on to feet







Made by people at MSSL

PA Plan

Model Philosophy

Selected Components/Materials

Defined Processes

Reliability

Safety



Calibrated Instrumentation

Design Reviews

Cleanliness

Storage/Transportation

Configuration Control

Documentation

Delay Before Proof of Satisfaction



Made by people at MSSL

PA Plan

Model Philosophy

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**Calibrated
Instrumentation**

Design Reviews

Cleanliness

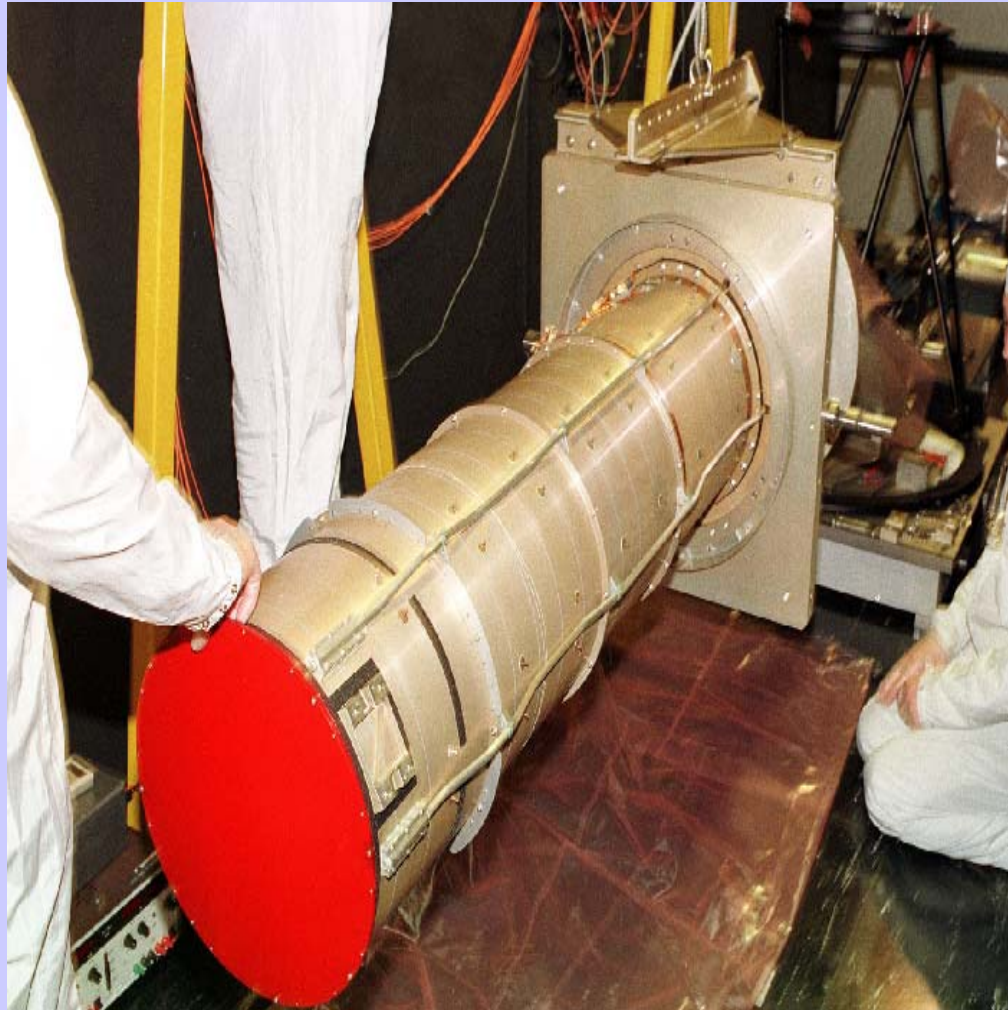
Storage/Transportation

Configuration Control

Documentation

**Delay Before Proof
of Satisfaction**







Herschel/SPIRE structure DDR

Structure FMECA

Chris Brockley-Blatt

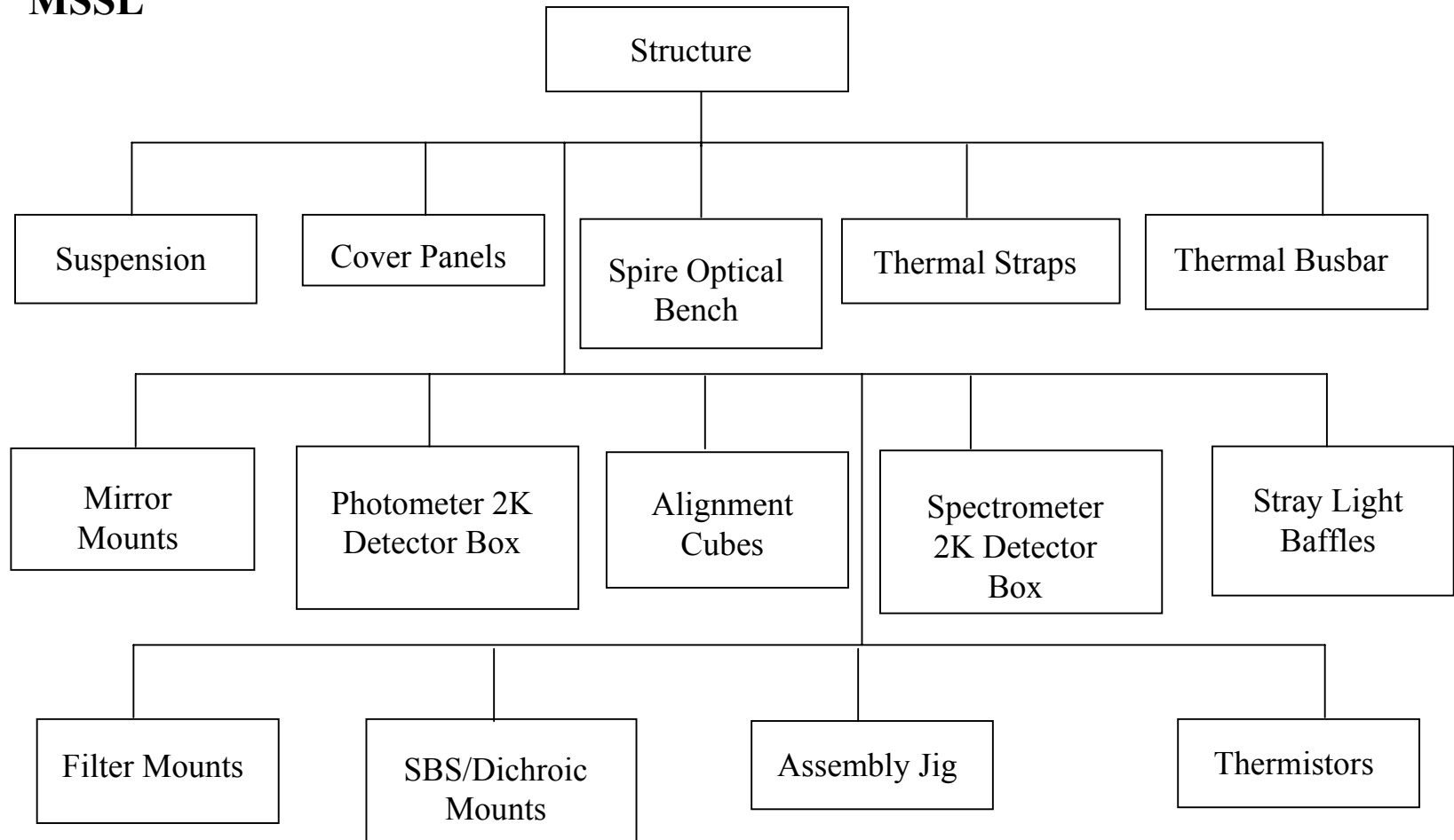
Mullard Space Science Laboratory
University College London



Structure FMECA

- **Strategy**
 - Categories
 - 1
 - 2
 - 3
 - Criticality Criterion
 - Total
 - Intermittent
 - Partial
 - Degradation

Breakdown of Structure



Results and Comments

- **Severity**
 - Majority are rated 1 and SFP
 - No Structure, no instrument!
 - Not a concern because....
- **Detection**
 - Alignment verification
 - Qualification testing
 - Visual health check
 - Running the instrument
- **Provisions**
 - Testing (prove strength, show margin)
 - Sufficient margin in design
 - Visual Checks in sequence at strategic locations

Most critical ones

- Mounting feet - design margin, we tested them as parts and will do in assy, visual inspection) not serious item
- Structure - design margin, tested in assy, visual inspection, not a serious item
- Thermal Straps – design margin, CQM testing, not a serious item
- Detector boxes – design margin, qualification testing, care taken when mounting
- Mirror Mounts – design margin, alignment checks, easily detectable
- Thermal Busbar - have to be careful with this item. Structure testing, CQM testing



Herschel/SPIRE structure DDR Planning

Berend Winter

Mullard Space Science Laboratory
University College London



Development Calendar

- Detailed design December 2000 – Jan. 2002
- STM Manufacture December 2001 – May 2002
- STM Integration alignment at MSSL May - August 2002
- CQM / STM Delivery RAL Mid September 2002



Schedule

Task Name	2001				2002				2003			
	Qtr 3	Qtr 4	Qtr 1	Qtr 2	Qtr 3	Qtr 4	Qtr 1	Qtr 2	Qtr 3	Qtr 4	Qtr 1	Qtr 2
Delta PDR												
Final Design	[Gantt bar spanning from Qtr 3 2001 to Qtr 2 2002]											
STM/CQM Production	[Gantt bar spanning from Qtr 1 2001 to Qtr 3 2002]											
STM/CQM structure production	[Gantt bar spanning from Qtr 1 2001 to Qtr 4 2001]											
MGSE production	[Gantt bar spanning from Qtr 4 2001 to Qtr 2 2002]											
External Input (black/plating)	[Gantt bar spanning from Qtr 2 2002 to Qtr 3 2002]											
integration MSSL	[Gantt bar spanning from Qtr 3 2002 to Qtr 4 2002]											
STM delivery and Margin	[Gantt bar spanning from Qtr 3 2002 to Qtr 2 2003]											
PFM - model	[Gantt bar spanning from Qtr 3 2002 to Qtr 2 2003]											
PFM delivery RAL and Margin	[Gantt bar spanning from Qtr 3 2002 to Qtr 2 2003]											
FS - model	[Gantt bar spanning from Qtr 3 2002 to Qtr 2 2003]											
FS delivery to RAL and Margin	[Gantt bar spanning from Qtr 3 2002 to Qtr 2 2003]											



Points to Note

- Four Full time designers
 - Working from now until March 2002
 - Producing manufacturing drawings
- Major lead time items
 - Photometer detector box 7 Man Weeks
 - Spectrometer detector box 7 Man Weeks
 - Optical Bench 7.5 Man Weeks
 - Side Cover Panels 19 Man Weeks
 - Need to be manufactured by same manufacturer to ensure fit



An Example

- Optical Bench
 - Start Detailing 17 January 2002
 - Finishing Detailing 18 February 2002
 - Start Manufacture 18 February 2002
 - Finish Manufacture 16 April 2002
 - Plating
 - Integration 13 May 2002
 - Finish integration 13 August 2002

Critical Items

- **Photometer Detector Box**
 - Needs to start Manufacture 18 February 2002
 - Design needs to be finished 11 February 2002
 - Design time unknown due to Thermal Busbar Development
 - Same time as Spectrometer Detector box and Optical Bench

- **Side Cover Panels**
 - Finding a single manufacturer for all of them to ensure fit
 - Manufacture start 7 January 2002
 - Manufacture finish 10 April 2002

- **Detector Box Supports**
 - One of last things to be manufactured due to design time



Manufacturers

- MSSL
 - Dichroic mounts
 - Filter Mounts
 - Spectrometer Detector Box
- Startrite
 - CAD/CAM ability
 - Secondary Optical Bench (received quote)
 - Mirror mounts
 - Optical Bench
 - Side panels
- Electro Mech
 - Received Quote
- Thrust
 - Awaiting Quote
- Edwards Brothers

ANNEX C

Comments on SPIRE – FMECA MSSL/SPIRE/PA005.1 29.11.2001

The title is misleading since it is not the FMECA for the whole instrument but for the structure.

The functional diagram or drawing is missing in this analysis. A unique reference number for each failure mode and cause is also missing in the analysis sheet. Each failure mode and cause shall have its own unique id number so that it is possible to refer to each row in the analysis sheets. The traceability between the failure modes in the analysis sheets and the drawings is required in the analysis and it shall be unambiguous.

§ 3 Category 2: Loss or degradation. Loss and degradation should be separated into different severity categories, according to ECSS-Q-30-02A. Thus there would be 4 severity categories.

§ 3. Failure modes considered. The failure modes listed are not corresponding to the failure modes in the analysis sheet. The listed failure modes are basically applicable to electronics and mechanics and not to structure. To be corrected.

A description of the columns in the analysis sheets is missing.

The critical items (severity category 1 and 2) shall be summarised and followed up in the report. There is no visibility on how the critical items are treated and what design provisions are taken to remove the criticality or how to control it. The ECSS-Q-30-02A describes how this shall be done, and the standard is available for download at the ECSS homepage <http://www.estec.esa.nl/ecss/>. Critical items shall be entered into the critical items list and analysed appropriately, if necessary through a process FMECA.

Analysis sheets

In this analysis some failures will occur during ground operations and some during flight. It should be clearly visible for each failure mode/cause if it is analysed during ground tests or during flight. The objective is to identify failures that can occur during flight and how to correct or control these. When other phases are included in the analysis it shall be clearly visible. An additional column shall be added with "Mission phase/Operational mode" stating in which phase or mode a failure occurs.

The "provisions" column. Compensation provisions are design provisions or operator actions, which circumvent or mitigate the effect of a failure. This means provisions that are to be taken when a failure occurs in flight. Design provisions are for instance: redundant items or alternative modes of operation that allow continued and safe operation, and safety or relief devices that allow effective operation or limit the failure effects. For most of the items here there are no provisions if a failure occurs in flight and in the column it should then be stated "None". The provisions described in this column now (such as sufficient design margin, visual inspection, etc.) are ways to control a critical item and minimise the risk of it occurring and should be entered into the corrective actions column or a remarks column.

The corrective actions are actions that are taken to render a critical item non-critical, or if that cannot be done how to control the criticality. This shall be followed up in the critical items list, and traceability shall be kept between the FMECA and the CI list.

The sheets refer in several cases to sufficient design margin. What is a sufficient margin and has a stress analysis been performed to obtain this margin? If an analysis has been performed it shall be referred to and the values of the margin shall be given.

Actions such as “training”, “qualification tests”, “engineering tests” are referred to. Are the plans and procedures available, and are such provisions as “sufficient design margin” known?

Page 7. Why are the three first failure modes SPFs but not the three following? A single point failure is according to ECSS-Q-30-02A: failure of an item, which results in the unrecoverable failure of the analysed product. The three last failures fall under these criteria too. This comment is also valid for the other failure of severity 1.

Id 9a refers to provision as “careful handling”. Are the handling procedures available or will they be written?

Id 13 refers to “sound engineering practice”, which is something that is expected in any case and not a corrective action. Please refer to correct mounting or handling procedures, stress analysis etc. (Quote relevant document number)

There should also be a column in the analysis sheet for remarks or clarifications.